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## Publication Date

1986-04-01

## CENTER FOR X-RAY OPTICS

## X-RAY DATA BOOKLET

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## CENTER FOR X-RAY OPTICS X-RAY DATA BOOKLET

Contributions by Janos Kirz, David T. Attwood, Burton L. Henke, Malcolm R. Howells, Kurt D. Kennedy, Kwang-Je Kim, Jeffrey B. Kortright, Rupert C. Perera, Piero Pianetta, John C. Riordan, James H. Scofield, Gary L. Stradling, Albert C. Thompson, James H. Underwood, Gwyn P. Williams, and Herman Winick.

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October 1985

This work was supported in part by the U.S. Department of Energy under Contract No. DE-AC03-76SF00098

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## PREFACE

Aside from a perceived need for such a compilation, the principal inspiration for this data booklet was the Particle Properties Data Booklet, which is compiled and published periodically by the Particle Data Group at the Lawrence Berkeley Laboratory. Indeed, Sections 1, 8.1, 8.2, and 8.3 of the present booklet have been borrowed, with permission and with only slight modification, from the 1984 edition of the particle data booklet.

Many other sections also draw heavily on work published elsewhere, as indicated in the text and figure captions. Furthermore, we are indebted to many colleagues whose names do not appear among the authors of the articles. Several willingly made illustrations and other material available to us, and we have tried to credit such contributions explicitly. Others served as reviewers and offered invaluable advice on several articles; their names appear among the contributors.

Despite these contributions and the efforts of the many authors, final decisions rested with only a few of us, as did responsibility for compiling the sections lacking by-lines. Blame for error is thus easy to assign.

David T. Attwood Janos Kirz
Douglas Vaughan 16 August 1985

## NOTE TO THE READER

As this is the first edition of the $X$-Ray Data Booklet, we are particularly interested in suggestions for improvement. If you find errors or omissions, or can think of ways the booklet can be made more useful, please send your comments to Douglas Vaughan, Building 50, Room 149. Lawrence Berkeley Laboratory, I Cyclotron Road, Berkeley, California 94720.

## SECTION 1 PHYSICAL CONSTANTS

Table 1-1 was adapted, with permission, from one that appeared in the April 1984 edition of the Particle Properties Data Booklet. A periodic table follows on page 1-4.

| Quantity | Symbol. equation | Value | Unceri. (ppm) |
| :---: | :---: | :---: | :---: |
| permeability of vacuum | $\mu_{0}$ | $\begin{aligned} & 4 \times 1 \times 10^{-7} \mathrm{Hm}^{-1} \\ & =12.5663706144 \times 10^{-7} \mathrm{H} \mathrm{~m}^{-1} \end{aligned}$ | - |
| speed of light | $c$ (see note ${ }^{* *}$ ) | $2.99792458(1.2) \times 10^{10} \mathrm{~cm} \mathrm{~s}^{-1}\left(10^{8} \mathrm{~m} \mathrm{~s}^{-1}\right)$ | 0.004 |
| permittivity of vacuum | $\epsilon_{0}=1 /\left(\mu_{0} c^{2}\right)$ | $8.85418782(7) \times 10^{-12} \mathrm{Fm}^{-1}$ | 0.008 |
| Planck constant | $h$ h | $6.626176(36) \times 10^{-27} \mathrm{erg} \mathrm{s}\left(10^{-34} \mathrm{~J} \mathrm{~s}\right)$ | 5.4 |
| Planck constant, reduced | $n=h / 2 \pi$ | $\begin{aligned} & 1.0545887(57) \times 10^{-27} \mathrm{erg} \mathrm{~s}\left(10^{-34} \mathrm{~J} \mathrm{~s}\right) \\ & \left.=6.582173(17) \times 10^{-22} \mathrm{MeV} \mathrm{~s}^{\left(10^{-16}\right.} \mathrm{eV}\right) \end{aligned}$ | 5.4 2.6 |
| electron charge magnitude | e | $4.803242(14) \times 10^{-10}$ esu | 2.9 |
|  |  | $=1.6021892(46) \times 10^{-19}$ coulomb | 2.9 |
| conversion constant | he | $197.32858(51) \mathrm{MeV}$ fm ( $=\mathrm{eV} \mathrm{nm}$ ) | 2.6 |
| electron mass | $m_{\text {e }}$ | $0.51100034(14) \mathrm{MeV} / \mathrm{c}^{2}=9.109534(47) \times 10^{-28} 8$ | 2.8. 5.1 |
| proton mass | $m_{p}$ | $938.2796(27) \mathrm{MeV} / \mathrm{c}^{2}=1.672648 \mathrm{~S}(86) \times 10^{-24} \mathrm{~g}$ | 2.8.5.1 |
|  | ${ }_{p}$ | $=1.007276470(11) \mathrm{amu}=1836.15152(70) \mathrm{me}_{e}$ | 0.011 .0 .38 |
| deuteron mass |  | $1875.6280(53) \mathrm{MeV} / \mathrm{c}^{2}$ | 2.8 |
| atomic mass unit (amu) | $\left(\right.$ mass ${ }^{12} \mathrm{C}$ atom)/12 $=(1 \mathrm{~g}) / N_{A}$ | $931.5016(26) \mathrm{McV} / \mathrm{c}^{2}=1: 6605655(86) \times 10^{-24} \mathrm{~g}$ | 2.8. 5.1 |
| fine structure constant | $\alpha=e^{2} / \mathrm{hc}$ | 1/137.03604(11) | 0.82 |
| classical electron radius | $r_{c}=e^{2} / m_{e} c^{2}$ | 2.817938 Of70) fin ( $10^{-15} \mathrm{~m}$ ) | 1) 2.5 |
| electron Compton wavelength | $x_{e}^{c}=n / m_{e}{ }^{c}=r_{e} \alpha^{-1}$ | $39615905(64) \times 10^{-11} \mathrm{~cm}\left(10^{-13} \mathrm{~m}\right)$ | 1.6 |
| Bohr radius ( $m_{\text {nueleus }}=\infty$ ) | $a_{\infty}=n^{2} / m_{c} e^{2} \Rightarrow r^{\prime} \alpha^{-2}$ | $0.529177066(44) \times 10^{-8} \mathrm{~cm}\left(10^{-10} \mathrm{~m}\right)$ | 0.82 |
| Rydberg energy ${ }^{\text {a }}$. | $h c R_{\infty}=m_{c} e^{4} / 2 \hbar^{2}=m_{e} c^{2} a^{2} / 2$ | $13.605804(36) \mathrm{eV}$ | 12.6 |
| Thomson cross section | $\sigma_{T}=8 \pi r_{e}^{2} / 3$ | $0.6652448(33)$ bam ( $10^{-28} \mathrm{~m}^{2}$ ) | 4.9 |
| Bohr magneton | $\mu_{B}=p / 2 m_{c} c^{\prime}$ | $5.7883785(95) \times 10^{-15} \mathrm{MeV}_{\text {gaus5 }}{ }^{-1}\left(10^{-5} \mathrm{eV} \mathrm{T}^{-1}\right)$ | 1.6 |
| nuclear magneton* | $\mu_{N}=2 h / 2 m_{o} c$ | $3.1524515(5) \times 10^{-18} \mathrm{MeV}^{\text {g gauss }}{ }^{-1}\left(10^{-8} \mathrm{eV} \mathrm{T}^{-1}\right)$ | 1.7 |
| electron cyclotron freq./field | $\omega_{\mathrm{cyc}}^{\mathrm{c}} \mathrm{c}^{\prime} / B=e / m_{e} e^{\text {c }}$ | $1.7588047(49) \times 10^{7} \mathrm{rads}^{-1}$ gauss ${ }^{-1}\left(10^{11} \mathrm{rad} \mathrm{s}^{-1} \mathrm{~T}^{-1}\right)$ | 2.8 |
| proton cyclotron freq./field | $\omega_{\text {chel }} / B=e / m_{p}{ }^{\text {c }}$ | $9.578756(28) \times 10^{3} \mathrm{rad} \mathrm{s}^{-1}$ gauss ${ }^{-1}\left(10^{7} \mathrm{rad} \mathrm{s}^{-1} \mathrm{~T}^{-1}\right)$ | 2.8 |


"Revised 1984 by Barry N. Taylor, based mainly on the "1973 Least-Squares Adjusiment of the Fundamental Constants," by E. R. Cohen and B. N. Taylor, J. Phys. Chem. Ref. Data 2, 663 (1973). The figures in parentheses give the 1 -standard-deviation uncertainties in the last digits of the main numbers, the uncertaintics in parts per million ( ppm ) are given in the last colurnn. The uncertaintres of the output values of a least-squares adjustment are in general correlated, and the laws of error propagation must be used in calculating additional quantities.

The set of constants resulting from the 1973 adjustment of Cohen and Taylor has been recommended for international use by CODATA (Committee on Data for Science and Technology), and is the most up-to-date, generally accepted set currently available. Since the publication of the 1973 adjustment, new experiments have yielded better values for some of the constants: $N_{A}=6.0220978(63) \times 10^{23} \mathrm{~mol}^{-1}(1.04 \mathrm{ppm}) ; \alpha^{-1}=137.035$ $951(15)(0.11 \mathrm{ppm})$; and $m_{p} / m_{t}=1836.152470(79)(0.043 \mathrm{ppm})$. However, since a change in the measured value of one constant usually leads to changes in the adjusted values of others, one must be cautious in using together the values from the 1973 -adjustment and the results of more recent experiments.

* In October 1983, the Conference Genérale des Poids et Mesures adopted a new definition of the meter. The meter is the length of the path Iravcled by light in vacuum during a time interval of $1 / 299792458$ s. Thus the speed of light is defined to be $299792458 \mathrm{~m} \mathrm{~s}^{-1}$. For a discussion of this change. see B. W. Petley. Nature 303, 373 (1983).




## SECTION 2

## THE ELEMENTS

### 2.1 PROPERTIES OF THE ELEMENTS

Table 2-1 lists the atomic weights, densities, melting and boiling points, 'first ionization potentials, and specific heats of the elements. Data were taken mostly from R. C. Weast, Ed. CRC Handbook of Chemistry and Physics, 65th ed. (CRC Press, Boca Raton, Florida, 1984). Atomic weights apply to elements as they exist naturally on earth or, in the cases of radium, actinium, thorium, protactinium, and neptunium, to the isotopes with the longest half-lives. Values in parentheses are the mass numbers for the longest-lived isotopes. Specific heats are given for the elements at $25^{\circ} \mathrm{C}$. Densities for solids and liquids are given at $20^{\circ} \mathrm{C}$ unless otherwise indicated by a superscript temperature (in ${ }^{\circ} \mathrm{C}$ ); densities for the gaseous elements are for the liquids at their boiling points.

Table 2-1. Propenies of the elements.

| 2 | Element | Atomic welght | $\begin{aligned} & \text { Density } \\ & \left(\mathrm{g} / \mathrm{cm}^{3}\right) \end{aligned}$ | Melting point ( $\left.{ }^{\circ} \mathrm{C}\right)$ | Boiling point ( ${ }^{\circ} \mathrm{C}$ ) | Ionization potential (ev) | Specific helt ( $\mathrm{cal} / \mathrm{g} \cdot \mathrm{K}$ ) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | 1 'Hydrogen | 1.00794 | 0.0708 | -259.14 | $-252.87$ | 13.598 | 3.41 |
|  | 2. Helium | 4.00260 | 0.122 | -272.2 | -268.934 | 24.587 | 1.24 |
|  | 3 Lithium | 6.941 | 0.533 | 180.54 | - 1342 | 5.392 | 0.834 |
|  | 4 Beryllium | 9.01218 | 1.845 | 1278 | 2970 | 9.322 | 0.436 |
|  | 5 Boron | 10.81 | 2.34 | 2079 | $2550{ }^{\text {c }}$ | 8.298 | 0.245 |
|  | 6 Carbon | 12.011 | 2.26 | 3550 | $3367^{\text {c }}$ | 11.260 | 0.170 |
|  | 7 Nitrogen | 14.0067 | 0.81 | -209.86 | -195.8 | 14.534 | 0.249 |
|  | 8 Oxygen | 15.9994 | 1.14 | -218.4 | -182.962 | 13.618 | 0.219 |
|  | 9 Fluorine | 18.998403 | 1.108 | -219.62 | -188.14 | 17.422 | 0.197 |
| 10 | Neon | 20.179 | 1.207 | -248.67 | -246.048 | 21.564 | 0.246 |
| 11 | Sodium | 22.98977. | 0.969 | 97.81 | 882.9 | 5.139 | 0.292 |
| 12 | 2 Magnesium | 24.305 | 1.735 | 648.8 | 1090 | + 7.646 | 0.245 |
| 13 | Aluminum | 26.98154 | 2.6941 | 660.37 | 2467 | 5.986 | 0.215 |
| 14 | Silicon | 28.0855 | $2.32{ }^{25}$ | 1410 | 2355 | 8.151 | 0.168 |
| 15 | Phosphorus | 30:97376 | 1.82 | 44.1 | 280 | 10.486 | 0.181 |
| 16 | Sulfur | 32.06 | 2.07 | 112.8 | 444.674 | 10.360 | 0.175 |
| 17 | Chlorine | 35.453 | 1.56 | . -100.98 | -34.6 | 12.967 | 0.114 |
| 18 | Argon | 39.948 | 1.40 | -189.2 | $-185.7$ | 15.759 | 0.124 |
| '19 | Potassium | 39.0983 | 0.860 | 63.25 | 760 | 4.341 | 0.180 |
| 20 | Calcium | 40.08 | 1.55 | 839 | 1484. | 6.113 | 0.155 |
| 21 | Scandium | 44.9559 | $2.980^{25}$ | 1541 | 2831 | 6.54 | 0.1173 |
| 22 | Titanium | 47.88 | 4.53 | 1660 | 3287 | 6.82 | 0.1248 |
| 23 | Vanadium | 50.9415 | $6.10^{18.7}$ | 1890 | 3380 | 6.74 | 0.116 |
| 24 | Chromium | 51.996 | . 7.18 | 1857 | 2672 | 6.766 | 0.107 |
| 25 | Manganese | 54.9380 | 7.43 | 1244 | 1962 | 7.435 | 0.114 |
| 26 | Iron | 55.847 | 7.860 | 1535 | 2750 | 7870 | 0.1075 |
| 27 | Cobatt | 58.9332 | 8.9 | 1495 | 2870 | 7.86 | 0.107 |
| 28 | Nickel | 58.69 | $8.876^{25}$ | 1453 | 2732 | 7.635 | 0.1061 |
| 29 | Copper | 63.546 | 8.94 | 1083.4 | 2567 | 7.726 | 0.0924 |
| 30 | Zine | 65.38 | $7.112^{25}$ | 419.58 | 907 | 9.394 | 0.0922 |
| 31 | Gallium | 69.72 | $5.877^{29.6}$ | 29.78 | 2403 | $5.999{ }^{\prime}$ | 0.088 |
| 32 | Germanium | 72.59 | $5.307^{25}$ | 937.4 | 2830 | 7.899 | 0.077 |
| 33 | Arsenic | 74.9216 | 5.72 | $817^{28}$ atm | $613^{\text {c }}$ | 9.81 | 0.0785 |
| 34 | Selenium | 78.96 | 4.78 | 217 | 684.9 | 9.752 | 0.0767 |
| 35 | Bromine | 79.904 | 3.11 | $-7.2$ | 58.78 | 11.814 | 0.0537 |
| 36 | Krypton | 83.80 | 2.6 | -156.6 | -152.30 | 13.999 | 0.059 |
| 37 | Rubidium | 85.4678 | 1.529 | 38.89 | 686 | 4.177 | 0.0860 |

Table 2-1. Properties of the elements (continued).

| 2 | Element | Atomic weight | Density ( $\mathrm{g} / \mathrm{cm}^{3}$ ) | Melting point $\left({ }^{\circ} \mathrm{C}\right)$ | Boiling polnt ( ${ }^{\circ} \mathrm{C}$ ) | lonization potential (eV) | Specific heat (cal/g $\cdot \mathrm{K}$ ) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 38 | Strontium | 87.62 | 2.54 | 769 | 1384 | 3.695 | 0.0719 |
| 39 | Yttrium | 88.9059 | $4.456{ }^{25}$ | 1522 | 3338 | 6.38 | 0.0713 |
| 40 | Zirconium | 91.22 | $6.494^{\prime}$ | 1852 | 4377 | 6.84 | 0.0660 |
| 41 | Niobium | 92.9064 | 8.55 | 2468 | 4742 | 6.88 | 0.0663 |
| 42 | Molybdenum | 95.94 | 10.20 | 2617 | 4612 | 7.099 | 0.0597 |
| 43 | Technetium | (98) | $11.48^{\text {a }}$ | 2172 | 4877 | 7.28 | 0.058 |
| 44 | Ruthenium | 101.07 | 12.39 | 2310 | 3900 | 7.37 | 0.0569 |
| 45 | Rhodium | 102.9055 | 12.39 | 1966 | 3727 | 7.46 | 0.0580 |
| 46 | Palladium | 106.42 | 12.00 | 1554 | 2970 | 8.34 | 0.0583 |
| 47 | Silver | 107.8682 . | 10.48 | 961.93 | 2212 | 7.576 | 0.0562 |
| 48 | Cadmium | 112.41 | 8.63 | 320.9 | 765 | 8.993 | 0.0552 |
| 49 | Indium | 114.82 | 7.30 | 156.61 | 2080 | 5.786 | 0.0556 |
| 50 | Tin | 118.69 | 7.30 | 231.9681 | 2270 | 7.344 | 0.0519 |
| 51 | Antimony | 121.75 | 6.679 | 630.74 | 1950 | 8.641 | 0.0495 |
| 52 | Tellurium | 127.60 | 6.23 | 449.5 | 989.8 | 9.009 | 0.0481 |
| 53 | Iodine | 126.9045 | 4.92 | 113.5 | 184.35 | 10.451 | 0.102 |
| 54 | Xenon | 131.29 | 3.52 | -111.9 | -107.1 | 12.130 | 0.0378 |
| 55 | Cesium | 132.9054 | 1.870 | 28.40 | 669.3 | 3.894 | 0.0575 |
| 56 | Barium | 137.33 | 3.5 | 725 | 1640 | 5.212 | 0.0362 |
| 57 | Lanihanum | 138.9055 | $6.127^{25}$ | 921 | 3457 | 5.577 | 0.0479 |
| 58 | Cerium | 140.12 | $6.637^{25}$ | 799 | 3426 | 5.47 | 0.0459 |
| 59 | Praseodymium | 140.9077 | 6.761 . | 931 | 3512 | 5.42 | 0.0467 |
| 60 | Neodymium | 144.24 | 6.994 | 1021 | 3068 | 5.49 | 0.0453 |
| 61 | Promethium | (145) | $7.20{ }^{25}$ | 168 | 2460 | 5.55 | 0.0442 |
| 62 | Samarium | 150.36 | 7.51 | 1077 | 1791 | 5.63 | 0.0469 |
| 63 | Europium | 151.96 | $5.228{ }^{25}$ | 822 | 1597 | 5.67 | 0.0326 |
| 64 | Gadoliaium | 157.25 | $7.8772^{25}$ | 1313 | 3266 | 6.14 | 0.056 |
| 65 | Terbium | 158.9254 | 8.214 | 1356 | 3123 | 5.85 | 0.0435 |
| 66 | Dysprosium | 162.50 | $8.525^{25}$ | 1412 | 2562 | 5.93 | 0.0414 |
| 67 | Holmium | 164.9304 | $8.769^{25}$ | 1474 | 2695 | 6.02 | 0.0394 |
| 68 | Erbium | 167.26 | $9.039^{25}$ | 159 | 2863 | 6.10 | 0.0401 |
| 69 | Thulium | 168.9342 | $9.294^{25}$ | 1545 | 1947 | 6.18 | 0.0382 |
| 70 | Yaterbium | 173.04 | 6.953 | 819 | 1194 | 6.254 | 0.0287 |
| 71 | Luletium | 174.967 | $9.811^{25}$ | 1663 | 3395 | 5.426 | 0.0285 |
| 72 | Hafnium | 178.49 | 13.29 | 2227 | 4602 | 7.0 | 0.028 |
| 73 | Tantalum | 180.9479 | 16.624 | 2996 | 5425 | 7.89 | 0.0334 |
| 74 | Tungsten | 183.85 | 19.3 | 3410 | 5660 | 7.98 | 0.0322 |

Table 2-1., Properties of the elentents (continued).

|  | Element | Atamic <br> - weight | Density ( $\mathrm{m} / \mathrm{cm}^{3}$ ) | Melting point ( $\left.{ }^{\circ} \mathrm{C}\right)$ | Boiling pö́nt ( $\left.{ }^{\circ} \mathrm{C}\right)$ | Ionization potential (ev) | $\begin{gathered} \text { Speciftc } \\ \text { heat } \\ (\mathrm{cal} / \mathrm{g} \cdot \mathrm{~K}) \end{gathered}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Rhenium | 186.207 | 20.98 | $3180^{\circ}$ | $5627{ }^{\text {b }}$ | 7.88 | 0.0330 |
| --. $76^{-1}$ | ${ }^{7}$ Osimiūm ${ }^{-1}$ | 190.2 | 22.53. | 3045 . | 5027 | 8.7 | 0.0310 |
| $-77$ | Iridium ${ }^{\text {a },}$ | 192.22 | $22.39{ }^{17}$ | 2410 | 4130 . | 9.1 | 0.0312 |
| 78 | Platinuri: : | $195.08{ }^{\circ}$ | 21.41'. | 1772 | 3827 | 9.0 - | 0.0317 |
| 79 | Gold | 196.9665 | 18.85 | 1064.43 | 3080 | 9.225 - | 0.0308 |
| 80 | Mercury | 200.59 | 13.522 | - 38.842 | 356.58 | 10.437 | 0.0333 |
| 81 | Thallium | 204.383 | $11.83:$ | . 303.5 | 1457 | 6.108 | 0.0307 |
| 82 | Lead | 207.2 | 11.33 : | 327.502 | 1740 | 7.416 | 0.0305 |
|  | Bismuth | 208.9804 | $9.730^{\circ}$ | 271.3 | 1560 | 7.289 | 0.0238 |
| 84 | Polonium | (209) | 7.30 | 254 | 962 | 8.42 | 0.030 |
| 85 | Astatine | (210) | - | 302. | $337{ }^{\text {b }}$ | - | - |
| 86 | Radon | (222) | $4.4{ }^{\prime}{ }^{\prime}$ | $-71$. | - 01.8 | 10.748 | 0.0224 |
| 87 | Francium | (223) | - | 27. | 677 | - | - |
|  | Radium | 226.0254 | 5 | 700 | 1140 | 5.279 | 0.0288 |
| 89 | Actinium | 227.0278 | $10.05^{\text {a }}$ | 1050 | $3200^{6}$ | 6.9 | -- |
| 90 | Thorium | 232.0381 | 11.70 | 1750 | 4790 | - | 0.0281 |
|  | Protactinium | 231.0359 | $15.34^{\text {a }}$ | $<1600$ | - | - | 0.029 |
| 92 | Uranium : | 238.0289 | 18.92 | $1132.3{ }^{\text { }}$ | 3818 | - | 0.0278 |
| 93 | Neptunium | 237.0482 | 20.21 | 640 | $3902{ }^{\text {b }}$ | - | - |
| 94 | Plutonium | (244) | 19.80 | 641 | 3232 | 5.8 | -- |
| 95 | Americium | (243) ${ }^{\text {- }}$ | 13.64 | 994 | 2607 | 6.0 |  |
| 96 | Curjum | (247) | $13.49^{\circ}$ | 1340 . | $\cdots$ | - | - |
| 97 | Berkelium | (247) | $14^{\text {b }}$ | - | - | - | - |
| 98 | Califormium | (251) | - | - | - | - | - |
| 99 | Einsteinium | (252) | - | - | - | - | - |
| 100 | Fermiurn | (257) ${ }^{\prime}$ | - | $\because$ | - | - | - |
| 101 | Mendelevium | (258) | - | - | - | - | - |
| 102 | Nobelium | (259) | - | - | - | - | - |
| 103 | Lawrencium | (260) | - | - | - | - | - |

${ }^{9}$ Calculated
${ }^{\text {b Estimated }}$
${ }^{\text {s }}$ Sublimes

### 2.2 ELECTRON BINDING ENERGIES

Gwyn P. Williams
Table 2-2 gives the electron binding energies for the elements in their natural forms. The energies are given in electron volts relative to the vacuum level for the rare gases and for $\mathrm{H}_{2}, \mathrm{~N}_{2}$, $\mathrm{O}_{2}, \mathrm{~F}_{2}$, and $\mathrm{Cl}_{2}$; relative to the Fermi level for the metals; and relative to the top of the valence bands for semiconductors. Values have been taken from Ref. I except as noted:

* Values taken from Ref. 2.
$\dagger$ Values taken from Ref. 3.
a One-particle approximation not valid owing to the extremely short lifetime of the core hole.
b Values derived from Ref. I.


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Table 2-2. Electron binding energies for the elements in their natural forms.

| Element | K Is | $\mathrm{L}_{1} \mathrm{I}$. | $L_{11}{ }^{2} P_{1 / 2}$ | $\mathrm{L}_{\text {III }} \boldsymbol{1}_{P_{3 / 1}}$ | $\mathrm{M}_{1} 35$ | $M_{11}{ }^{3} \boldsymbol{P}_{1 / 2}$ | $\mathrm{MHI}^{\mathbf{3} p_{3 / 2}}$ | $M_{1 v}{ }^{3} d_{3 / 2}$ | $\mathrm{M}_{\mathrm{V}} \mathbf{3 d}_{\mathbf{5 / 2}}$ | $\mathrm{N}_{1}{ }^{4}$ | $N_{11} \mathbb{A P}_{1 / 2}$ | $\mathbf{N I I I}^{\mathbf{4}} \mathbf{P}_{\mathbf{3 / 2}}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 H | $16^{\circ}$ |  |  |  |  |  |  | , | * | . |  | $\cdots$ |
| 2 He | 24.6* |  |  |  |  |  |  |  |  |  |  | - |
| 3 Li | - $54.7{ }^{*}$ |  | . | - |  | - |  |  | . |  |  |  |
| 4 Bc | 111.5* |  |  |  |  |  |  |  |  |  |  |  |
| 5 B | 188* |  |  |  |  |  | - |  |  |  | I | - |
| 6 C | 284.2* |  |  | . |  |  |  |  |  |  |  |  |
| 7 N | 409.9** | 37.3* |  | , |  |  |  |  |  |  |  |  |
| 80 | $543.1 *$ | 41.6* |  |  |  |  |  | $\because$ |  |  | - |  |
| +9F | 696.7* |  |  |  |  |  |  |  |  |  |  |  |
| 10 Ne | $870.2^{*}$ | 48.5* | 21.7* | 21.6* |  | . |  |  |  |  |  |  |
| 11 Na | $1070.8^{\prime}$ | $63.5{ }^{\dagger}$ | $30.4{ }^{\text {t }}$ | 30.5* |  |  |  | $\cdots$ |  |  |  |  |
| 12 MB | $1303.0^{\dagger}$ | 88.6* | $49.6{ }^{\dagger}$. | $49.2{ }^{\prime}$ | - | - | - | $\stackrel{*}{ } \cdot$ |  | - |  |  |
| 13 A ! | 1558.98* | 117.8** | 72.9* | 72.5* | - |  | . |  | . | $\cdots$. |  |  |
| 14 Si | 1839 | $149.7{ }^{\text {* }} \mathrm{b}$ | 99.8* | 99.2* |  |  | - |  |  |  |  |  |
| 15 P | 2149 | 189* | 136* | - 135* |  | - | - . |  |  | - | 1 |  |
| 16 S | 2472 | $2309{ }^{*} \mathrm{~b}$ | $163.6{ }^{*}$ | 162.5* |  | - |  | . ${ }^{*}$ | . |  | ]. |  |
| 17 Cl | 2833 . | $270^{\circ}$ | 202* | $200^{*}$ |  |  | - |  |  | - | 1 |  |
| 18 Ar | 3205.9* | 326.3* | 250.6* | 284.4* | 29.3* | 15,9** | 15.7* |  |  |  | . |  |
| 19 K | 3608.4* | 378.6* | 297.3* | 294.6* | 34.8* | 18.3" | 18.3** | , - | , |  |  |  |
| 20 Ca | 4038.5* | $438.4^{\dagger}$ | $349.7{ }^{\dagger}$ | 346. ${ }^{\text { }}$ | $44.3{ }^{1}$ | $25.4{ }^{+}$ | $25.4{ }^{+}$ | - . |  |  |  | . |
| 21 Sc | 4492 | $498.0{ }^{\circ}$ | $403.6 *$ | 398.7* | $51.1{ }^{*}$ | 28.3* | 28.3* |  |  |  |  |  |
| 22 T | 4966 | $560.9^{+}$ | $461.2^{\dagger}$ | $453.8{ }^{\dagger}$ | $58.7{ }^{\dagger}$ | $32.6{ }^{+}$ | $32.6{ }^{+}$ |  | . |  |  |  |



Table 2-2. Electron binding energies (continued).

| -Element | K 1s | $\mathrm{L}_{1}{ }^{2} 5$ | $\mathbf{L}_{11} \mathbf{2 p}_{1 / 2}$. | $\mathrm{L}_{\text {III }}{ }^{2} p_{3 / 2}$ | $\mathrm{M}_{1} 3 \mathrm{~s}$ | $\mathbf{M}_{11}{ }^{\mathbf{3}} \mathbf{1 / 2}$ | $\mathbf{M}_{\text {III }}{ }^{\mathbf{3}} \mathbf{y}_{\mathbf{3} / 2}$ | $\mathrm{M}_{\text {IV }} \mathbf{3 d}_{\mathbf{3 / 2}}$ | $\mathrm{M}_{\mathrm{V}} \mathbf{3} d_{5 / 2}$ | $\mathrm{N}_{\mathrm{I}} 4 \mathrm{~s}$ | $\mathrm{N}_{11} \boldsymbol{4}_{p_{1 / 2}}$ | $\mathrm{N}_{\text {III }}{ }^{\mathbf{4}} \mathbf{p}_{3 / 2}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 48. Cd | 26711 | 4018 | 3727 | 3538 | $772.0^{\dagger}$ | $652.6{ }^{\text {t }}$ | $618.4{ }^{\dagger}$ | $411.9{ }^{+}$ | $405.2{ }^{\dagger}$ | $109.8{ }^{\dagger}$ | $63.9{ }^{\dagger}$ a | $63.9{ }^{\text {+ }}$ a |
| 49 In | 27940 | 4238 | 3938; | 3730. | $827.2^{\dagger}$ | $703.2^{\dagger}$ | $665.3{ }^{\text {t }}$ | $451.4{ }^{+}$. | $443.9{ }^{\text {¢ }}$ | $122.7{ }^{\dagger}$ | $73.5{ }^{\dagger} \mathrm{a}$ | . $73.5{ }^{\dagger} \mathrm{a}$ |
| 50 Sn | 29200 | 4465 | 4156. | 3929 | $884.7{ }^{\dagger}$ | $756.5{ }^{\text {t }}$ | $714.6{ }^{+}$ | $493.2{ }^{+}$ | 484.9 ${ }^{+}$. | $137.1^{\dagger}$ | $83.6{ }^{\text {ta }}$ | $83.6{ }^{\text {ta }}$ |
| 51 Sb | 30491 | 4698 | 4380 | 4132 | $946{ }^{\dagger}$ | .812.7 ${ }^{\dagger}$ | .766.4 ${ }^{\dagger}$ | 537.5 ${ }^{+}$ | $528.2^{\dagger}$ | $153.2{ }^{\dagger}$ | $95.6{ }^{\circ} \mathrm{a}$ | $95.6{ }^{\dagger} \mathrm{a}$ |
| \$2 Te | 31814 | 4939 | 4612 | 4341 | $1006{ }^{\dagger}$ | . $870.8{ }^{\dagger}$ | $820.8{ }^{\dagger}$ | 583.4 ${ }^{\text {\% }}$ | $573.0^{\dagger}$ | $169.4{ }^{\dagger}$ | $103.3{ }^{\dagger} \mathrm{a}$ | $103.3{ }^{\dagger} \mathrm{a}$ |
| 531 | 33169. | 5188 | 4852 | 4557. | 1072* | 931* | 875* | 631* | 620* | 186* | 123* | $123^{\circ}$ |
| - 54 Xe | 34561 | 5453 | 5104 | 4782 | 1148.7* | 1002.1* | 940.6* | 689.0* | 676.4* | 213.2* | 146.7 | 145.5* |
| 55 Cs | 35985 | 5714 | 5359 | 5012 | $1211^{*} \mathrm{~b}$ | 1071* | 1003* | 740.5* | 726.6* | 232.3* | 172.4* | 161.3* |
| $56 . \mathrm{Ba}$ | 37441 | 5989 | -5624 | 5247 | $1293{ }^{\circ} \mathrm{b}$ | 1137*b | $1063^{*} \mathrm{~b}$ | 795.7* | 780.5* | $253.5{ }^{\dagger}$ | 192 | $178.6{ }^{+}$ |
| 57 La | 38925 | 6266 | $5891{ }^{\circ}$ | 5483 | $1362 \%$ b | 1209*b | $1128{ }^{\circ} \mathrm{b}$ | 853* | $836{ }^{*}$ | 247.7* | 205.8 | 196.0* |
| 58 Ce | 40443. | 6548 | 6164 | 5723 : | $1436{ }^{\circ} \mathrm{b}$ | $1274 *$ b | 1187*b | 902.4* | 883.8* | 291.0* | 223.2 | 206.5* |
| 59 Pr | 41991 | 6835 | 6440 | 5964 | 1511 | 1337 | 1242 * | 948.3* | 923.8* | 304.5 | 236.3 | 217.6 |
| 60 Nd | 43569 | 7126 | 6722 | 6208 | 1575 | 1403 | 1297 | 1003.3* | 980.4* | 319.2* | 243.3 | 224.6 |
| 61 Pm | 45184 | 7428 | 7013 | 6459 | - | 1403 | 1357 | 1052 | 1027 | $\cdots$ | 242 | 242 |
| 62 Sm | 46834 | 7737 | 7312 | 6716 | 1723 | 1541 | 1419.8 | 1110.9** | 1083.4* | 347.2** | 265.6 | 247.4, |
| 63 Eu | 48519 | 8052 | 7617 | 6977 | 1800 | 1614 | 1481 | 1158.6* | 1127.5* | 360 | 284 | 257 |
| 64 Gid | 50239 | 8376 | 7930 | 7243 | 1881 | 1688 | 1544 | 1221.9** | 1189.6** | 378.6* | 286. | 271 |
| 65 Tb | 51996 | 8708 | 8252 | 7514 | 1968 | 1768 | 1611 | 1276.9* | 1241.1** | 396.0* | 322.4* | - 284.1 * |
| 66 Dy | 53789 | 9046 | 8581 | 7790 | 2047 | 1842 | 1676 | 1333 | 1292* | 414.2* | $333.5{ }^{\circ}$ | 293.2* |
| 67 Ho | 55618 | 9394 | 8918 | 8071 | 2128 | - 1923. | 1741 | 1392 | 1351 | 432.4* | 343.5 | 308.2* |
| 68 Er | 57486 | 9751: | 9264 | 8358 | 2206 | 2006. | 1812 | 1453 - | 1409 | 449.8* | 366.2 | 320.2* |
| 69 Tm | 59390 | 10116 | 9617 | 8648 | 2307 | 2090 | 1885 | 1515 | 1468 | * $470.9 *$ | 385.9** | 332.6* |
| 70 Yb | 61332 | 10486 | 9978 | 8944 , | 2398 | 2173 | 1950 | 1576 | 1528 | 480.5* | 388.7* | 339.7* |

Table 2-2. Electron binding energies (continued).

| Element | $\mathrm{N}_{\text {fv }} \mathrm{dd}_{3 / 2}$ | $\mathrm{N}_{\mathrm{V}} \mathrm{dd}_{5 / 2}$ | $\mathrm{N}_{\mathbf{V I}}{ }^{4} \mathbf{f}_{5 / 2}$ | $\mathrm{N}_{\text {vit }}{ }^{4 f_{7 / 2}}$ | $\mathrm{O}_{\mathrm{I}} 5$ | $\mathrm{O}_{11} 5_{p_{1 / 2}}$ | $\mathrm{O}_{1 I \mathrm{I}} 5 p_{3 / 2}$ | $o_{16}{ }^{5} d_{3 / 2}$ | $\mathrm{O}_{\mathrm{v}} \mathrm{Sd}_{5 / 2}$ | $\mathrm{P}_{1} 6 \mathrm{~s}$ | $\mathrm{P}_{11} 6 \mathrm{P}_{1 / 2}$ | $\mathrm{P}_{111}{ }^{6 P_{3 / 2}}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 48 Cd | $11.7{ }^{7}$ | $10.7{ }^{\dagger}$ |  |  |  | $\cdots$ |  |  |  |  | . |  |
| 49 In | . $17.7{ }^{\text {¢ }}$ | $16.4{ }^{\dagger}$ | - . |  |  |  |  |  |  |  |  |  |
| 50 Sn | $24.9{ }^{\dagger}$ | $23.9{ }^{\dagger}$ |  |  |  | \% | - |  |  |  |  |  |
| 51 Sb | 33.3 t | $32.1{ }^{\dagger}$ |  |  |  |  |  | , |  |  |  |  |
| 52 Te | $41.9 \dagger$ | $40.4{ }^{\dagger}$ |  |  |  |  |  | $\cdot$ |  |  |  |  |
| 53 I | $50 *$ | $50^{*}$ |  |  |  |  |  |  |  | - |  |  |
| 54 Xe | 69.5* | 67.5* | - | . - | 23.3* | 13.4 | 12.1* |  | , |  |  |  |
| 55 Cs | 79.8* | 77.5* | - | - | 22.7 | 14.2" | 12.1* |  |  |  |  |  |
| 56 Ba | $92.6{ }^{+}$ | $89.9{ }^{+}$ | - | - | $30.3{ }^{\dagger}$ | $17.0{ }^{*}$ | $14.8{ }^{\dagger}$ |  |  |  |  |  |
| 57 La | 105.3* | 102.5* | - | - | $34.3{ }^{\circ}$ | 19.3* | 16.8* |  |  |  |  | . |
| 58 Ce | 109* | - | 0.1 | 0.1 | 37.8 | 19.8* | 17.0* |  |  |  | . |  |
| 59 Pr | $115.1{ }^{*}$ | '115.1* | 2.0 | 2.0 | 37.4 | 22.3 | 22.3 |  |  |  |  |  |
| 60 Nd | 120.5* | 120.5* | 1.5 | 1.5 | 37.5 | 21.1 | 21.1 | - |  |  | - |  |
| 61 Pm | 120 | 120 | - | - | - | - | - |  |  |  |  | . |
| 62 Sm | 129 | 129 | 5.2 | 5.2 | 37.4 | 21.3 | 21.3 |  |  |  |  |  |
| 63 Eu | . 133 | 133 | 0 | 0 | 32 | 22 | 22 | . |  |  |  |  |
| 64 Gd | - | 127.7* | 8.6* | 8.6 * | 36 | 20 | 20 |  |  |  | - |  |
| 65 Tb | 150.5* | 150.5* | $7.7 *$ | 2.4* | 45.6* | 28.7* | 22.6* |  |  |  |  |  |
| 66 Dy | 153.6* | 153.6* | $8.0^{*}$ | 4.3* | 49.9* | 26.3 | 26.3 |  |  |  |  |  |
| 67 Ho | 160* | $160^{*}$ | 8.6* | 5.2* | $49.3 *$ | $30.8{ }^{*}$ | 24.1* |  |  |  |  |  |
| 68 Er | 167.6* | $167.6{ }^{*}$ | -- | 4.7* | $50.6{ }^{*}$ | $31.4{ }^{\circ}$ | 24.7* |  |  |  |  |  |
| 69 Tm | 175.5* | 175.5* | - | 4.6 | 54.7* | $31.8{ }^{\text {² }}$ | $25.0{ }^{\circ}$ |  |  |  |  |  |
| 70 Yb | 191.2* | 182.4* | 2.5* | 1.3* | $52.0{ }^{*}$ | 30.34 | 24.1* |  |  |  |  |  |

Table 2-2. Electron binding energies (continued).

| Elemerst | K is | $\mathrm{L}_{1} 2 \mathrm{~s}$. | $\mathrm{L}_{11} \mathbf{2 P}_{1 / 2}$ | $\mathrm{L}_{\text {III }}{ }^{\mathbf{2}} \mathrm{p}_{3 / 2}$ | $\mathrm{M}_{\mathrm{I}} 3 \mathrm{~s}$ | $\mathrm{M}_{11} \mathbf{3 P}_{1 / 2}$ | $\mathrm{M}_{\text {III }} \mathbf{3 p}_{3 / 2}$ | $M_{\text {IV }}{ }^{3} \mathrm{~d}_{3 / 2}$ | $\mathrm{M}_{\mathbf{V}} \mathbf{3} \mathrm{f}_{5 / 2}$ | $\mathrm{N}_{1}{ }^{4}$ | $\mathbf{N}_{\text {II }} \boldsymbol{4}_{\boldsymbol{p}_{\mathbf{1 / 2}}}$ | $\mathbf{N}_{\text {III }} \mathbf{4 P}_{\mathbf{3 / 2}}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 71 Lu | 63314 | 10870 | 10349 | 9244 | 2491 | 2264 | 2024 | . 1639 | 1589 | $506.8{ }^{*}$ | 412.4* | $359.2{ }^{\circ}$ |
| 72 Hf | 65351 | 11271 | 10739 | 9561 | $2601^{\circ}$ | 2365 | 2107 | 1716 | 1662 | $538{ }^{*}$ | $438.2^{\dagger}$ | 380.7 ${ }^{7}$ |
| .73 Ta | 67416 | 11682 | 11136 | 9881 | 2708 | 2469 | 2194 | 1793 | 1735 | $563.4{ }^{\dagger}$ | $463.4^{\dagger}$ | $400.9{ }^{4}$ |
| 74 W | 69525 | 12100 | 1-1544 | 10207 | 2820 | 2575 | 2281 | 1949 | 1809 | 594.1 ${ }^{\dagger}$ | 490.4 ${ }^{\dagger}$ | $423.6{ }^{\text {+ }}$ |
| $75 \mathrm{Re}{ }^{2}$ | 71676 | 12527 | 11959 | 10535 | 2932 | 2682 | 2367 | 1949 | 1883 | $625.4{ }^{\dagger}$ | $518.7{ }^{+}$ | $446.8{ }^{\dagger}$ |
| $76 \mathrm{O5}$ | 73871 | 12968 | 12385 | 10871 | 3049 | 2792 | 2457 | 2031 | 1960 | $658.2{ }^{\dagger}$ | $549.1{ }^{+}$ | $470.7{ }^{4}$ |
| 77 Jr | 76111 | 13419 | 12824 | 11215 | 3174 | 2909 | 2551 | 2116 | 2040 | $691.1^{\dagger}$ | $577.8^{\dagger}$ | $495.8{ }^{\text {* }}$ |
| 78 Pa | 78395 | 13880 | 13273 | 11564 | 3296 | 3027 | 2645 | 2202 | 2122 | $725.4{ }^{\text {t }}$ | $609.1{ }^{\text {t }}$ | $519.4{ }^{+}$ |
| 79 Au | 80725 | 14353 | 13734 | 11919 | 3425 | 3148 | 2743 | 2291 | 2206 | $762.1{ }^{\dagger}$ | $642.7{ }^{\dagger}$ | $546.3^{+}$ |
| 80 HB | 83102 | 14839 | 14209 | 12284 | 3562 | +3279 | 2847 | 2385 | 2295 | $802.2^{\dagger}$ | 680.2 ${ }^{\dagger}$ | $576.6{ }^{\dagger}$ |
| 8171 | 85530 | 15347 | 14698 | 12658 | 3704 | 3416 | 2957 | 2485 | 2389 | $846.2^{\dagger}$ | $720.5{ }^{\dagger}$ | $609.5{ }^{\dagger}$ |
| 82 Pb | 88005 | 15861 | 15200 | 13055 | 3851 | 3554 | - | - 3066 | 2586 | 891.8t. | $761.9{ }^{\dagger}$ | $643.5{ }^{+}$ |
| 83 Bi | 90526 | 16388 | 15711 | 13419. | 3999 | 3696' | . 3177 | 2688 | 2580 | = $939{ }^{\dagger}$ | $805 .{ }^{\dagger}$ | $678.8{ }^{\text {t }}$ |
| 84 PO | 93105 | 16939 | 16244. | 13814 | 4149 | 3854 | 3302 | 2798 | 2683 | 995* | 851* | $705^{*}$ |
| 85 At | 95730 | 17493 | 16785 | 14214 | 4317. | 4008 | 3426 | 2909 | 2787 | 1042* | $886^{\circ}$ | $740^{\circ}$ |
| 86 Ra | 98404. | 18049 | . 17337 | 14619. | 4482 | 4159 | 3538 | 3022 | 2892 | 1097* | $929{ }^{\circ}$ | $768^{*}$ |
| 87 Fr | $101137^{\circ}$ | 18639 | - 17907 | 15031 | 4652 | 4327 | 3663 | 3136 | 3000 | 1153** | 980*- | $810^{*}$ |
| 88 Ra | 103922 | 19237 | 18484 | 15444 | 4822 | 4490 | 3792 | 3248 . | 3105 | 1208* | 1958** | 879** |
| 89 Ac | 106755 | 19840 | 19083 | 15871 | 5002 | 4656 | 3909 | 3370 | 3219 | 1269* | 1080 | $890{ }^{\circ}$ |
| 90 Th | 109651 | 20472 | 19693 | 16300 | 5182 | 4830 | 4046 | 3491 | 3332 | 1330** | 1168* | $966.4{ }^{\text {t }}$ |
| 91 Pa | 112601 | 21105 | 20314 | 16733 | 5367 | 5001 | 4174 | 3611 | 3442 | 1387** | 1224* | 1007* |
| 92 U | 115606 | 21757 | 20948 | 17166 | - 5548 | 5182 | 4303 | 3728 | 3552 | $1439 \%$ | $1271{ }^{\text {\% }}$ b | $1043^{+}$ |

Table 2-2. Electron binding energies (continued).

| Element | $\mathrm{IV}^{4} d_{3 / 2}$ | $\mathrm{N}_{\mathrm{v}}{ }^{4 d_{5 / 2}}$ | $\mathrm{N}_{\mathbf{V I}}{ }^{4 / 5 / 2}$ | $\mathrm{N}_{\mathrm{VII}}{ }^{4 f_{7 / 2}}$ | $\mathrm{O}_{1} 5$ | $\mathrm{O}_{11} \mathbf{5 p}_{1 / 2}$ | $\mathrm{O}_{\mathrm{II}} \mathbf{5 p}_{3 / 2}$ | $O_{I V} 5 d_{3 / 2}$ | $\mathrm{O}_{\mathrm{V}} \mathrm{Sd}_{5 / 2}$ | $\mathrm{P}_{1} 6 \mathrm{~s}$ | $\mathrm{P}_{\mathrm{Il}} \mathbf{6 p}_{1 / 2}$ | $\mathrm{P}_{1 \mathrm{II}} 6 \mathrm{P}_{3 / 2}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 71 Lu | 206.1* | $196.3^{*}$ | 8.9** | $7.5 *$ | $57.3{ }^{\circ}$ | 33.6* | $26.7^{*}$ | . |  |  |  |  |
| 72 Hf | $220.0^{*}$ | $211.5{ }^{\text {+ }}$ | $15.9{ }^{+}$ | $14.2{ }^{+}$ | $64.2{ }^{\dagger}$ | $38{ }^{\text {\% }}$ | $29.9{ }^{\dagger}$. |  | - |  |  |  |
| 73 Ta | $237.9{ }^{\circ}$ | $226.4{ }^{+}$ | $23.5{ }^{+}$ | $21.6{ }^{\dagger}$ | $69.7{ }^{\dagger}$ | 42.2* | $32.7{ }^{\dagger}$ |  |  |  |  |  |
| 74 w | $255.9{ }^{\dagger}$ | $243.5{ }^{\text {+ }}$ | $33.6 *$ | $31.4{ }^{\dagger}$ | $75.6{ }^{\dagger}$ | 45.30 b | $36.8{ }^{\dagger}$ |  |  |  |  |  |
| 75 Rc | $273.9{ }^{\text {* }}$ | $260.5{ }^{+}$ | 42.9* | 40.5* | $83^{\dagger}$ | $45.6{ }^{\dagger}$ | $34.6{ }^{*} \mathrm{~b}$ |  | , |  |  |  |
| 76 Os | $293.1{ }^{\text {+ }}$ | $278.5{ }^{+}$ | $52.4{ }^{+}$ | $50.7{ }^{\dagger}$ | $83^{\dagger}$ | 58* | $44.5{ }^{\dagger}$ |  |  |  |  |  |
| 77 lr | $311.9{ }^{\text {t }}$ | $296.3^{\dagger}$ | $63.8{ }^{\dagger}$ | $60.8{ }^{\dagger}$ | 95.2*b | 63.0 * | $48.0{ }^{\dagger}$ | . | . | . |  |  |
| 78 PI | $331.6{ }^{\dagger}$ | $314.6{ }^{\dagger}$ | $74.5{ }^{+}$ | $71.2{ }^{\dagger}$ | 101.7* ${ }^{\text {b }}$ | $65.3{ }^{*} \mathrm{~b}$ | $51.7{ }^{+}$ | . |  |  |  |  |
| 79 Au | $353.2{ }^{\text {t }}$ | $335.1{ }^{\dagger}$ | $87.6^{+}$ | $83.9{ }^{+}$ | 107.2*b | $74.2^{+}$ | 57.2 ${ }^{\dagger}$ |  | $\cdots$ |  | , |  |
| 80 Hg | $378.2{ }^{\text {¢ }}$ | $358.8^{\dagger}$ | $104.0^{+}$ | $99.9{ }^{\text { }}$ | $127^{\dagger}$ | $83.1{ }^{+}$ | $64.5{ }^{\dagger}$ | $9.6{ }^{\text {t }}$ | 7.8 ${ }^{\text {+ }}$ |  |  | - |
| 81 Ti | $405.7^{\dagger}$ | $385.0^{4}$ | $122.2{ }^{+}$ | $117.8{ }^{\dagger}$ | $136 .{ }^{\circ} \mathrm{b}$ | - 94.6 ${ }^{+}$ | 73.5 ${ }^{+}$ | $14.7{ }^{\dagger}$ | $12.5{ }^{\dagger}$ |  |  |  |
| 82 Pb | $434.3{ }^{\text {t }}$ | $412.2{ }^{+}$ | $141.7^{\dagger}$ | $136.9{ }^{\text {t }}$ | $147 \%$ | $106.4^{+}$ | $81.3{ }^{+}$ | $20.7{ }^{\dagger}$ | $18.1{ }^{\text {t }}$ |  |  |  |
| 83 Bi | $464.0{ }^{\dagger}$ | $440.1{ }^{\text {+ }}$ | $162.3{ }^{\text {+ }}$ | $157.0^{\dagger}$ | $159.3{ }^{\circ} \mathrm{b}$ | $119.0^{+}$ | $92.6{ }^{+}$ | $26.9{ }^{\dagger}$ | $23.8{ }^{\dagger}$ |  | . |  |
| 84 Po. | $500 *$ | 473* | $184^{\circ}$ | 184* | 177** | 132* | 104* | 31*. | $31 *$ |  |  |  |
| 85 Al | 533* | 407* | $210{ }^{*}$ | $210{ }^{*}$ | , 195* | $148{ }^{*}$ | 115* | 40* | $40^{*}$ |  |  |  |
| 86 Rn | 567* | $541 *$ | $238{ }^{\circ}$ | 238* | 214* | $164{ }^{\prime \prime}$ | 127* | $48^{*}$ | 48* | 26 | . |  |
| 87 Fr . | 603* | 577*. | 268* | 268* | $234 *$. | 182* | $140^{*}$ | $58{ }^{*}$ | 58* | 34 | 15 | 15 |
| 88 Ra | $636 *$ | 603* | 299** | 299** | 254* | 200* | 153* | $68 *$ | $68{ }^{*}$ | 44 | - 19 | 19 |
| 89 Ac | 675* | 639** | $310^{*}$ | 319** | 272* | 215* | 167** | 80* | $80^{*}$ | - | - | - |
| 90 Th | $712.1{ }^{\dagger}$ | $675.2{ }^{\dagger}$ | $342.4{ }^{\text {¢ }}$ | $333.1{ }^{+}$ | 290*a | 229** | 182* ${ }^{\text {a }}$ | $92.5{ }^{*}$ | $85.4{ }^{\dagger}$ | $41.4{ }^{\dagger}$ | $24.5{ }^{\dagger}$ | $16.6{ }^{+}$ |
| 91 Pa | 743* | 708* | 371* | $360{ }^{*}$ | $310^{*}$ | $232{ }^{*}$ | 232*, | 94* | 94* | $\bigcirc$ | - | - |
| 92 L | $778.3{ }^{\dagger}$ | $736.2^{\dagger}$ | 388.2* | $377.4{ }^{+}$ | . $321^{\circ} \mathrm{ab}$ | 257** ${ }^{\text {ab }}$ | 192* ${ }^{\circ}$ b | $102.8{ }^{\dagger}$ | $94.2{ }^{+}$ | $43.9{ }^{\dagger}$ | . $26.8{ }^{\dagger}$ | $16.8{ }^{\dagger}$ |

### 2.3 CHARACTERISTIC X-RAY ENERGIES

Jeffrey B. Kortright

In Table 2-3 and Fig. 2-1, characteristic $K$ and $L$ x-ray line energies are given for elements with $3 \leqslant Z \leqslant 95$. Only the strongest lines are included: $K \alpha_{1}, K \alpha_{2}, K \beta_{1}, L \alpha_{1}, L \alpha_{2}, L \beta_{1}$, $L \beta_{2}$, and $L \gamma_{1}$. The table presents the energies of these lines, for each of the elements, in order of increasing atomic number. Wavelengths, in angstroms, can be obtained from the relation $\lambda=12.4 / E$, where $E$ is in keV . The data in the table were taken from Ref. 1, which should be consulted for a complete listing of all lines. Widths of the $K \alpha$ lines can be found in Ref. 2. Figure 2-1 shows the approximate energies and wavelengths of principal $x$-ray lines below 40 keV .

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Table 2-3. Energies, in electron volts, of principal $x$-ray emission lines.

| Element | $\mathrm{K} \alpha_{1}$ | $\mathrm{K} \mathrm{N}_{2}$ | $\mathbf{K} \boldsymbol{\beta}_{1}$ | $\underline{L}{ }_{1}$ | $L \alpha_{2}$ | $L^{1} \beta_{1}$ | $\underline{L} \beta_{2}$ | $\mathbf{L} \gamma_{1}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 3 Li | 0.0543 |  |  |  |  |  |  |  |
| 4 Be | 0.1085 |  |  |  |  |  |  |  |
| 5 B | 0.1833 |  |  |  |  |  |  |  |
| 6 C | 0.277 |  |  |  |  |  |  |  |
| 7 N | 0.3924 |  |  |  |  |  |  |  |
| 80 | 0.5249 |  |  |  |  |  |  |  |
| 9 F | 0.6768 |  |  |  |  |  |  |  |
| 10 Ne | 0.8486 | 0.8486 |  |  |  |  |  |  |
| 11 Na | 1.04098 | 1.04098 | 1.0711 |  |  |  |  |  |
| 12 Mg | 1.25360 | 1.25360 | 1.3022 |  |  |  |  |  |
| 13 Al | 1.48670 | 1.48627 | 1.55745 |  |  |  |  |  |
| 14 Si | 1.73998 | 1.73938 | 1.83594 |  |  |  |  |  |
| 15 P | 2.0137 | 2.0127 | 2.1391 |  |  | . |  |  |
| 16 S | 2.30784 | 2.30664 | 2.46404 |  |  |  |  |  |
| 17 Cl | 2.62239 | 2.62078 | 2.8156 |  |  |  |  |  |
| 18 Ar | 2.95770 | 2.95563 | 3.1905 |  |  |  |  |  |
| 19 K | 3.3138 | 3.3111 | 3.5896 |  |  |  |  |  |
| 20 Ca | 3.69168 | 3.68809 | 4.0127 | 0.3413 | 0.3413 | 0.3449 |  |  |
| 21 Sc | 4.0906 | 4.0861 | 4.4605 | 0.3954 | 0.3954 | 0.3996 |  |  |

Table 2-3. Energies of $x$-ray emission lines (continued).

| Element | $\mathbf{K} \boldsymbol{\alpha}_{\mathbf{1}}$ | $\mathbf{K} \boldsymbol{\alpha}_{\mathbf{2}}$ | $\mathbf{K} \boldsymbol{\beta}_{\mathbf{1}}$ | $\mathbf{L} \boldsymbol{\alpha}_{\mathbf{1}}$ | $\mathbf{L} \boldsymbol{\alpha}_{\mathbf{2}}$ | $\mathbf{L} \boldsymbol{\beta}_{\mathbf{1}}$ | $\mathbf{L} \boldsymbol{\beta}_{\mathbf{2}}$ | $\mathbf{L} \boldsymbol{\gamma}_{\mathbf{1}}$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 22 Ti | 4.51084 | 4.50486 | 4.93181 | 0.4522 | 0.4522 | 0.4584 |  |  |
| 23 V | 4.95220 | 4.94464 | 5.42729 | 0.5113 | 0.5113 | 0.5192 |  |  |
| 24 Cr | 5.41472 | 5.405509 | 5.9467 .1 | 0.5728 | 0.5728 | 0.5828 |  |  |
| 25 Mn | 5.89875 | 5.88765 | 6.49045 | 0.6374 | 0.6374 | 0.6488 |  | - |
| 26 Fe | 6.40384 | 6.39084 | 7.05798 | 0.7050 | 0.7050 | 0.7185 |  |  |
| 27 Co | 6.93032 | 6.91530 | 7.64943 | 0.7762 | 0.7762 | 0.7914 |  |  |
| 28 Ni | 7.47815 | 7.46089 | 8.26466 | 0.8515 | 0.8515 | 0.8688 |  |  |
| 29 Cu | 8.04778 | 8.02783 | 8.90529 | 0.9297 | 0.9297 | 0.9498 |  |  |
| 30 Zn | 8.63886 | 8.61578 | 9.5720 | 1.0117 | 1.0117 | 1.0347 |  |  |
| 31 Ga | 9.25174 | 9.22482 | 10.2642 | 1.09792 | 1.09792 | 1.1248 |  |  |
| 32 Ge | 9.88642 | 9.85532 | 10.9821 | 1.18800 | 1.18800 | 1.2185 |  |  |
| 33 As | 10.54372 | 10.50799 | 11.7262 | 1.2820 | 1.2820 | 1.3170 |  |  |
| 34 Se | 11.2224 | 11.1814 | 12.4959 | 1.37910 | 1.37910 | 1.41923 |  |  |
| $35 \mathrm{Br} *$ | 11.9242 | 11.8776 | 13.2914 | 1.48043 | 1.48043 | 1.52590 |  |  |
| 36 Kr | 12.649 | 12.598 | 14.112 | 1.5860 | 1.5860 | 1.6366 |  |  |
| 37 Rb | 13.3953 | 13.3358 | 14.9613 | 1.69413 | 1.69256 | 1.75217 |  |  |
| 38 Sr | 14.1650 | 14.0979 | 15.8357 | 1.80656 | 1.80474 | 1.87172 |  |  |
| 39 Y | 14.9584 | 14.8829 | 16.7378 | 1.92256 | 1.92047 | 1.99584 |  |  |
| 40 Zr | 15.7751 | 15.6909 | 17.6678 | 2.04236 | 2.0399 | 2.1244 | 2.2194 | 2.3027 |


| 41 Nb | 16.6151 | 16.5210 | 18.6225 | 2.16589 | 2.1630 | 2.2574 | 2.3670 | 2.4618 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 42 Mo | 17.47934 | 17.3743 | 19.6083 | 2.29316 | 2.28985 | 2.39481 | 2.5183 | 2.6235 |
| 43 Tc | 18.3671 | 18.2508 | 20.619 | 2.4240 | - | 2.5368 | - | - |
| 44 Ru | 19.2792 | 19.1504 | 21.6568 | 2.55855 | 2.55431 | 2.68323 | 2.8360 | 2.9645 |
| 45 Rh | 20.2161 | 20.0737 | 22.7236 | 2.69674 | 2.69205 | 2.83441 | 3.0013 | 3.1438 |
| 46 Pd | 21.1771 | 21.0201 | 23.8187 | 2.83861 | 2.83329 | 2.99022 | 3.17179 | 3.3287 |
| 47 Ag | 22.16292 | 21.9903 | 24.9424 | 2.98431 | 2.97821 | 3.15094 | 3.34781 | 3.51959 |
| 48 Cd | 23.1736 | 22.9841 | 26.0955 | 3.13373 | 3.12691 | 3.31657 | 3.52812 | 3.71686 |
| 49 In | 24.2097 | 24.0020 | 27.2759 | 3.28694 | 3.27929 | 3.48721 | 3.71381 | 3.92081 |
| 50 Sn | 25.2713 | 25.0440 | 28.4860 | 3.44398 | 3.43542 | 3.66280 | 3.90486 | 4.13112 |
| 51 Sb | 26.3591 | 26.1108 | 29.7256 | 3.60472 | 3.59532 | 3.84357 | 4.10078 | 4.34779 |
| 52 Te | 27.4723 | 27.2017 | 30.9957 | 3.76933 | 3.7588 | 4.02958 | 4.3017 | 4.5709 |
| 53 I | 28.6120 | 28.3172 | 32.2947 | 3.93765 | 3.92604 | 4.22072 | 4.5075 | 4.8009 |
| 54 Xe | 29.779 | 29.458 | 33.624 | 4.1099 | - | - | - |  |
| 55 Cs | 30.9728 | 30.6251 | 34.9869 | 4.2865 | 4.2722 | 4.6198 | 4.9359 | 5.2804 |
| 56 Ba | 32.1936 | 31.8171 | 36.3782 | 4.46626 | 4.45090 | 4.82753 | 5.1565 | 5.5311 |
| 57 La | 33.4418 | 33.0341 | 37.8010 | 4.65097 | 4.63423 | 5.0421 | 5.3835 | 5.7885 |
| 58 Ce | 34.7197 | 34.2789 | 39.2573 | 4.8402 | 4.8230 | 5.2622 | 5.6134 | 6.052 |
| 59 Pr | 36.0263 | 35.5502 | 40.7482 | 5.0337 | 5.0135 | 5.4889 | 5.850 | 6.3221 |
| 60 Nd | 37.3610 | 36.8474 | 42.2713 | 5.2304 | 5.2077 | 5.7216 | 6.0894 | 6.6021 |
| 61 Pm | 38.7247 | 38.1712 | 43.826 | 5.4325 | 5.4078 | 5.961 | 6.339 | 6.892 |
| 62 Sm | 40.1181 | 39.5224 | 45.413 | 5.6361 | 5.6090 | 6.2051 | 6.586 | 7.178 |

Table 2-3. Energies of $x$-ray emission lines (continued).

| Element | $\mathbf{K} \boldsymbol{\alpha}_{\mathbf{1}}$ | $\mathbf{K} \boldsymbol{\alpha}_{\mathbf{2}}$ | $\mathbf{K} \boldsymbol{\beta}_{\mathbf{1}}$ | $\mathbf{L} \boldsymbol{\alpha}_{\mathbf{1}}$ | $\mathbf{L} \boldsymbol{\alpha}_{\mathbf{2}}$ | $\mathbf{L} \boldsymbol{\beta}_{\mathbf{1}}$ | $\mathbf{L} \boldsymbol{\beta}_{\mathbf{2}}$ | $\mathrm{L} \boldsymbol{\gamma}_{\mathbf{1}}$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 63 Eu | 41.5422 | 40.9019 | 47.0379 | 5.8457 | 5.8166 | 6.4564 | 6.8432 | 7.4803 |
| 64 Gd | 42.9962 | 42.3089 | 48.697 | 6.0572 | 6.0250 | 6.7132 | 7.1028 | 7.7858 |
| 65 Tb | 44.4816 | 43.7441 | 50.382 | 6.2728 | 6.2380 | 6.978 | 7.3667 | 8.102 |
| 66 Dy | 45.9984 | 45.2078 | 52.119 | 6.4952 | 6.4577 | 7.2477 | 7.6357 | 8.4188 |
| 67 Ho | 47.5467 | 46.6997 | 53.877 | 6.7198 | 6.6795 | 7.5253 | 7.911 | 8.747 |
| 68 Er | 49.1277 | 48.2211 | 55.681 | 6.9487 | 6.9050 | 7.8109 | 8.1890 | 9.089 |
| 69 Tm | 50.7416 | 49.7726 | 57.517 | 7.1799 | 7.1331 | 8.101 | 8.468 | 9.426 |
| 70 Yb | 52.3889 | 51.3540 | 59.37 | 7.4156 | 7.3673 | 8.4018 | 8.7588 | 9.7801 |
| 71 Lu | 54.0698 | 52.9650 | 61.283 | 7.6555 | 7.6049 | 8.7090 | 9.0489. | 10.1434 |
| 72 Hf | 55.7902 | 54.6114 | 63.234 | 7.8990 | 7.8446 | 9.0227 | 9.3473 | 10.5158 |
| 73 Ta | 57.532 | 56.277 | 65.223 | 8.1461 | 8.0879 | 9.3431 | 9.6518 | 10.8952 |
| 74 W | 59.31824 | 57.9817 | 67.2443 | 8.3976 | 8.3352 | 9.67235 | 9.9615 | 11.2859 |
| 75 Re | 61.1403 | 59.7179 | 69.310 | 8.6525 | 8.5862 | 10.0100 | 10.2752 | 11.6854 |
| 76 Os | 63.0005 | 61.4867 | 71.413 | 8.9117 | 8.8410 | 10.3553 | 10.5985 | 12.0953 |
| 77 Ir | 64.8956 | 63.2867 | 73.5608 | 9.1751 | 9.0995 | 10.7083 | 10.9203 | 12.5126 |
| 78 Pt | 66.832 | 65.112 | 75.748 | 9.4423 | 9.3618 | 11.0707 | 11.2505 | 12.9420 |
| 79 Au | 68.8037 | 66.9895 | 77.984 | 9.7133 | 9.6280 | 11.4423 | 11.5847 | 13.3817 |
| 80 Hg | 70.819 | 68.895 | 80.253 | 9.9888 | 9.8976 | 11.8226 | 11.9241 | 13.8301 |
| 81 Tl | 72.8715 | 70.8319 | 82.576 | 10.2685 | 10.1728 | 12.2133 | 12.2715 | 14.2915 |.


| 82 Pb | 74.9694 | 72.8042 | 84.936 | 10.5515 | 10.4495 | 12.6137 | 12.6226 | 14.7644 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 83 Bi | 77.1079 | 74.8148 | 87.343 | 10.8388 | 10.73091 | 13.0235 | 12.9799 | 15.2477 |
| 84 Po | 79.290 | 76.862 | 89.80 | 11.1308 | 11.0158 | 13.447 | 13.3404 | 15.744 |
| 85 At | 81.52 | 78.95 | 92.30 | 11.4268 | 11.3048 | 13.876 | - | 16.251 |
| 86 Rn | 83.78 | 81.07 | 94.87 | 11.7270 | 11.5979 | 14.316 | - | 16.770 |
| 87 Fr | 86.10 | 83.23 | 97.47 | 12.0313 | 11.8950 | 14.770 | 14.45 | 17.303 |
| 88 Ra | 88.47 | 85.43 | 100.13 | 12.3397 | 12.1962 | 15.2358 | 14.8414 | 17.849 |
| 89 Ac | 90.884 | 87.67 | 102.85 | 12.6520 | 12.5008 | 15.713 | - | 18.408 |
| 90 Th | 93.350 | 89.953 | 105.609 | 12.9687 | 12.8096 | 16.2022 | 15.6237 | 18.9825 |
| 91 Pa | 95.868 | 92.287 | 108.427 | 13.2907 | 13.1222 | 16.702 | 16.024 | 19.568 |
| 92 U | 98.439 | 94.665 | 111.300 | 13.6147 | 13.4388 | 17.2200 | 16.4283 | 20.1671 |
| 93 Np | - | - | - | 13.9441 | 13.7597 | 17.7502 | 16.8400 | 20.7848 |
| 94 Pu | - | - | - | 14.2786 | 14.0842 | 18.2937 | 17.2553 | 21.4173 |
| 95 Am | - | - | - | 14.6172 | 14.4119 | 18.8520 | 17.6765 | 22.0652 |

Wavelength $(\AA)$


Fig. 2-I. Approximate energies and wavelengths of principal $x$-ray emission lines below 40 keV .

### 2.4 FLUORESCENCE YIELDS FOR K AND LSHELLS

Jeffrey B. Kortright
Fluorescence yields for the $K$ and $L$ shells for the elements $5 \leqslant Z \leqslant 110$ are plotted in Fig. 2-2; the data are based on Ref. 1. These yields represent the probability of a core hole in the $K$ or $L$ shells being filled by a radiative process, in com-


Fig. 2-2. Fluorescence yields for $K$ and $L$ shells for $5 \leqslant Z \leqslant 110$. The plotted curve for the $L$ shell represents an average of $L_{1}, L_{2}$. and $L_{3}$ effective pields.
petition with nonradiative processes. Auger processes are the only nonradiative processes competing with fluorescence for the $K$ shell and $L_{3}$ subshell holes. Auger and Coster-Kronig nonradiative processes complete with fluorescence to fill $L_{1}$ and $L_{2}$ subshell holes. Only one curve is presented for the three $L$ subshells, representing the average of the $L_{1}, L_{2}$, and $L_{3}$ effective fluorescence yields in Ref. 1, which differ by less than about $10 \%$ over most of the periodic table. See Ref. 1 for more detail on the $L$ subshell rates and the nonradiative rates, and for an appendix containing citations to the theoretical and experimental work upon which Fig. 2-2 is based. Widths of the $K$ and $L$ fluorescence lines can be found in Ref. 2.

## REFERENCES

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### 2.5 PRINCIPAL AUGER <br> ELECTRON ENERGIES

Figure 2-3 has been reproduced by permission of the Physical Electronics Division of Perkin-Elmer, Inc. For each element, dots indicate the energies of principal Auger peaks, the predominant ones represented by the heavier dots. The families of Auger transitions are denoted by labels of the form $W X Y$, where $W$ is the shell in which the original vacancy occurs, $X$ is the shell from which the $W$ vacancy is filled, and $Y$ is the shell from which the Auger electron is ejected.


Fig. 2-3. Auger electron energies for the elements. (Reproduced by permission of the Physical Electronics Division of Perkin. Elmer, Inc.)

### 2.6 ENERGY LEVELS OF HYDROGEN-, HELIUM-, AND NEONLIKE IONS

James H. Scofield

Table 2-4 presents ionization energies for selected few-electron ions with $6 \leqslant Z \leqslant 54$. Table $2-5$ gives the energies of the resonant $2 p$ transitions in hydrogen- and heliumlike ions. Because of the interest in lasers based on neonlike ions in the soft x -ray region, selective transitions for the neonlike ions are presented in Table 2-6. This table includes the two lines for which lasing has been observed in selenium [1], the depopulating transition of the lower lasing level, and two strong lines in the spontaneous spectrum. In addition, Fig. 2-4 shows the $2 p^{5} 3 /$ levels for neonlike selenium. The level positions are labeled with a designation of the form $2 S+1_{L_{J}}$ and a $j j$ coupling label.

The energy values in this section have been generated using the relativistic Hartree-Fock code of I. P. Grant and collaborators [2] with a correction term of the form $A+B /(Z-Q)$ added to bring about agreement with the experimental values known for low atomic numbers. Nuclear size effects, radiative corrections, and the Breit interaction accounting for retardation and the magnetic electron-electron interaction are included in the calculations. The hydrogenic values are uncorrected as they come from the code, but to the accuracy ${ }^{\text {. }}$ given here, they agree with more detailed calculations. The $n=3$ 10 $n=2$ values given in Table 2-6 for the neonlike ions are also uncorrected and show differences at the $2-\mathrm{eV}$ level with experimental values.

## REFERENCES

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2. I. P. Grant, B. J. McKenzie, P. H. Norrington, D. F. Mayers, and N. C. Pyper, "An Atomic Multiconfigurational Dirac-Fock Package," Comput. Phys. Commun. 21, 207 (1980).

Table 2-4. Ionization energies, in electron volts. for selected fewelectron ionic species. Each column is labeled with the number of electrons in the ion before ionization and with the symbol for the neutral atom with the same number of electrons.

| Element | 1 (H) | 2 (He) | 3 (Li) | 4 (Be) | 10 (Ne) | 11 (Na) | 12 (Mg) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 6 C | 490.0 | 392.1 | 64,49 | 47.89 |  |  |  |
| 7 N | 667.1 | 552.1 | 97.89 | 77.48 |  |  | . |
| 80 | 871.4 | 739.3 ${ }^{-}$ | 138.11 | 113.90 |  | - - |  |
| 9 F | 1103.1 | 953.9 | 185.18 | 157.15 |  |  |  |
| 10 Ne | 1362.2 | 1195.8 | 239.09 | 207.26 | 21.564 |  |  |
| 11 Na | 1648.7 | 1465.1 | 299.86 | 264.21 | 47.286 | 5.139 |  |
| 12 Mg | 1962.7 | 1761.8 | 367.5 | 328.0 | 80.143 | 15.035 | 7.646 |
| 13 Al | 2304.2 | 2086.0 | 442.0 | 398.7 | 119.99 | 28.447 | 18.828 |
| 14 Si | 2673.2 | 2437.7 | 523.4 | 476.3 | 166.42 | 45.12 | 33.64 |
| is P | 3070 | 2816.9 | 611.7 | 560.8 | 220.31 | 65.02 | 51.50 |
| 16 S | 3494 | 3224 | 707.0 | 652.1 | 281.00 | 88.05 | 72.59 |
| 17 Cl | 3946 | 3658 | 809.2 | 750.5 | 348.5 | 114.20 | 96.84 |
| 18 Ar | 4426 | 4121 | 918.4 | 855.8 | 422.8 | 143.46 | 124.24 |
| 19 K | 4934 | 4611 | 1034.6 | 968.0 | 503.9 | 175.82 | 154.75 |
| 20 Ca | 5470 | 5129 | 1157.7 | 1087.3 | 591.9 | 211.28 | 188.38 |
| 21 Sc | 6034 | 5675 | 1288.0 | 1213.6 | 686.6 | 249.84 | 225.13 |
| 22 Ti | 6626 | 6249 | 1425.3 | 1346.9 | 788.2 | 291.50 | 264.98 |
| 23 V | 7246 | 6851 | 1569.7 | 1487.3 | 896.6 | 336.3 | 307.9 |
| 24 Cr | 7895 | 7482 | 1721.2 | 1634.8 | 1011.8 | 384.2 | 354.0 |
| 25 Mn | 8572 | 8141 | 1879.9 | 1789.5 | 1133.8 | 435.2 | 403.2 |
| 26 Fe | 9278 | 8828 | 2045.8 | 1951.3 | 1262.7 | 489.3 | 455.6 |
| 27 Co | 10012 | 9544 | 2218.9 | 2120.4 | 1398.3 | 546.6 | 514.0 |
| 28 Ni | 10775 | 10289 | 2399.3 | 2296.7 | 1540.8 | 607.0 | 569.7 |
| 29 Cu | 11461 | 10969 | 2559.1 | 2455.1 | 1690.2 | 670.6 | 631.4 |
| 30 Zn | 12389 | 11865 | 2782.0 | 2671.1 | 1846.4 | 737.3 | 696.4 |
| 31 Ga | 13239 | 12696 | 2984.4 | 2869.4 | 2009.4 | 807.3 | 764.5 |
| 32 Ge | 14119 | 13557 | 3194 | 3075 | 2179.3 | 880.4 | 835.8 |
| 33 As | 15029 | 14448 | 3412 | 3288 | 2356.0 | 956.8 | 910.3 |
| 34 Se | 15968 | 15367 | 3637 | 3509 | 2539.6 | 1036.3 | 988.1 |
| ${ }^{35} \mathrm{Br}$ | 16937 | 16317 | . 3869 | 3737 | 2730.1 | 1119.1 | 1069.1 |
| 36 Kr | 17936 | 17296 | 4109 | 3973 | 2927.4 | 1205.2 | 1153.3 |
| 37 Rb | 18965 | 18306 | 4357 | 4216 | 3132 | 1294.5 | 1240.8 |
| 38 SI | 20025 | 19345 | 4612 | 4467 | 3343 | 1387.2 | 1331.5 |
| 39 Y | 21115 | 20415 | 4876 | 4726 | 3561 | 1483.1 | 1425.6 |
| 40 Zr | 22237 | 21516 | 5147 | 4993 | 3786 | 1582.4 | 1523.0 |
| 41 Nb | 23389 | 22648 | 5426 | 5268 | 4017 | 1684.9 | 1623.7 |
| 42 Mo | 24572 | 23810 | 5713 | 5550 | 4256 | 1790.9 | 1727.8 |
| ${ }^{43} \mathrm{Tc}$ | . 25787 | 25004 | 6008 | 5841 | 4502 | 1900.3 | 1835.2 |
| 44 Ru | 27033 | 26230 | 6312 | 6140 | 4754 | 2013.0 | 1946.1 |
| 45 Rh | 28312 | 27487 | 6623 | 6447 | 5014 | 2129.2 | 2060.3 |
| 46 Pd | 29623 | 28776 | 6943 | 6762 | 5280 | 2248.9 | 2178.0 |
| 47 AB | 30966 | 30097 | 7271 | 7086 | 5553 | 2372.0 | 2299.2 |
| 48 Cd | 32341 | 31451 | 7608 | 7418 | 5834 | 2498.6 | 2423.9 |
| 49 If | 33750 | 32837 | 7953 | 7758 | 6121 | 2628.8 | 2552.1 |
| 50 Sn | 35192 | 34257 | 8307. | 8107 | 6415 | 2762.5 | 2683.9 |
| SISb | 36668 | 35710 | 8670 | 8465 | 0717 | 2899.8 | 2819.2 . |
| 52 Te | 38177 | 37196 | 9041 | 88.12 | 7025 | 3041 | 2958.1 |
| $531{ }^{\circ}$ | 39721 | 38716 | 9421 | 9207 | 7340 | 3185 | 3101 |
| 54 Xe | 41300 | 40271 | 9810 | 9591 | 7663 | 3334 | 3247 |

Table 2-5. Transition energies, in electron volts, for transitions from the $n=2$ states to the $n=1$ ground state of H - and He-like ions.

| Element | Hydrogenlike |  | Heliumlike |  |
| :---: | :---: | :---: | :---: | :---: |
|  | $2 \mu_{1 / 2}$ | $2 p_{3 / 2}$ | $2^{\rho}{ }^{3} \mathrm{P}_{1}$ | ${ }_{2 p}{ }^{1} P_{1}$ |
| 58 | 255.17 | 255.20 . | 202.78 | 205.37 |
| 6 C | 367.5 | 367.5 | 304.3 | $307.8{ }^{\text {' }}$ |
| 7 N | 500.3 | 500.4 | 426.3 | 430.7 |
| 80 | 653.5 | 653.7 | 568.7 | 574.0 |
| 9 F | 827.3 | 827.6 | 731.5 | 737.8 |
| 10 Ne | 1021.5 | 1022.0 | 914.9 | 922.1 |
| 11 Na | 1236.3 | 1237.0 | 1118.8 | 1126.9 |
| 12 Mg | 1471.7 | 1472.7 | 1343.2 | 1352.3 |
| 13 Al | 1727.7 | 1729.0 | 1588.3 | 1598.4 |
| 14 Si | 2004.3 | 2006.1 | 1853.9 | 1865.1 |
| 15 P | 2301.7 | 2304.0 | 2140.3 | 2152.6 |
| 16 S | 2619.7 | 2622.7 | 2447.3 | 2460.8 |
| 17 Cl | 2958.5 | 2962.4 | 2775.1 | 2789.8 |
| 18 Ar | 3318 | 3323 | 3124 | 3140 |
| 19 K | 3699 | 3705 | 3493 | 3511 |
| 20 Ca | 4100 | 4108 | 3883 | 3903 |
| 21 Sc | 4523 | 4532 | 4295 | 4316 |
| 22 Ti | 4966 | 4977 | 4727 | 4750 |
| 23 V | 5431 | 5444 | 5180 | 5205 |
| 24 Cr | 5917 | 5932 | 5655 | 5682 |
| 25 Mn | 6424 | 6442 | 6151 | 6181 |
| 26 Fe | 6952 | 6973 | 6668 | 6701 |
| 27 Co | 7502 | 7526 | 7206 | 7242 |
| 28 Ni | 8073 | 8102 | 7766 | 7806 |
| 29 Cu | 8593 | 8599 | 8280 | 8307 |
| 30 Zn | 9281 | 9318 | 8950 | 8999 |
| 31 Ga | 9917 | 9960 | 9575 | 9628 |
| 32 Gc | 10575 | 10624 | 10221 | 10280 |
| 33 As | '11255 | 11311 | 10889 | 10955 |
| 34 Se | 11958 | 12021 | 11579 | 1165 ? |
| 35 Br | 12682 | 12753 | 12292 | 12372 |
| 36 Kr | 13429 | 13509 | 13026 | 13114 |
| 37 Rb | 14199 | 14288 | 13783 | 13880 |
| 38 Sr | 14990 | 15090 | 14562 | 14669 |
| 39 Y | 15805 | 15916 | 15364 | 15482 |
| 40 Zr | 16643 | 16765 | 16189 | 16318 |
| 41 Nb | 17503 | 17639 | 17036 | 17178 |
| 42 Mo | 18387 | 18537 | 17907 | 18062 |
| 43 Tc | 19294 | 19459 | 18800 | 18971 |
| 44 Ru | 20224 | 20406 | 19717 | 19904 |
| 45 Rh | 21178 | 21377 | 20658 | 20861 |
| 46 Pd | 22156 | 22374 | . 21622 | 21843 |
| 47 Ag | 23157 | 23396 | 22609 | 22851 |
| 48 Cd | 24183 | 24444 | 23621 | 23884 |
| 49 ln | 25233 | 25518 | 24657 | 24942 |
| 50 Sn | 26308 | 26617 | 25717 | 26027 |

Table 2-6. Transition energies, in electron volts, for selected transitions in Ne-like ions with 2p vacancies. The transitions for which lasing has been observed are indicated in boldface type.

| Element | $\begin{gathered} 3 s-2 p \\ { }^{3} \mathbf{P}_{1}-{ }^{1} \mathrm{~S}_{0} \end{gathered}$ | $\begin{array}{r} 3 s-2 p \\ { }^{\mathbf{1}} \mathbf{P}_{1}-{ }^{1} \mathbf{S}_{\mathbf{0}} \end{array}$ | $\begin{gathered} 3 d-\mathbf{2 p} \\ { }^{\mathbf{3}} \mathrm{P}_{1}-{ }^{\mathbf{1}} \mathrm{S}_{6} \end{gathered}$ | $\begin{gathered} 3 p-3 s \\ { }^{3} \mathbf{P}_{2}-{ }^{\mathbf{1}} \mathbf{P}_{1} \end{gathered}$ | $\begin{gathered} 3 p-3 s \\ { }^{\mathbf{1}} \mathrm{D}_{2}-{ }^{3} \mathrm{P}_{1} \end{gathered}$ | $\begin{gathered} 3 d-3 p \\ { }^{3} \mathrm{~F}_{3}-{ }^{3} \mathrm{D}_{2} \end{gathered}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 14 Si | - $103.06=$ | -104.07 | $126.41^{\circ}$ | - $9.849^{\circ}$ | - $10.393{ }^{\circ}-$ | 12.809 |
| 15 P | - 134.41 | 135.66 | 162.77 | 11.776 | 12.403 | -15.565 |
| 16 S | 169.52 | 171.06 | 202.85 | 13.736 | 14.486 | 18.279 |
| 17 Cl | 208.39 | 210.28 | 246.68 | 15.728 | 16.435 | 20.969 |
| 18 At | 251.02 | 253.35 | 294.27 | 17.754 | 18.474 | 23.650 |
| 19 K | 297.38 | 300.3 . | 343.6. | 19.814 | - 20.540 | 26.333 |
| 20 Ca | 347.5 | 351.1 | 400.8 | 21.915 | 22.641 | 29.031 |
| 21 Se | 401.3 | 405.7 | 459.8 | 24.058 | 24.786 | 31.75 |
| 22 Ti | 458.8 | - 464.3 | 522.5 | $26.25!$ | 26.981 | 34.51 |
| 23 V | 520.1 | \$26.8 | 589.1 | 28.497 | 29.235 | 37.31 |
| 24 Cr | 585.1 , | 593.3 | 659.5 | 30.81. | 31.55 | 40.15 |
| 25 Mn | .653.7 | 663.7 . | 733.8 | 33.19 | 33.94 | 43.06 |
| 26 Fe | $\quad 726.1$ | 738.0 | $811.8{ }^{\circ}$ | 35.64 | 36.42 | 46.03 |
| 27 Co | 802.2 | 816.4 | 893.6 | 38.19 | 38.97 | 49.08 |
| 28 Ni | 881.9 | 898.7 | 979.3 | 40.82. | 41.63 | 52.21 |
| 29 Cu | 965.3 | 985.1 | 1068.8 | - 43.56 | 44.39 | 55.43 |
| 30 Zn | 1052.4 | 1075.6 | 1162.1 | 46.41 | 47.27 | - 58.76 |
| 31 Ga | 1143.1 | 1170.1 | 1259.2 | 49.39 | 50.26 | 62.20 |
| 32 Ge | 1237.5 | 1268.7 | 1360.1 | 52.50 | 53.39 | 65.76 |
| 33 As | 1335.5 | 1371.5 | 1464.9 | 55.75 | 56.67 | 69.45 |
| 34 Se | 1437.2 | 1478.4 | 1573.4 | 59.15 | 60.10 | 73.29 |
| 35 Br | 1542.4 | 1589.5 | 1685.8 | 62.72 | 63.70 | 77.28 |
| 36 Kr | 1651.3 | 1704.8 | 1802.0 | 66.47 | 67.48 | 81.43 |
| 37 Rb | 1763.8 | 1824.4 | 1899.3 | 70.41 | 71.45 | 85.77 |
| 38 Sr | 1879.9 | 1948.2 | 2021.9 | 74.56 | 75.62 | 90.30 |
| 39 Y | 1999.6 | 2076.4 | 2148.2 | 78.92 | 80.01 | 95.03 |
| 40 Zr | 2122.8 . | 2208.9 | 2278.4 | 83.52 | 84.64 | 99.99 |
| 41 Nb | 2249.5 | 2345.8 | 2412.4 | 88.37 | 89.51 | 105.17 |
| 42 Mo | 2379.9 | 2487.1 | 2550.2 | 93.48 | 94.65. | 110.61 |
| 43 Tc | 2513.7 | 2632.9 | 2691.8 | 98.87 | 100.06 | 116.31 |
| 44 Ru | 2651.1 | 2783.2 | 2837.3 | 104.56 | 105.77: | 122.29 |
| 45 Rh | 2791.9 | 2938.0 | 2986.6 | 110.57 | 111.80 | 128.57 |
| 46 Pd | 2936.3 | 3097 | 3140 | 116.92 | 118.15 | 135.17 |
| 47 Ag | 3084 | 3262 | 3297 | 123.62 | 124.86 | 142.10 |
| 48 Cd | 3235 | 3430 | 3457 | 130.72 : | 131.93 | 149.38 |
| 49 In | 3390 | 3604 | 3622 | 138.24 | 139.39 | 157.04 |
| ' 50 Sn | 3548 | 3782 | 3791 | 146.32 | 147.27 | 165.09 |



Fig. 2-4. Selected excited energy levels for Ne-like selenium ( $Z=24$, $1 s^{2} 2 s^{2} 2 p^{5} 31 ; 10$ of the 36 levels in this manifold are shown. Transitions for which lasing has been observed are indicated.

### 2.7. SCATTERING FACTORS AND MASS ABSORPTION COEFFICIENTS

Burton L. Henke

At photon energies between 100 eV and 10 keV , accurate calculations for absorption and scattering in material systems (e.g., filters, mirrors, multilayers, and crystals) can be based on atomic scattering factors $\left(f_{1}+i f_{2}\right)$ for the constituent atoms. These factors are derived from available experimental photoabsorption data, using the Kramers-Kronig dispersion relations [1,2]:

$$
\begin{equation*}
f_{1}=Z+C \quad \int_{0}^{\infty} \frac{\epsilon^{2} \mu_{a}(\epsilon) d \epsilon}{E^{2}-\dot{\epsilon}^{2}} \tag{1}
\end{equation*}
$$

and

$$
\begin{equation*}
f_{2}=\frac{\pi}{2} \dot{C} E \mu_{a}(E) \tag{2}
\end{equation*}
$$

where $Z$ is the total number of electrons; $C$ is a constant equal to $1 / \pi r_{0} h c$ with $r_{0}$ the classical electron radius, $h$ Planck's constant, and $c$ the velocity of light; $\mu_{a}(\epsilon)$ is the atomic photoabsorption cross section; and $E$ is the incident photon energy. The atomic photoabsorption cross section (in $\mathrm{cm}^{2} /$ atom) is related to the mass absorption coefficient $\mu$ (in $\mathrm{cm}^{2} / \mathrm{g}$ ) by

$$
\begin{equation*}
\mu_{a}=\left(A / N_{A}\right) \mu, \tag{3}
\end{equation*}
$$

where $A$ is the atomic weight and $N_{A}$ is Avogadro's number.
One may also obtain the complex dielectric constant

$$
\begin{equation*}
\epsilon=1-\alpha^{\prime \prime}-i \gamma \tag{4}
\end{equation*}
$$

and the index of refraction

$$
\begin{equation*}
n=1-\delta-i \beta \tag{5}
\end{equation*}
$$

from the scattering factors by using the relations

$$
\begin{equation*}
\delta=\frac{\alpha}{2}=K f_{1} \tag{6}
\end{equation*}
$$

and

$$
\begin{equation*}
\beta=\frac{\gamma}{2}=K f_{2}, \tag{7}
\end{equation*}
$$

where

$$
\begin{equation*}
K=\frac{r_{0} \lambda^{2}}{2 \pi} \frac{N_{A}}{A} \rho \tag{8}
\end{equation*}
$$

and $\rho$ is the density. The parameters $\beta$ and $\delta$ are called the absorption index and refractive index decrement, respectively.

Figures 2-5 and 2-6 illustrate the variation with atomic number of the mass absorption coefficient for several selected energies, indicating the presence of absorption edges. Near these edges, one expects additional absorption structure, reflecting the molecular and solid states of complex systems. This structure cannot be predicted by calculations that assume atomlike behavior of the system components. Tables 2-7 and 2-8 are a more comprehensive tabulation of the values of the mass absorption cocfficient.

Tables 2-9 through 2-12 tabulate the two components of the atomic scattering factor for selected energies and atomic numbers. Values in the tables are recorded in the form $1.42(-) 02$ to denote the value $1.42 \times 10^{(-) 2}$

## REFERENCES

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2. B. L. Henke, P. Lee, T. J. Tanaka, R. L. Shimabukuro, and B. K. Fujikawa, "Low-Energy X-Ray Interaction Coefficients: . Photoabsorption, Scattering, and Reflection," At. Data Nucl. Data Tables 27, 1 (1982).


Mass absorption coefficients at energies between 250 and 1000 eV ; as functions of atomic number.
4
4
4


Fig. 2-6. Mass absorption coefficients at energies between 2.5 and 10 keV , as functions of atomic number.

Table 2-7. Mass absorption coefficients for selected values of atomic number $Z$ at energies between 100 and 1000 eV .

| $\boldsymbol{Z}$ | 100 | 200 | 300 | 400 | $\begin{gathered} \text { Energy } \\ \mathbf{5 0 0} \end{gathered}$ | $600$ | -700 | 800 | 900 | 1000 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 3 | 1.4205 | 2.4704 | 7.9803 | 3.7103 | 1.8103 | 1.0903 | 6.4902 | 4.4702 | 3.0802. | 2:2802 |
| 6 | 2.3304 | 5.1403 | 4.8304 | 2.4904 | 1.3704 | 8.8903 | 5.7403 | 4.1303 | 2.9603 | 2.2703 |
| 9 | 8.7304 | 1.8804 | 7.0303 | 3.6103 | 1.9703 | 1.2803 | 1.2804 | 9.9103 | 7.3103 | 5.7903 |
| 12 | 1:30 05 | 4.9004 | $2.0004^{\text {. }}$ | 1.0704 | 5.7503 | 3.6903 | 2.3503 | 1.6803 | 1.2103 | 9.2902 |
| 15 | 1.0204 | 6.90 .04 | 3.4504 | 2.0204 | 1.1604 | 7.6503 | 4.9703 | 3.6203 | 2.6103 | $2.0203^{\circ}$ |
| 18 | 1.9204 | 8.0603 | 4.0704 | 2.9004 | 1.7604 | 1.2104 | 8.1003 | 6.0003 | 4.3903 | 3.4203 |
| 21 | 2.6904 | 1.2404 | 6.3503 | 3.9203 | 2.5304 | 1.7804 | 1.2104 | 9.0803 | 6.7503 | 5.3203 |
| 24 | 4.5804 | 1.7904 | 9.0003 | 5.5303 | 3.4103 | 2.3903 | 1.6604 | 1.2604 | 9.5003 | 7.5603 |
| 27 | 6.1304 | 2.6804 | 1.3204 | 7.8703 | 4.8003 | 3.3703 | 2.3603 | 1.4604 | 1.1104 | 9.9103 |
| 30 | 7.8704. | 3.9104 | 2.0004 | 1.1904 | 7.1803 | 4.9303 | 3.4003 | 2.6103 | 1.9603 | 1.5803 |
| 33 | 4.4404 | 4.1504 | 2.4004 | 1.5404 | 9.5503 | 6.7103 | 4.6503 | 3.5603 | 2.6903 | 2.1503 |
| 36 | 9.1803 | 3.9704 | 2.9404 | 2.0404 | 1.2904 | 9.1503 | 6.3703 | 4.8803 | 3.7103 | 2.9703 |
| 39 | 1.3004 | 2.1504 | 2.9204 | 2.5004 | 1.6304 | 1.1804 | 8.3203 | 6.4203 | 4.9103 | 3.9503 |
| 42 | 8.8103 | 5.3503 | 2.0504 | 2.0004 | 1.6904 | 1.3504 | 1.0104 | 8.1503 | 6.2603 | 5.0603 |


| 45 | 5.4103 | 6.6603 | 4.2603 | 1.9304 | 2.0204 | 1.6804 | 1.2904 | 1.0104 | 7.7803 | 6.3103 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 48 | 4.3404 | 6.6403 | 5.3203 | 4.1103 | 2.1804 | 1.6604 | 1.4204 | 1.2004 | 9.3003 | 7.5903 |
| 51 | 7.5204 | 7.0803 | 6.1503 | 4.9703 | 3.6103 | 1.9804 | 1.3404 | 1.1104 | 1.0104 | 8.6803 |
| 54 | 1.2305 | 4.6103 | 6.7503 | 5.6903 | 4.4203 | 3.4803 | 2.2404 | 1.2504 | 9.5503 | 9.3803 |
| 57 | 2.8904 | 3.5503 | 6.6803 | 6.3003 | 4.9103 | 3.9503 | 3.0803 | 2.5303 | 1.0904 | 8.8103 |
| 60 | 1.4304 | 9.9503 | 7.9603 | 7.9603 | 5.9803 | 4.7403 | 3.6703 | 3.0003 | 2.4203 | 8.9703 |
| 63 | 1.7304 | 2.3004 | 1.1304 | 9.4803 | 6.9903 | 5.4803 | 4.2103 | 3.4503 | 2.7803 | 2.3303 |
| 66 | 3.2504 | 2.5704 | 1.6704 | 1.1704 | 8.3503 | 6.4903 | 4.9403 | 4.0103 | 3.2203 | 2.6903 |
| 69 | 2.8804 | 2.2404 | 1.5504 | 1.2404 | 1.0004 | 7.8503 | 5.9703 | 4.8103 | 3.8403 | 3.2103 |
| 72 | 2.1004 | 2.1204 | 1.6504 | 1.2804 | 1.0604 | 8.8603 | 6.7603 | 5.4603 | 4.3803 | 3.6603 |
| 75 | 1.6204 | 1.8704 | 1.7404 | 1.4004 | 1.1504 | 9.6703 | 7.6903 | 6.2503 | 5.0303 | 4.2103 |
| 78 | 1.9204 | 1.6004 | 1.5804 | 1.5104 | 1.1804 | 1.0604 | 8.3803 | 7.2303 | 5.8303 | 4.8803 |
| 81 | 2.3104 | 9.6203 | 1.5004 | 1.4904 | 1.2604 | 1.0504 | 9.2903 | 7.7903 | 6.6303 | 5.6403 |
| 84 | 4.9704 | 6.0903 | 1.2004 | 1.4104 | 1.4004 | 1.1504 | 9.2503 | 8.5703 | 7.0403 | 6.2003 |
| 87 | 6.5604 | 8.5403 | 5.6003 | 1.1404 | 1.2004 | 1.1204 | 1.0104 | 8.4103 | 7.4303 | 6.5803 |
| 90 | 1.3005 | 6.1503 | 6.9903 | 8.8403 | 1.0704 | . 1.0304 | 9.9503 | 8.6303 | 7.2103 | 6.1603 |

Table 2-8. Mass absorption coefficients for selected values of atomic number $Z$ at energies between 1 and 10 keV .

| 2 | 1000 | 2000 | 3000 | 4000 | Energy 5000 | $\text { V) } 6000$ | 7000 | 8000 | 9000 | 10000. |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 3 | 2.2802 | 2.5001 | 6.5400 | 2.4900 | 1.18.00 | 6.46-01 | 3.88-01. | 2.49-01 ${ }^{\text {I }}$ | 1.69-01 | 1.19-01 |
| 6 | 2.2703 | 3.0202 | 9.0401 | 3.7701 | 1.8901 | 1.0601 | 6.5300 | 4.2600 | 2.9100 | 2.0600 |
| 9 | 5.7903 | 9.0002 | 2.8802. | 1.2502 | 6.4401 | 3.7201 | 2.3201 | 1.5401 | 1.0701 | 7.7000 |
| 12 | 9.2902 | 2.0303 | 6.7502 | 3.0002 | 1.5802 | 9.2601 | 5.8801 | 3.9601 | 2.7901 | 2.0401 |
| 15 | 2.0203 | 3.0302 | 1.1503 | 5.3102 | 2.86 .02 | 1.7102 | 1.1002 | 7.4901 | 5.3201 | 3.9101 |
| 18 | 3.4203 | 5.3202 | 1.7602 | 7.9502 | 4.4002 | 2.6702 | 1.7402 | 1.2002 | 8.5901 | 6.3701 |
| 21 | 5.3203 | 8.8402 | 3.0002 | 1.3602 | 6.5702 | 4.1202 | 2.7402 | 1.9002 | 1.3702 | 1.0202 |
| 24 | 7.5603 | 1.2603 | 4.1602 | 1.8802 | 1.0202 | 5.1702 | $3.5202{ }^{\text {- }}$ | 2.4902 | 1.8202 | 1.3702 |
| 27 | 9.9103 | 1.7603 | 5.9302 | 2.6902 | 1.4602 | 8.8301 | 5.8001 | 3.2002 | 2.3802 | 1.8102 |
| 30 | 1.5803 | 2.3903 | 8.2802 | 3.8302 | 2.0902 | 1.2702 | 8.3001 | 5.7101 ; | $4.0901^{\prime}$ | 2.3702 |
| 33 | 2.1503 | 3.0203 | 1.0803 | 5.0002 | 2.7302 | 1.6602 | 1.0902 | 7.5201 | 5.4301 | 4.0401 |
| 36 | 2.9703 | 3.5503 | 1.3003 | 6.0502 | 3.3002 | 2.0002 | 1.3102 | 9.0401 | $6.5301{ }^{\text { }}$ | 4.8801 |
| 39 | 3.9503 | 7.4202 | 1.6703 | 8.0002 | 4.4102 | 2.6902 | 1.7702 | 1.2202 | 8.8501 | 6.6101 |
| 42 | 5.0603 | 9.5902 | 2.0003 | 9.7302 | 5.4202 | 3.3302 | 2.1902 | 1.5202 | 1.1002 | 8.2501 |


| 45 | 6.3103 | 1.2203 | 4.3102 | 1.1703 | 6.6102 | 4.0802 | 2.7002 | 1.8802 | 1.3602 | 1.0202 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 48 | 7.5903 | 1.5103 | 5.1002 | 1.0503 | 6.9602 | 4.3302 | 2.8702 | 2.0102 | 1.4602 | 1.0902 |
| 51 | 8.6803 | 1.7503 | 6.4402 | 3.0002 | 8.4202 | 5.2802 | 3.5302 | 2.4702 | 1.8002 | 1.3502 |
| 54 | 9.3803 | 2.1303 | 8.0802 | 3.8902 | 6.6902 | 6.5902 | 4.4302 | 3.1202 | 2.2802 | 1.7202 |
| 57 | 8.8103 | 2.5503 | 9.9302 | 4.8602 | 2.6702 | 6.8102 | 5.2602 | 3.7302 | 2.7402 | 2.0702 |
| 60 | 8.9703 | 2.9203 | 1.0903 | 5.3802 | 3.0702 | 1.9302 | 5.1002 | 4.1702 | 3.1002 | 2.3602 |
| 63 | 2.3303 | 2.7603 | 1.0403 | 5.1102 | 2.9302 | 1.8502 | 3.5902 | 3.3802 | 2.8802 | 2.2002 |
| 66 | 2.6903 | 3.4703 | 1.3803 | 6.7502 | 3.8502 | 2.4302 | 1.6402 | 3.2502 | 3.2302 | 2.8502 |
| 69 | 3.2103 | 4.0603 | 1.7903 | 8.8502 | 5.0802 | 3.2102 | 2.1602 | 1.5302 | 3.0902 | 3.1902 |
| 72 | 3.6603 | 3.8903 | 1.8903 | 9.3502 | 5.4102 | 3.4402 | 2.3302 | 1.6502 | 1.2102 | 2.4702 |
| 75 | 4.2103 | 4.3203 | 2.1103 | 1.0503 | 6.0402 | 3.8102 | 2.5702 | 1.8202 | 1.3502 | 1.0202 |
| 78 | 4.8803 | 1.1603 | 2.1403 | 1.1903 | 6.8402 | 4.3202 | 2.9202 | 2.0702 | 1.5302 | 1.1702 |
| 81 | 5.6403 | 1.3303 | 2.3703 | 1.3103 | 7.6102 | 4.8202 | 3.2502 | 2.3102 | 1.7102 | 1.3002 |
| 84 | 6.2003 | 1.5303 | 2.2803 | 1.3903 | 8.3902 | 5.3402 | 3.6202 | 2.5802 | 1.9102 | 1.4602 |
| 87 | 6.5803 | 1.7303 | 7.0502 | 1.4703 | 9.3702 | 5.9602 | 4.0402 | 2.8802 | 2.1302 | 1.6302 |
| 90 | 6.1603 | 1.9203 | 7.8602 | 1.3803 | 9.8202 | 6.5502 | 4.4502 | 3.1702 | 2.3402 | 1.7902 |

Table 2-9. Values for component $f_{1}$ of the atomic scattering factor, for selected values of atomic number $Z$ at energies beiween 100


| 45 | 1.8501 | 1.4101 | 9.6600 | 4.2800 | 1.8101 | 2.5201 | 3.1701 | 3.4601 | 3.6601 | 3.7701 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 48 | 2.1101 | 1.6401 | 1.4401 | 7.6000 | 1.5501 | 2.2901 | 2.9201 | 3.4701 | 3.8201 | 4.0201 |
| 51 | 2.5301 | 1.8101 | 1.7101 | 1.5001 | 1.3800 | 1.9201 | 2.9101 | 3.0001 | 3.5701 | 3.8701 |
| 54 | 9.4800 | 2.0501 | 1.8601 | 1.8801 | 1.6901 | 1.0401 | 1.5601 | 3.0401 | 3.2501 | 3.4301 |
| 57 | 6.8400 | 2.5301 | 2.2001 | 2.3601 | 2.4501 | 2.4101 | 2.1101 | 1.1601 | 2.2101 | 3.0501 |
| 60 | 1.4401 | 3.0201 | 2.3701 | 2.7401 | 2.9301 | 3.0001 | 2.9601 | 2.8001 | 2.3001 | 1.1201 |
| 63 | 1.4401 | 3.2101 | 3.1101 | 3.3001 | 3.5401 | 3.6501 | 3.6801 | 3.6501 | 3.4901 | 3.1701 |
| 66 | 1.1801 | 2.4701 | 2.6601 | 3.3301 | 3.5501 | 3.6801 | 3.7801 | 3.8001 | 3.7601 | 3.6501 |
| 69 | 1.2501 | 1.9101 | 2.4601 | 2.7801 | 3.2701 | 3.6201 | 3.8301 | 3.9301 | 3.9701 | 3.9501 |
| 72 | 1.0601 | 1.5301 | 2.3201 | 2.7401 | 3.2901 | 3.7201 | 4.0501 | 4.2101 | 4.3201 | 4.3601 |
| 75 | 1.5501 | 1.4601 | 2.2901 | 2.9001 | 3.3501 | 3.8501 | 4.3701 | 4.6201 | 4.8001 | 4.9101 |
| 78 | 1.7701 | 1.2201 | 1.7501 | 2.4301 | 3.1301 | 3.6501 | 4.1601 | 4.5301 | 4.8201 | 4.9901 |
| 81 | 2.1201 | 1.2601 | 1.51 .01 | 2.0201 | 2.99 .01 | 3.5601 | 4.0601 | 4.4401 | 4.8901 | 5.1501 |
| 84 | 2.4701 | 2.0101 | 1.1101 | 1.8001 | 2.7601 | 3.5701 | 4.0301 | 4.5401 | 4.9901 | 5.2401 |
| 87 | 1.6201 | 2.8301 | 1.6801 | 1.2301 | 2.2201 | 2.7501 | 3.8701 | 4.3801 | 4.6401 | 5.1701 |
| 90 |  | 2.6701 | 1.8301 | 1.8301 | 2.0101 | 2.9501 | 3.5601 | 4.3001 | 4.8301 | 5.0301 |

Table 2-10. Values for component $f_{1}$ of the atomic scattering factor, for selected values of atomic number $Z \boldsymbol{Z}$ at energies between I and 10 keV .

| $\boldsymbol{Z}$ | Energy (eV) |  |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | 1000 | 2000 | 3000 | 4000 | 5000 | 6000 | 7000 | 8000 | 9000 | 10000 |
| 3. | 3.0600 | 3.0200 | 3.0100 | 3.0100 | 3.0000 | . 3.0000 | 3.0000 | 3.0000 | 3.0000 | 3.0000 |
| 6 | 6.3400 | 6.1700 | 6.1000 | 6.0600 | 6.0500 | 6.0300 | 6.0300 | 6.0200 | 6.0200 | 6.0100 |
| 9 | 8.7500 | 9.3800 | 9.2800 | 9.2100 | 9.1600 | 9.1200 | 9.1000 | 9.0800 | 9.0700 | 9.0600 |
| 12 | 1.0201 | 1.2101 - | 1.2401 | 1.2401 | 1.2301 | 1.2301 | 1.2201 | 1.2201 | 1.2201 | 1.2101 |
| 15 | 1.4101 | 1.2101 | 1.4901 | 1.5401 | 1.5401 | 1.5401 | 1.5401 | 1.5301 | 1.5301 | 1.5301 |
| 18 | 1.7701 | -1.69 01 | 1.5201 | 1.7501 | 1.8201 | 1.8401 | 1.8401 | 1.8401 | 1.8401 | 1.8401 |
| 21 | 2.0601 | 2.0501 | 1.9901 | 1.8901 | 1.9601 | 2.0801 | 2.1201 | 2.1401 | 2.1401 | 2.1501 |
| 24 | 2.2301 | 2.4001 | 2.3501 | 2.3101 | 2.2401 | 1.8001. | 2.3201 | 2.3901 | 2.4201 | 2.4301 |
| 27 | 2.1001 | 2.7101 | 2.7001 | 2.6601 | 2.6201 | 2.5801 | 2.5001 | 2.4501 | 2.6201 | 2.6801 |
| 30 | 1.0001 | 2.9701 | 3.0201 | 2.9901 | 2.9601 | 2.9301 | 2.9001 | 2.8601 | 2.7801 | 2.7501 |
| 33 | 2.3301 | 3.1101 | 3.3201 | 3.3201 | 3.3001 | 3.2701 | 3.2501 | 3.2201 | . 3.1901 | 3.1501 |
| 36 | 2.8601 | 2.9201 | 3.5801 | 3.6401 | 3.6301 | 3.6101 | 3.5901 | 3.5701 | 3.5501 | 3.5201 |
| 39 | 3.2301 | 2.4801 | $3.7101^{*}$ | 3.9101 | 3.9401 | 3.9301 | 3.9201 | 3.9001 | 3.8801 | 3.8601 |
| 42 | 3.5001 | 3.4201 | 3.6101 | 4.1301 | 4.2301 | 4.2501 | $4.2401^{\circ}$ | 4.2301 | 4.2101 | 4.2001 |


| 45 | 3.7701 | 3.9001 | 2.4401 | 4.2401 | 4.4801 | 4.5401 | 4.5501 | 4.5501 | 4.5401 | 4.5301 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 48 | 4.0201 | 4.3901 | 4.1901 | 4.0401 | 4.6801 | 4.8101 | 4.8501 | 4.8601 | 4.8601 | 4.8501 |
| 51 | 3.8701 | 4.7001 | 4.6001 | 4.0801 | 4.6901 | 5.0201 | 5.1201 | 5.1601 | 5.1701 | 5.1701 |
| 54 | 3.4301 | 4.9301 | 4.9401 | 4.7501 | 4.3101 | 5.0801 | 5.3301 | 5.4201 | 5.4601 | 5.4801 |
| 57 | $3.0501^{\circ}$ | 5.0701 | 5.2601 | 5.1901 | 4.9101 | 4.7901 | 5.4201 | 5.6301 | -5.7201 | 5.76 .01 |
| 60 | 1.1201 | 5.3301 | 5.6201 | 5.5801 | 5.4501 | 5.0301 | 5.2901 | 5.76 .01 | 5.9301 | 6.0201 |
| 63 | 3.1701 | 5.7201 | 6.0401 | 6.0301 | 5.9601 | 5.8201 | 5.1101 | 5.7401 | 6.1201 | 6.2501 |
| 66 | 3.6501 | 5.3901 | 6.2501 | 6.3201 | 6.2801 | 6.1801 | 5.9901 | 5.7101 | 5.9601 | 6.3901 |
| 69 | 3.9501 | 5.0801. | 6.3901 | 6.5901 | 6.5901 | 6.5201 | 6.4001 | 6.1701 | 6.0201 | 6.2501 |
| 72 | 4.3601 | 4.6401 | 6.5801 | 6.9001 | 6.9401 | 6.9101 | 6.8401 | 6.7201 | 6.4801 | 6.430 |
| 75 | 4.9101 | 3.2801 | 6.5601 | 7.1701 | 7.28 .01 | 7.2801 | 7.2301 | 7.1501 | 7.0301 | 6.7901 |
| 78 | 4.9901 | 4.1401 | 6.4101 | 7.3701 | 7.5801 | 7.6101 | 7.5901 | 7.5301 | 7.4601 | 7.340 |
| 81 | 5.1501 | 5.3401 | 6.1101 | 7.4501 | 7.8301 | 7.9201 | 7.9301 | 7.8901 | 7.8401 | 7.7601 |
| 84 | 5.2401 | 6.0101 | 5.9101 | 7.4401 | 8.0301 | 8.2001 | 8.2401 | 8.2301 | 8.2001 | 8.1401 |
| 87 | 5.1701 | 6.4001 | 1.3101 | 7.3901 | 8.1401 | 8.4401 | 8.5301 | 8.5501 | 8.5301 | 8.5001 |
| 90 | 5.0301 | 6.7701 | 6.2901 | 6.9301 | 8.1301 | 8.6301 | 8.8001 | 8.8601 | 8.8701 | 8.8501 |

Table 2-11. Values for component $f_{2}$ of the atomic scattering factor, for selected values of atomic number $Z$ at energies between 100 and 1000 eV .

|  |  |  | Energy (eV) |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\boldsymbol{Z}$ | $\mathbf{1 0 0}$ | $\mathbf{2 0 0}$ | $\mathbf{3 0 0}$ | $\mathbf{4 0 0}$ | $\mathbf{5 0 0}$ | $\mathbf{6 0 0}$ | $\mathbf{7 0 0}$ | $\mathbf{8 0 0}$ | $\mathbf{9 0 0}$ | $\mathbf{1 0 0 0}$ |  |
| 3 | 2.3400 | $8.18-01$ | $3.99-01$ | $2.42-01$ | $1.51-01$ | $1.07-01$ | $7.58-02$ | $5.89-02$ | $4.58-02$ | $3.74-02$ |  |
| 6 | $6.66-01$ | $2.95-01$ | 4.1800 | 2.8200 | 1.9700 | 1.5200 | 1.1600 | $9.40-01$ | $7.61-01$ | $6.42-01$ |  |
| 9 | 3.9500 | 1.7100 | $9.62-01$ | $6.46-01$ | $4.48-01$ | $3.44-01$ | 4.0900 | 3.5700 | 2.9800 | 2.5900 |  |
| 12 | 7.5400 | 5.6900 | 3.5000 | 2.4500 | 1.6800 | 1.2700 | $9.58-01$ | $7.77-01$ | $6.29-01$ | $5.33-01$ |  |
| 15 | $7.51-01$ | 1.0201 | 7.7000 | 5.8800 | 4.3000 | 3.3700 | 2.5900 | 2.1300 | 1.7300 | 1.4800 |  |
| 18 | 1.8200 | 1.5400 | 1.1701 | 1.0901 | 8.4400 | 6.8400 | 5.4400 | 4.5500 | 3.7500 | 3.2200 |  |
| 21 | 2.8800 | 2.67 .00 | 2.0600 | 1.6600 | 1.3601 | 1.1301 | 9.1600 | 7.7500 | 6.5000 | 5.6400 |  |
| 24 | 5.6600 | 4.4600 | 3.3700 | 2.7100 | 2.1300 | 1.7600 | 1.4501 | 1.2401 | 1.0601 | 9.2700 |  |
| 27 | 8.5900 | 7.5500 | 5.6000 | 4.3700 | 3.3900 | 2.8200 | 2.3300 | 1.6301 | 1.4001 | 1.3801 |  |
| 30 | 1.2201 | 1.2201 | 9.4100 | 7.3500 | 5.6300 | 4.5800 | 3.7400 | 3.2400 | 2.7400 | 2.4400 |  |
| 33 | 7.9200 | 1.4901 | 1.3001 | 1.0801 | 8.5800 | 7.1300 | 5.8600 | 5.0500 | 4.3200 | 3.8000 |  |
| 36 | 1.8300 | 1.5901 | 1.7801 | 1.6101 | 1.2901 | 1.0901 | 8.9800 | 7.7500 | 6.6500 | 5.8700 |  |
| 39 | 2.7500 | 9.1200 | 1.8701 | 2.0901 | 1.7401 | 1.4801 | 1.2401 | 1.0801 | 9.3500 | 8.2800 |  |
| 42 | 2.0100 | 2.4500 | 1.4201 | 1.8001 | 1.9401 | 1.8301 | 1.6301 | 1.4801 | 1.2901 | 1.1501 |  |


| 45 | 1.3200 | 3.2700 | 3.1600 | 1.8701 | 2.4901 | 2.4601 | 2.2301 | 1.9601 | 1.7101 | 1.5301 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 48 | 1.1601 | 3.5700 | 4.3000 | $\cdot 4.3500$ | 2.9301 | 2.6501 | 2.6901 | 2.5601 | 2.2401 | 2.0101 |
| 51 | 2.1801 | 4.1200 | 5.3900 | 5.6900 | 5.2700 | 3.4201 | 2.7401 | 2.5701 | 2.6401 | 2.4901 |
| 54 | 3.8501 | 2.9000 | 6.3800 | 7.0300 | 6.9600 | 6.4800 | 4.9501 | 3.1201 | 2.6901 | 2.9101 |
| 57 | 9.5300 | 2.3500 | 6.6900 | 8.2300 | 8.1800 | 7.7800 | 7.1900 | 6.6700 | 3.2401 | 2.8901 |
| 60 | 4.9200 | 6.8600 | 8.2800 | 1.0801 | 1.0301 | 9.7100 | -8.9000 | 8.2000 | 7.4900 | 3.0501 |
| 63 | 6.2700 | 1.6701 | 1.24 .01 | 1.3601 | 1.2701 | 1.1801 | 1.0801 | 9.9400 | 9.0600 | 8.3700 |
| 66 | 1.2601 | 1.9901 | 1.9501 | 1.7901 | 1.6301 | 1.5001 | 1.3501 | 1.2401 | 1.1201 | 1.0301 |
| 69 | 1.1601 | 1.8101 | 1.8901 | 1.9801 | 2.0301 | 1.8801 | 1.6901 | 1.5401 | 1.3901 | 1.2801 |
| 72 | 8.9300 | 1.8101 | 2.1301 | 2.1501 | 2.2801 | 2.2501 | 2.0301 | 1.8501 | 1.6801 | 1.5401 |
| 75 | 7.1600 | 1.6601 | 2.3301 | 2.4501 | 2.5701 | 2.5601 | 2.4101 | 2.2101 | 2.0101 | 1.8501 |
| 78 | 8.9300 | 1.4901 | 2.2201 | 2.7801 | 2.7701 | 2.9301 | 2.7501 | 2.6801 | 2.4401 | 2.2501. |
| 81 | 1.1201 | 9.4000 | 2.2101 | 2.8701 | 3.0901 | 3.0301 | 3.1901 | 3.0201 | 2.9001 | 2.7201 |
| 84 | 2.48 .01 | 6.1100 | 1.8101 | 2.7801 | 3.5301 | 3.4401 | 3.2601 | 3.4201 | 3.1701 | 3.0701 |
| 87 | 3.4801 | 9.1000 | 9.0000 | 2.3901 | 3.2001 | 3.5401 | 3.7701 | 3.5601 | 3.5501 | 3.4601 |
| 90 | 7.1901 | 6.8200 | 1.1701 | 1.9301 | 2.9801 | 3.3801 | 3.8801 | 3.8001 | 3.5901 | 3.3701 |

Table 2-12. Values for component $f_{2}$ of the atomic scattering factor. for selected values of atomic number $Z$ at energies between 1 and 10 keV .

|  |  |  |  | Energy (eV) |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\boldsymbol{Z}$ | $\mathbf{1 0 0 0}$ | $\mathbf{2 0 0 0}$ | $\mathbf{3 0 0 0}$ | $\mathbf{4 0 0 0}$ | $\mathbf{5 0 0 0}$ | $\mathbf{6 0 0 0}$ | $\mathbf{7 0 0 0}$ | $\mathbf{8 0 0 0}$ | $\mathbf{9 0 0 0}$ | $\mathbf{1 0 0 0 0}$ |  |  |
| $\mathbf{3}$ | $3.74-02$ | $8.25-03$ | $3.24-03$ | $1.64-03$ | $9.77-04$ | $6.40-04$ | $4.48-04$ | $3.29-04$ | $2.51-04$ | $1.96-04$ |  |  |
| 6 | $6.42-01$ | $1.73-01$ | $7.74-02$ | $4.30-02$ | $2.69-02$ | $1.82-02$ | $1.31-02$ | $9.72-03$ | $7.47-03$ | $5.89-03$ |  |  |
| 9 | 2.5900 | $8.13-01$ | $3.90-01$ | $2.26-01$ | $1.45-01$ | $1.01-01$ | $7.34-02$ | $5.57-02$ | $4.35-02$ | $3.48-02$ |  |  |
| 12 | $5.33-01$ | 2.3400 | 1.1700 | $6.92-01$ | $4.55-01$ | $3.21-01$ | $2.38-01$ | $1.83-01$ | $1.45-01$ | $1.18-01$ |  |  |
| 15 | 1.4800 | $4.46-01$ | 2.5400 | 1.5600 | 1.0500 | $7.55-01$ | $5.67-01$ | $4.41-01$ | $3.53-01$ | $2.88-01$ |  |  |
| 18 | 3.2200 | 1.0100 | $5.01-01$ | 3.0200 | 2.0900 | 1.5200 | 1.1600 | $9.11-01$ | $7.35-01$ | $6.05-01$ |  |  |
| 21 | 5.6400 | 1.8900 | $9.61-01$ | $5.80-01$ | 3.5100 | 2.6400 | 2.0500 | 1.6300 | 1.3200 | 1.0900 |  |  |
| 24 | 9.2700 | 3.1100 | 1.5400 | $9.32-01$ | $6.33-01$ | 3.8300 | 3.0500 | 2.4600 | 2.0200 | 1.69 .00 |  |  |
| 27 | 1.3801 | 4.9300 | 2.4900 | 1.5100 | 1.0200 | $7.42-01$ | $5.69-01$ | 3.5900 | 3.0000 | 2.5400 |  |  |
| 30 | 2.4400 | 7.4400 | 3.8600 | 2.3800 | 1.6300 | 1.1900 | $9.03-01$ | $7.11-01$ | $5.73-01$ | 3.6900 |  |  |
| 33 | 3.8000 | 1.0801 | 5.7600 | 3.5600 | 2.4300 | 1.77 .00 | 1.3600 | 1.0700 | $8.70-01$ | $7.20-01$ |  |  |
| 36 | 5.8700 | 1.4101 | 7.7500 | 4.8200 | 3.2900 | 2.3900 | 1.8200 | 1.4400 | 1.1700 | $9.73-01$ |  |  |
| 39 | 8.2800 | 3.1400 | 1.0601 | 6.7600 | 4.6700 | 3.4200 | 2.6200 | 2.0700 | 1.6800 | 1.4000 |  |  |
| 42 | 1.1501 | 4.3800 | 1.3701 | 8.8800 | 6.1900 | 4.5600 | 3.5000 | 2.7800 | 2.2600 | 1.8800 |  |  |


| 45 | 1.5301 | 5.9900 | 3.1700 | 1.1501 | 8.0800 | 5.9900 | 4.6200 | 3.6800 | 3.0000 | 2.5000 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| 48 | 2.0101 | 8.0900 | 4.0900 | 1.1201 | 9.3100 | 6.9400 | 5.3700 | 4.2900 | 3.5100 | 2.9200 |
| 51 | 2.4901 | 1.0101 | 5.5900 | 3.4800 | 1.2201 | 9.1700 | 7.1400 | 5.7200 | 4.6900 | 3.9200 |
| 54 | 2.9101 | 1.3301 | 7.5700 | 4.8600 | 1.0401 | 1.2301 | 9.6900 | 7.8000 | 6.4100 | 5.3700 |
| 57 | 2.8901 | 1.6801 | 9.8400 | 6.4200 | 4.4200 | 1.3501 | 1.2201 | 9.8600 | 8.1500 | 6.8500 |
| 60 | 3.0501 | 2.0001 | 1.1301 | 7.3800 | 5.2700 | 3.9800 | 1.2201 | 1.1501 | 9.5600 | 8.0900 |
| 63 | 8.3700 | 1.9901 | 1.1301 | 7.3900 | 5.2900 | 4.0000 | 9.0700 | 9.7700 | 9.3600 | 7.9500 |
| 66 | 1.0301 | 2.6801 | 1.6001 | 1.0401 | 7.4400 | 5.6300 | 4.4500 | 1.0001 | 1.1201 | 1.1001 |
| 69 | 1.2801 | 3.2601 | 2.1501 | 1.4201 | 1.0201 | 7.7300 | 6.0800 | 4.9200 | 1.1201 | 1.2801 |
| 72 | 1.5401 | 3.3001 | 2.4001 | 1.5901 | 1.1501 | 8.7600 | 6.9300 | 5.6100 | 4.6200 | 1.0501 |
| 75 | 1.8501 | 3.8201 | 2.8001 | 1.8701 | 1.3401 | 1.0101 | 7.9700 | 6.4600 | 5.3700 | 4.5400 |
| 78 | 2.2501 | 1.0801 | 2.9801 | 2.2101 | 1.5901 | 1.2001 | 9.4700 | 7.6900 | 6.3900 | 5.4100 |
| 81 | 2.7201 | 1.3001 | 3.4601 | 2.5401 | 1.8501 | 1.4001 | 1.1 .101 | 8.9700 | 7.4600 | 6.3200 |
| 84 | 3.0701 | 1.5301 | 3.4201 | 2.7701 | 2.1001 | 1.6001 | 1.260 .1 | 1.0301 | 8.5700 | 7.2700 |
| 87 | 3.4601 | 1.8301 | 1.1201 | 3.1101 | 2.4801 | 1.9001 | 1.5001 | 1.2201 | 1.0201 | 8.6300 |
| 90 | 3.3701 | 2.1201 | 1.3001 | 3.0501 | 2.7101 | 2.1701 | 1.7201 | 1.4001 | 1.1601 | 9.8700 |

# 2.8 TRANSMISSION BANDS OF.SELECTED FILTERS 

Burton L. Henke

Figures 2-7 and 2-8 show transmission bands for selected practical filter materials between 50 eV and 10 keV . The filter materials and absorption edges are given in Table 2-13, along with the mass thickness $m$ required to give about a $60 \%$ maximum transmission. This value of $m$ is equal to $1 /(2 \mu)$, where $\mu$ is the mass absorption coefficient in $\mathrm{cm}^{2} / \mu \mathrm{g}$. These figures illustrate only the principal transmission band for each filter. A typical transmission curve for a wider spectral region is shown in Fig. 2-9, and detailed transmission curves for all the filter materials considered here can be found in B. L. Henke and P. A. Jaanimagi, "A Two-Channel, Elliptical Analyzer Spectrograph for Absolute, Time-Resolving/Time-Integrating Spectrometry of Pulsed X-Ray Sources in the $100-10,000 \mathrm{eV}$ Region," Rev. Sci. Instrum. 56, 1537 (1985).

Table 2-13. Absorption edges and mass thicknesses for the filters with transmission characteristics illustrated in Figs. 2-7 and 2-8.

| No. | Filter | Edge (eV) | $\begin{gathered} 1 / 2 \mu \\ \left(\mu \mathrm{~g} / \mathrm{cm}^{2}\right) \end{gathered}$ |
| :---: | :---: | :---: | :---: |
| 1 | Beryllium (Be) | Be-K (111) | 81 |
| 2 | Boron nitride (BN) | B-K (188) - | 68 |
| 3 | Carbon (C) | C-K (284) | 226 |
|  | Polypropylene $\left(\mathrm{CH}_{2}-\mathrm{CHCH}_{3}\right)_{x}$ | C-K (284) | 256 |
|  | Formvar ( $\mathrm{C}_{5} \mathrm{H}_{7} \mathrm{O}_{2}$ ) | C-K (284) | 156 |
|  | Mylar ( $\mathrm{C}_{10} \mathrm{H}_{8} \mathrm{O}_{4}$ ) | C-K (284) | 152 |
|  | Kimfol ( $\mathrm{C}_{16} \mathrm{H}_{14} \mathrm{O}_{3}$ ) | C-K (284) | 181 |
| 4 | Boron nitride (BN) | N-K (400) | 66 |
| 5 | Aluminum oxide ( $\mathrm{Al}_{2} \mathrm{O}_{3}$ ) | O-K (532) | 126 |
|  | Silicon dioxide ( $\mathrm{SiO}_{2}$ ) | O-K (532) | 116 |
|  | Polyformaldehyde ( $\mathrm{CH}_{2} \mathrm{O}$ ) ${ }_{x}$ | O-K (532) | 92 |
| 6 | Iron (Fe) | Fe-L ${ }_{3}$ (707) | 234 |
| 7 | Nickel ( Ni ) ${ }^{\text {. }}$ | $\mathrm{Ni}-\mathrm{L}_{3}{ }^{\text {(854) }}$ | 279 |
| 8 | Copper (Cu) | $\mathrm{Cu}-\mathrm{L}_{3}$ (933) | 318 |
| 9 | Magnesium (Mg) | Mg-K (1303) | 1139 |
| 10 | Aluminum (Al) | Al-K (1560) | 1427 |
| 11 | Silicon (Si) | Si-K (1840) | 1680 |
| 12 | Saran ( $\left.\mathrm{CH}_{2}=\mathrm{CCl}_{2}\right)_{x}$ | Cl-K (2820) | 3151 |
| 13 | Silver ( Ag ) | Ag-L ${ }_{3}$ (3351) | 1296 |
| 14 | Tin (Sn) | $\mathrm{Sn}^{\mathrm{L}} 3 \mathrm{l}$ (3929) | 1669 |
| 15 | Titanium ( T ) | Ti-K (4964) | 6010 |
| 16 | Chromium ( Cr ) | Cr-K (5989) | 7924 |
| 17 | Iron (Fe) | Fe-K (7111) | 9804 |
| 18 | Nickel (Ni) | Ni-K (8331) | 11820 |
| 19 | Copper (Cu) | Cu-K (8980) | 13699 |



Fig. 2-7. Transmission bands of selected filters (see table) between 50 eV and 1 keV .
I


Fig. 2-8. Transmission bands of selected fllers (see table) between 500 eV and 10 keV .


## SECTION 3

 SCATTERING PROCESSES
### 3.1 SCATTERING OF X-RAYS FROM ELECTRONS AND ATOMS

Janos Kirz

## A. COHERENT, RAYLEIGH, OR ELASTIC SCATTERING

Scattering from single electrons (Thomson scattering) has a total cross section

$$
\begin{equation*}
\sigma_{T}=8 \pi r_{e}^{2} / 3=6.652 \times 10^{-29} \mathrm{~m}^{2} \tag{1}
\end{equation*}
$$

where $r_{e}$ is the classical radius of the electron, $e^{2} / m c^{2}=$ $2.818 \times 10^{-15}$ meter. The angular distribution for unpolarized incident radiation is proportional to $\left(1+\cos ^{2} \theta\right)$, where $\theta$ is the scattering angle. For polarized incident radiation, the cross section vanishes at $90^{\circ}$ in the plane of polarization.

Scattering from atoms involves the cooperative effect of all the electrons, and the cross section becomes

$$
\begin{equation*}
\sigma_{R}=\pi r_{e}^{2} \int_{-1}^{1}|f(\theta)|^{2}\left(1+\cos ^{2} \theta\right) \dot{d}(\cos \theta) \tag{2}
\end{equation*}
$$

where $f(\theta)$ is the (complex) atomic scattering factor, tabulated in Section 2.7 of this booklet. Up to about 2 keV , the scattering factor is approximately independent of scattering angle, with a real part that represents the effective number of electrons that participate in the scattering. At higher energies, the scattering factor falls off rapidly with scattering angle. For details see Ref. 1.

## B. COMPTON SCATTERING

In relativistic quantum mechanics, the scattering of $x$-rays by a free electron is given by the Klein-Nishina formula. If we assume unpolarized x-rays and unaligned electrons, this formula can be approximated as follows for $x$-ray energies below .100 keV :

$$
\begin{equation*}
d \sigma_{\mathrm{KN}} / d \Omega \cong \frac{r_{e}^{2}\left(1+\cos ^{2} \theta\right)}{2[1+k(1-\cos \theta)]^{2}} \tag{3}
\end{equation*}
$$

where $k=E / m c^{2}$, the photon energy measured in units of the electron rest energy. The total cross section is approximately

$$
\begin{equation*}
\sigma_{\mathrm{KN}} \cong 8 \pi r_{e}^{2} \frac{\left(1+2 k+1.2 k^{2}\right)}{3(1+2 k)^{2}} \tag{4}
\end{equation*}
$$

Note that for very low energies ( $k \rightarrow 0$ ), we recover the Thomson cross section. The real difference comes when we deal with atoms. In that case, if the scattering leaves the atom in the ground state, we deal with coherent scattering (see above), whereas if the electron is ejected from the atom, the scattering is (incoherent) Compton scattering. At high energies, the total Compton cross section approaches $Z \sigma_{\mathrm{KN}}$. At low energies and small scattering angles, however, binding effects are very. important, the Compton cross section is significantly reduced, and coherent scattering dominates (see Figs. 3-1 and 3-2). For details see Refs. 1 and 2.

The scattered $x$-ray suffers an energy loss, which (ignoring binding effects) is given by

$$
\begin{equation*}
E^{\prime} / E=1 /[1+k(1-\cos \theta)] \tag{5}
\end{equation*}
$$

or, in terms of the wavelength shifi,

$$
\begin{equation*}
\lambda^{\prime}-\lambda=\lambda_{c}(1-\cos \theta) \tag{6}
\end{equation*}
$$

where $\lambda_{c}=h / m c=2.426 \times 10^{-12}$ meter. The kinetic energy of the recoil electron is just the energy lost by the phoion in this approximation:

$$
\begin{equation*}
E_{e}=E \frac{k(1-\cos \theta)}{1+k(1-\cos \theta)} \tag{7}
\end{equation*}
$$



Fig. 3-1. Total photon cross section $\sigma_{\text {tot }}$ in carbon. as a function of energy, showing the contributions of different processes: $\tau$. atomic photo-effect (electron ejection. photon absorption): $\sigma_{\text {coh }}$ coherent scattering (Rayleigh scattering-atom neither ionized nor excited): $\sigma_{\text {incotr }}$ incoherent scattering (Compton scattering off an electron): $\kappa_{n}$, pair production, nuclear field: $\kappa_{e}$. pair production. electron field: $\sigma_{\text {ph }}$ photonuclear absorption (nuclear absorption. usually followed by emission of a neutron or other particie). (From Ref. 3; figure courtesy of J. H. Hubbell.)

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Fig. 3.2. Total photon cross section $\sigma_{\text {tot }}$ in lead, as a function of energy. See Fig. 3-1. (From Ref. 3: figure courtesy of . J. H. Hubbell.)
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### 3.2 LOW-ENERGY ELECTRON RANGES IN MATTER

Piero Pianetta

The electron range is a measure of the straight-line penetration distance of electrons in a solid [1]. Electrons with energies in the kilo-electron volt range, traveling in a solid, are scattered inelastically in collisions with the electrons in the material. For low- $Z$ materials, such as organic insulators, scattering from the valence electrons is the major loss mechanism for incident electron energies from 10 eV to 10 keV . The core levels contribute less than $10 \%$ to the electron's energy dissipation for energies between 1 keV and 10 keV [2].

For electron energies below 5 keV , the usual Bethe-Bloch formalism is inadequate for calculating the electron energy loss in a solid, and an approach using the dielectric response of the material is used [3]. The complex dielectric function $\varepsilon(k, \omega)$ describes the response of a medium to a given energy transfer $\hbar \omega$ and momentum transfer $\hbar k$. The dielectric function contains contributions from both valence and core electrons. References 4 and 5 describe the steps for calculating $\epsilon(k, \omega)$ for insulators and metals, respectively. For an electron of energy $E$, the probability of an energy loss $\omega$ per unit distance is given by [2]

$$
\begin{equation*}
\tau(E, \hbar \omega)=\frac{1}{\pi a_{0} E} \int_{k_{-}}^{*_{+}} \frac{d k}{k} \operatorname{Im}\left[\frac{-1}{\epsilon(k, \omega)}\right] \tag{1}
\end{equation*}
$$

where $\hbar k_{ \pm}=\sqrt{2 m}(\sqrt{E} \pm \sqrt{E-\hbar \omega})$ and $a_{0}=\hbar^{2} / m e^{2}$. The quantity $\tau(E, \hbar \omega)$ is also known as the differential inverse mean free path, because by integrating it over all allowed energy transfers, the inelastic mean free path is obtained. Furthermore, an integration of $h \omega \tau(E, \hbar \omega)$ over all allowed energy transfers gives the energy loss per unit path length, or stopping power $S(E)$. The stopping power can then be used to calculate the distance it takes to slow an electron down to a given energy. This distance is called the continuous slowing down approximation range, or CSDA range, because the calculation assumes that the electron slows down continuously from the initial energy $E$ to the final energy, which is usually taken
to be $10 \mathrm{eV}[2]$. The CSDA range $R_{0}(E)$ is given by

$$
\begin{equation*}
R_{0}(E)=\int_{10 \mathrm{~V}}^{E} \frac{d E^{\prime}}{S\left(E^{\prime}\right)} \tag{2}
\end{equation*}
$$

The calculations for inelastic mean free path and stopping power have been carried out down to 10 eV for a number of materials, including $\mathrm{SiO}_{2}$ [3]; polystyrene [2]; polyethylene [6]; collodion [7]; and silicon, aluminum, nickel, copper, and gold [5]. The CSDA ranges from 15 eV to 6 keV were then calculated for polystyrene, silicon, and gold by integrating Eq. (2) and are shown in Fig. 3-3. These curves can be used with confidence down to 100 eV . However, comparisons of different available calculations with the meager experimental data below 100 eV indicate that errors as large as $100 \%$ may occur


Fig, 3-3. Plot of the CSDA range, as a function of energy. for gold and silicon [5] and for polystyrene, $\left(\mathrm{C}_{8} \mathrm{H}_{8}\right)_{n}$, with a density of $1.05 \mathrm{~g} / \mathrm{cm}^{3}[2]$. The measured electron range in collodion with a density of $1 \mathrm{~g} / \mathrm{cm}^{3}$ is also plotted [7].
at 10 eV . An example of this is shown in the figure, where experimental range data for collodion are given. It is clear that the agreement between the collodion and polystyrene data starts to become reasonable above 100 eV . The differences below 100 eV could equally well be due to problems with the theory or to the increased difficulty of the measurement. Stopping-power calculations for PMMA have been carried out only from 100 eV , so that the CSDA range as defined above could not be calculated [4]. However, data on effective electron ranges of photoelectrons in PMMA at several energies can be found in Ref. 8.

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## SECTION 4

## X-RAY SOURCES

### 4.1 CHARACTERISTICS OF SYNCHROTRON RADIATION

Kwang-Je Kim

Synchrotron radiation occurs when a charge moving at relativistic speeds follows a curved trajectory. In this section, formulas and supporting graphs are used to quantitatively describe characteristics of this radiation for the cases of circular motion (bending magnets) and sinusoidal motion (periodic magnetic structures).

We will first discuss the ideal case, where the effects due to the angular divergence and the finite size of the electron beam-the emittance effects-can be neglected.

## A. BENDING MAGNETS

The angular distribution of radiation emitted by electrons moving through a bending magnet with a circular trajectory in the horizontal plane is given by

$$
\begin{align*}
& \frac{d^{2} \mathscr{G}_{B}(\omega)}{d \theta d \psi}=\frac{3 \alpha}{4 \pi^{2}} \gamma^{2} \\
& \frac{\Delta \omega}{\omega} \frac{I}{e} y^{2}\left(1+X^{2}\right)^{2}  \tag{1}\\
& \times\left[K_{2 / 3}^{2}(\xi)+\frac{X^{2}}{1+X^{2}} K_{1 / 3}^{2}(\xi)\right]
\end{align*}
$$

where

$$
\begin{aligned}
\mathscr{I}_{B}= & \text { photon flux (number of photons per second) } \\
\theta= & \text { observation angle in the horizontal plane } \\
\psi= & \text { observation angle in the vertical plane } \\
\alpha= & \text { fine-structure constant } \\
\gamma= & \text { electron energy } / m_{e} c^{2}\left(m_{e}=\right.\text { electron mass, } \\
& c=\text { velocity of light) } \\
\omega= & \text { angular frequency of photon }(\epsilon=\hbar \omega=\text { energy } \\
& =\text { of photon) } \\
I= & \text { beam current } \\
e= & \text { electron charge }=1.602 \times 10^{-19} \text { coulomb } \\
y= & \omega / \omega_{c}=\epsilon / \epsilon_{c} \\
\omega_{C}= & \text { critical frequency, defined as the } \\
& \text { frequency that divides the emitted power } \\
& \text { into equal halves, }=3 \gamma^{3} c / 2 \rho \\
\rho= & \text { radius of instantaneous curvature of the } \\
& \text { electron trajectory }[\text { in practical units, } \\
& \rho(\mathrm{m})=3.3 E(\text { GeV }) / B(\mathrm{~T})] \\
E= & \text { electron beam energy } \\
B= & \text { magnetic field strength } \\
\epsilon_{c}= & h \omega_{c}[\text { in practical units, } \\
& \left.\epsilon_{c}(\text { keV })=0.665 E^{2}(\mathrm{GeV}) B(\mathrm{~T})\right] \\
X= & \gamma \psi \\
\xi= & \mathcal{Y}\left(1+X^{2}\right)^{3 / 2} / 2
\end{aligned}
$$

The subscripted $K \mathrm{~s}$ are modified Bessel functions of the second kind. In the horizontal direction ( $\psi=0$ ), Eq. (1) becomes

$$
\begin{equation*}
\left.\frac{d^{2} \mathscr{S}_{B}}{d \theta d \psi}\right|_{\psi=0}=\frac{3 \alpha}{4 \pi^{2}} \gamma^{2} \cdot \frac{\Delta \omega}{\omega} \frac{I}{e} H_{2}(\gamma) \tag{2}
\end{equation*}
$$

where

$$
\begin{equation*}
H_{2}(y)=y^{2} K_{2 / 3}^{2}(y / 2) \tag{3}
\end{equation*}
$$

In practical units [photons $\cdot \mathrm{s}^{-1} \cdot \mathrm{mr}^{-2} \cdot(0.1 \% \text { bandwidth })^{-1}$ ],

$$
\left.\left.\left.\frac{d^{2} \mathscr{S}_{B}}{d \theta d \psi}\right|_{\psi=0}=1.327 \times 10^{13} E^{2}[G e V] I \right\rvert\, A\right] H_{2}(y)
$$

The function $\mathrm{H}_{2}(y)$ is shown in Fig 4-1.
The distribution integrated over $\psi$ is given by


Fig. 4-1. The functions $G_{1}\left(y^{\prime}\right)$ and $H_{2}(y)$, where $y$ is the ratio of photon energy to critical photon energy.

$$
\begin{equation*}
\frac{d \mathcal{F}_{B}}{d \theta}=\frac{\sqrt{3}}{2 \pi} \alpha \gamma \frac{\Delta \omega}{\omega} \frac{I}{e} G_{1}(y), \tag{4}
\end{equation*}
$$

where

$$
\begin{equation*}
G_{1}(y)=y \quad \int_{y}^{\infty} K_{5 / 3}\left(y^{\prime}\right) d y^{\prime} \tag{5}
\end{equation*}
$$

In practical units [photons $\cdot \mathrm{s}^{-1} \cdot \mathrm{mr}^{-1} \cdot(0.1 \% \text { bandwidth })^{-1}$ ],

$$
\frac{d \mathscr{F}_{B}}{d \theta}=2.457 \times 10^{13} E[\mathrm{GeV}] I[\mathrm{~A}] G_{1}(y)
$$

The function $G_{1}(y)$ is also plotted in Fig 4-1.
Radiation from a bending magnet is linearly polarized when observed in the bending plane. Out of this plane, the polarization is elliptical and can be decomposed into its horizontal and vertical components. The first and second terms
in the last bracket of Eq. (1) correspond, respectively, to the intensity of the horizontally and vertically polarized radiation. Figure 4 -2 gives the normalized intensities of these two components, as functions of emission angle, for different energies. The square root of the ratio of these intensities is the ratio of the major and minor axes of the polarization ellipse. The sense of the electric field rotation reverses as the vertical observation angle changes from positive to negative.

Synchrotron radiation occurs in a narrow cone of nominal angular width $\sim 1 / \gamma$. To provide a more specific measure of this angular width, in terms of electron and photon energies, it is convenient to introduce the effective rms half-angle $\sigma_{\psi}$ as follows:

$$
\begin{equation*}
\frac{d \mathscr{F}_{B}}{d \theta} /\left.\frac{d^{2} \mathscr{F}_{B}}{d \theta d \psi}\right|_{\psi=0}=\sqrt{2 \pi} \sigma_{\psi}, \tag{6}
\end{equation*}
$$

where $\sigma_{\psi}$ is given by

$$
\begin{equation*}
\sigma_{\psi}=\frac{2}{\gamma \sqrt{2 \pi}} C(y)=0.408 \frac{C(y)[\mathrm{mr}]}{E[\mathrm{GeV}]} \tag{7}
\end{equation*}
$$

The function $C(y)$ is plotted in Fig 4-3. In terms of $\sigma_{\psi}$ Eq. (2) may now be rewritten as


Fig. 42. Normalized intensities of horizontal and vertical polarization' components, as functions of the vertical observation angle $\psi$. for different photon energies. (Adapted from Ref. I.)


Fig. 43. The function $C(y)$. The limiting slopes, for $\epsilon / \epsilon_{c} \ll I$ and $\epsilon / \epsilon_{c} \gg 1$, are indicated.

$$
\begin{equation*}
\left.\frac{d^{2} \mathscr{S}_{B}}{d \theta d \psi}\right|_{\psi=0}=\frac{d \mathscr{F}_{B}}{d \theta} \frac{1}{\sigma_{\psi} \sqrt{2 \pi}} \tag{2a}
\end{equation*}
$$

## B. PERIODIC MAGNETIC STRUCTURES

In a wiggler or an undulator, electrons travel through a periodic magnetic structure. We consider the case where the magnetic field $B$ varies sinusoidally and is in the vertical direction:

$$
\begin{equation*}
B(z)=B_{0} \cos \left(2 \pi z / \lambda_{u}\right), \tag{8}
\end{equation*}
$$

where $z$ is the distance along the wiggler axis, $B_{0}$ the peak magnetic field, and $\lambda_{u}$ the magnet period. Electron motion is also sinusoidal and lies in the horizontal plane. An important parameter characterizing the electron motion is the deflection parameter $K$ given by

$$
\begin{equation*}
K=e B_{0} \lambda_{u}^{\prime} / 2 \pi m c=0.934 \lambda_{u}[\mathrm{~cm}] B_{0}[\mathrm{~T}] \tag{9}
\end{equation*}
$$

In terms of $K$, the maximum angular deflection of the orbit is
$\delta=K / \gamma$. For $K \leqslant 1$, radiation from the various periods can exhibit strong interference phenomena, because the angular excursions of the electrons are within the nominal $1 / \gamma$ radiation cone; in this case, the structure is referred to as an undulator. In the case $\mathrm{K} \gg 1$, interference effects are less important, and the structure is referred to as a wiggler. $\qquad$

## B. 1 Wiggler radiation

In a wiggler, $K$ is large (typically $z 10$ ) and radiation from different parts of the electron trajectory adds incoherently. The flux distribution is then given by $2 N$ (where $N$ is the number. of magnet periods) times the appropriate formula for bending magnets, either Eq. (1) or Eq. (2). However, $\rho$ or $B$ must be taken at the point of the electron's trajectory tangent to the direction of observation. Thus, for a horizontal angle $\theta$,

$$
\begin{equation*}
\epsilon_{c}(\theta)=\epsilon_{c} \max \sqrt{1-(\theta / \delta)^{2}} \tag{10}
\end{equation*}
$$

where

$$
\epsilon_{c \max }=0.665 E^{2}[\mathrm{GeV}] B_{0}[\mathrm{~T}]
$$

When $\psi=0$, the radiation is linearly polarized in the horizontal plane, as in the case of the bending magnet. As $\psi$ increases, the direction of the polarization changes, but because the elliptical polarization from one half-period of the motion combines with the elliptical polarization (of opposite sense of rotation) from the next, the polarization remains linear.

## B. 2 Undulator radiation.

In an undulator, $K$ is moderate ( $\leqslant 1$ ) and radiation from different periods interferes coherently, thus producing sharp peaks at harmonics of the fundamental ( $n=1$ ). The wavelength of the fundamental on axis $(\theta=\psi=0)$ is given by

$$
\begin{equation*}
\lambda_{1}=\frac{\left(1+K^{2} / 2\right)}{2 \gamma^{2}} \lambda_{u} \tag{lí}
\end{equation*}
$$

or

$$
\lambda_{1}[A]=\frac{13.056 \lambda_{u}[\mathrm{~cm}]}{E^{2}[\mathrm{GeV}]}\left(1+K^{2} / 2\right)
$$

The corresponding energy, in practical units, is

$$
\epsilon_{1}[\mathrm{keV}]=0.950 \frac{E^{2}[\mathrm{GeV}]}{1+K^{2} / 2}
$$

The relative bandwidth at the nth harmonic is

$$
\begin{equation*}
\frac{\Delta \lambda}{\lambda} \cong \frac{\Delta \omega}{\omega} \cong \frac{1}{n N} \quad(n=1,2,3, \ldots) \tag{12}
\end{equation*}
$$

On axis the peak intensity of the nth harmonic is given by

$$
\begin{array}{rlr}
\left.\frac{d \mathscr{F}_{n}}{d \theta d \psi}\right|_{0} & =\alpha N^{2} \gamma^{2} \frac{\Delta \omega}{\omega} \frac{1}{e} F_{n}(K) & (n=1,3,5, \ldots) \\
& =0 & \\
(n=2,4,6, \ldots) \tag{13}
\end{array}
$$

where

$$
\begin{align*}
F_{n}(K)=\frac{K^{2} n^{2}}{\left(1+K^{2} / 2\right)^{2}} & \left\{\frac{n-1}{2}\left[\frac{n K^{2}}{4\left(1+K^{2} / 2\right)}\right]\right. \\
& \left.-J_{\frac{n+1}{2}}\left[\frac{n K^{2}}{4\left(1+K^{2} / 2\right)}\right]\right\}^{2} . \tag{14}
\end{align*}
$$

Here, the $J s$ are Bessel functions. The function $F_{n}(K)$ is plotted in Fig 4-4. In practical units [photons $\cdot \mathrm{s}^{-1} \cdot \mathrm{mr}^{-2}$. ( $0.1 \%$ bandwidth) ${ }^{-1}$ ], Eq. (13) becomes

$$
\left.\frac{d F_{n}}{d \theta d \psi}\right|_{0}=1.744 \times 10^{14} N^{2} E^{2}[\mathrm{GeV}] I[\mathrm{~A}] \dot{F_{n}}(K)
$$

The angular distribution of the nth harmonic is concentrated in a narrow cone whose half-width is given by

$$
\begin{equation*}
\sigma_{r^{\prime}} \simeq \sqrt{\frac{\lambda_{n}}{L}}=\frac{1}{\gamma} \sqrt{\frac{\left(1+K^{2} / 2\right)}{2 N n}} \tag{15}
\end{equation*}
$$

Here $L$ is the length of the undulator ( $L=N \lambda_{u}$ ). Additional rings of radiation of the same frequency also appear at angular distances

$$
\begin{equation*}
\theta_{n, \ell}=\frac{1}{\gamma} \sqrt{\frac{\ell}{n}\left(1+K^{2} / 2\right)} \quad(\ell=1,2,3, \ldots) \tag{16}
\end{equation*}
$$

4-8


Fig. 4-4. The function $F_{n}(K)$ for different values of $n$, where $K$ is the deflection parameter.

The angular structure of undulator radiation is illustrated in Fig. 4-5 for the limiting case of zero beam emittance.

We are usually interested in the central cone. An approximate formula for the flux integrated over the central cone is

$$
\begin{equation*}
\mathscr{F}_{n}=\pi \alpha N \frac{\Delta \omega}{\omega} \frac{I}{e} Q_{n}(K) \tag{17}
\end{equation*}
$$

or, in units of photons $\cdot \mathrm{s}^{-1} \cdot(0.1 \% \text { bandwith })^{-1}$,

$$
g_{n}=1.431 \times 10^{14} N Q_{n} I[\mathrm{~A}]
$$

The function $Q_{n}(K)=\left(1+K^{2} / 2\right) F_{n} / n$ is plotted in Fig. 4-6. Equation (13) can also be written as

$$
\begin{equation*}
\left.\frac{d^{2} \mathscr{F}_{n}}{d \theta d \psi}\right|_{0}=\frac{\mathscr{F}_{n}}{2 \pi \sigma_{r^{\prime}}^{2}} \tag{13a}
\end{equation*}
$$

Away from the axis, there is also a change in wavelength; The factor ( $1+K^{2} / 2$ ) in Eq. (11) must be replaced by $\left[1+K^{2} / 2+\gamma^{2}\left(\theta^{2}+\psi^{2}\right)\right]$. Because of this wavelength shift with emission angle, the angle-integrated spectrum consists of peaks at $\lambda_{n}$ superposed on a continuum. The peak-to-

Fig. 4-5. The angular distribution of fundamental $(n=1)$ undulator radiation for the limiting case of zero beam emittance. The $x$ and $y$ axes correspond to the observation angles $\theta$ and $\psi$ (in radians), respectively, and the $z$ axis is the intensity in photons $\cdot s^{-1} \cdot a \mathrm{mp}{ }^{-1} \cdot(0.1 \mathrm{mr})^{-2} \cdot(1 \% \text { bandwidth })^{-1}$. The undulator parameters for this theoretical calculation were $N=14, K=1.87, \lambda_{u}=3.5 \mathrm{~cm}$, and $E=1.3 \mathrm{GeV}$. (Figure courtesy of R. Tatchyn, Stanford Universily.)

4-10


Fig. 4-6. The function $Q_{n}(\dot{K})$ for different values of $n$.
continuum ratio is large for $K \ll 1$, but the continuum increases with $K$, as one shifts from undulator to wiggler conditions.

## B. 3 Power

The total power radiated by an undulator or wiggler is

$$
\begin{equation*}
P_{T}=\frac{N}{6} Z_{0} I e \frac{2 \pi c}{\lambda_{u}} \gamma^{2} K^{2} \tag{18}
\end{equation*}
$$

where $Z_{0}=377$ ohms, or, in practical units,

$$
P_{T}[\mathrm{~kW}]=0.633 E^{2}[\mathrm{GeV}] B_{0}^{2}[\mathrm{~T}] L[\mathrm{~m}] I[\mathrm{~A}]
$$

The angular distribution of the radiated power is

$$
\begin{equation*}
\frac{d^{2} P}{d \theta d \psi}=P_{T} \frac{21 \gamma^{2}}{16 \pi K} G(\dot{K}) f_{K}(\gamma \theta, \gamma \psi) \tag{19}
\end{equation*}
$$

or, in units of $\mathrm{W} \cdot \mathrm{mr}^{-2}$,

$$
\left.\left.\frac{d^{2} P}{d \theta d \psi}=10.84 B_{0} \right\rvert\, \mathrm{T}\right] E^{4}[\mathrm{GeV}] I[\mathrm{~A}] N G(K) f_{K}(\gamma \theta, \gamma \psi)
$$

The behavior of the angular function $f_{K}(\gamma \theta, \gamma \psi)$, which is


Fig. 4-7. The angular function $f_{K}$, for different values of the deflection parameter $K$, (a) as a function of the vertical observation angle $\psi$ when the horizontal observation angle $\theta=0$ and (b) as a function of $\theta$ when $\psi=0$.

4-12
normalized as $f_{K}(0,0)=1$, is shown in Fig. 4-7. The function $G(K)$, shown in Fig. 4-8, quickly approaches unity as $K$ increases from zero.


Fig. 4-8. The function $G(K)$.

## C. EMITTANCE EFFECTS

Electrons in storage rings are distributed in a finite area of transverse phase space-position $\times$ angle. We introduce the rms beam sizes $\sigma_{x}$ (horizontal) and $\sigma_{y}$ (vertical), and beam divergences $\sigma_{x^{\prime}}$ (horizontal) and $\sigma_{y^{\prime}}$ (vertical). The quantities $\epsilon_{x}=\sigma_{x} \sigma_{x^{\prime}}$ and $\epsilon_{y}=\sigma_{y} \sigma_{y^{\prime}}$ are known as the horizontal and vertical emittances, respectively. In general, owing to the finite emittances of real electron beams, the intensity of the radiation observed in the forward direction is less than that given by Eqs. (2a) and (13a). Finite emittances can be taken into account approximately by replacing these equations by
and

$$
\begin{equation*}
\left.\frac{d^{2} \mathscr{F}_{B}}{d \theta d \psi}\right|_{\psi=0}=\frac{d \mathscr{F}_{B}}{d \theta} \frac{1}{\sqrt{2 \pi\left(\sigma_{\psi}^{2}+\sigma_{y^{\prime}}^{2}\right)}} \tag{20}
\end{equation*}
$$

$$
\begin{equation*}
\left.\frac{d^{2} \mathscr{F}_{n}}{d \theta d \psi}\right|_{0}=\frac{\mathscr{F}_{n}^{\prime}}{2 \pi \sqrt{\left(\sigma_{r^{\prime}}^{2}+\sigma_{x}^{2}\right)\left(\sigma_{r^{\prime}}^{2}+\sigma_{y^{\prime}}^{2}\right)}} \tag{21}
\end{equation*}
$$

for bends and undulators, respectively. For bending magnets, the electron beam divergence effect is usually negligible in the horizontal plane.

## D. SPECTRAL BRIGHTNESS AND TRANSVERSE COHERENCE

For experiments that require a small angular divergence and a small irradiated area, the relevant figure of merit is the beam brightness $\mathscr{B}$, which is the photon flux per unit phase space volume, often given in units of photons $\cdot \mathrm{s}^{-1} \cdot \mathrm{mr}^{-2} \cdot \mathrm{~mm}^{-2}$ - ( $0.1 \%$ bandwidth $)^{-1}$. For an undulator, an approximate formula for the peak brightness is

$$
\begin{equation*}
\mathscr{B}_{n}(0,0)=\frac{\mathscr{F}_{n}}{(2 \pi)^{2} \sigma_{T x} \sigma_{T y^{\prime}} \sigma_{T x^{\prime}} \sigma_{T y^{\prime}}} \tag{22}
\end{equation*}
$$

where, for example,

$$
\begin{align*}
& \sigma_{T x}=\sqrt{\sigma_{x}^{2}+\sigma_{r}^{2}}  \tag{23}\\
& \sigma_{T x^{\prime}}=\sqrt{\sigma_{x^{\prime}}^{2}+\sigma_{r^{\prime}}^{2}}
\end{align*}
$$

and where the single-electron radiation from an axially extended source of finite wavelength is described by

$$
\begin{align*}
& \sigma_{r}=\frac{1}{4 \pi} \sqrt{\lambda L}  \tag{24}\\
& \sigma_{r^{\prime}}=\sqrt{\lambda / L}
\end{align*}
$$

Brightness is shown in Fig. 4-9 for several sources of synchrotron radiation, as well as some conventional x-ray sources.

That portion of the flux that is transversely coherent is given by

$$
\begin{equation*}
\mathscr{F}_{c}=\mathscr{B}_{n}\left(\frac{\lambda}{2}\right)^{2}=\frac{\mathscr{F}_{n} \lambda^{2}}{(4 \pi)^{2} \sigma T x^{\sigma} T y^{\sigma} T x^{\prime \sigma} T y^{\prime}} \tag{25}
\end{equation*}
$$



Fig. 4-9. Spectral brightness for several synchrotron radiation sources and conventional $x$-ray sources., The data for conventional $x$-ray tubes should be taken as rough estimates onty, since brightness depends strongly on such parameters as operating voltage and take-off angle. The indicated two-order-of. magnitude ranges show the approximate variation that can. be expected among stationary-anode tubes (lower end of range), rotating-anode tubes (middle), and rotating-anode tubes with microfocusing (upper end of range).

A substantial fraction of undulator flux is thus transversely coherent for a low-emittance beam satisfying $\epsilon_{x} \epsilon_{y} \leqslant(\lambda / 4 \pi)^{2}$.

## E. LONGITUDINAL COHERENCE

Longitudinal coherence is described in terms of a coherence length

$$
\begin{equation*}
e_{c}=\lambda^{2} / \Delta \lambda \tag{26}
\end{equation*}
$$

For an undulator, the various harmonics have a natural spectral purity of $\Delta \lambda / \lambda=1 / n N$ |see Eq. (12)]; thus, the coherence length is given by

$$
\begin{equation*}
\ell_{c}=n N \lambda, \tag{27}
\end{equation*}
$$

which corresponds to the relativistically contracted length of the undulator. Thus, undulator radiation from low-emittance electron beams $\left[\epsilon_{x} \epsilon_{y} \leqslant(\lambda / 4 \pi)^{2}\right]$ is transversely coherent and is longitudinally coherent within a distance described by Eq. (27). In the case of finite beam emittance or finite angular acceptance, the longitudinal coherence is reduced because of the change in wavelength with emission angle. In this sense, undulator radiation is partially coherent. Transverse and longitudinal coherence can be enhanced when necessary by the use of spatial and spectral filtering (i.e., by use of apertures and monochromators, respectively).

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### 4.2 X-RAY TUBES

The spectral brightness of conventional $x$-ray tubes is compared to that of sources of synchrotron radiation in Fig. 4-9. Detailed data on the emission characteristics of tubes, together with additional references, can be found in the references listed below.

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### 4.3 PULSED X-RAY SOURCES

## Gary L. Stradling and John C. Riordan

Both laser-generated plasmas and Z-pinch plasmas are commonly used pulsed x-ray sources. In both, x-ray generation is by radiative recombination and atomic inner-shell line emission. The relative contributions of these two processes at a given x-ray energy depends on several physical plasma parameters, including the electron density and energy distribution, the plasma material, and the ionization states. Bremsstrahlung radiation is generally negligible, except in the case of plasmas produced by long-wavelength lasers. In optically thick, high-atomic-number plasmas, the thermal x-ray emission spectrum can be roughly approximated by a black-body spectrum, with some atomic line structure superimposed.

## A. LASER PLASMA SOURCES

Laser-generated plasmas are produced by illuminating matter with high-power lasers, focused intensities typically ranging from $10^{12}$ to $10^{15} \mathrm{~W} / \mathrm{cm}^{2}$. Small systems in which a few tenths of a joule of $1.06-\mu \mathrm{m}$ light, delivered to an area of about $10^{4} \mu \mathrm{~m}^{2}$ within a few tens of picoseconds, have proved to be useful $x$-ray generators, as have larger systems that deliver tens of kilojoules in less than a nanosecond.

Parametric studies have shown that the x-ray emission efficiency, spectral shape, and emission pulse width depend on the illumination conditions, as well as the irradiated material [1]. Shorter (submicron) wavelengths, moderate irradiation intensities ( $\sim 10^{14} \mathrm{~W} / \mathrm{cm}^{2}$ ), and high-atomic-number plasmas appear to provide the highest $x$-ray production efficiency [2]. Figure 4-10 shows some experimental and theoretical results.

The x-ray emission pulse shape depends on both the photon energy of the emitted radiation and the plasma atomic number. Higher photon energies ( $\geqslant 1 \mathrm{keV}$ ) and higher atomic numbers yield pulse shapes that conform closely to that of the laser. Lower photon energies ( $<1 \mathrm{keV}$ ) and low atomic numbers tend to show pulses wider than the laser pulse. This observation can clearly be understood as the effect of a cooling plasma emitting at progressively lower temperatures. An


Fig. 4-10. Measured and theoretical $x$-ray conversion efficiencies as functions of incident intensities, for three laser wavelengths. The curves represent the results of computer simulations. (From Ref. 2.)
example of this spectral dependence of the pulse width is shown in Fig. 4-11.

A crude relationship can be established between the converted incident laser intensity and the x-ray emission characteristics of the plasma by invoking the Stefan-Boltzmann relationship. In units common to laser applications,

$$
I_{\mathrm{rad}}=1.03 \times 10^{5}\left[\mathrm{~W} /\left(\mathrm{cm}^{2} \cdot \mathrm{eV}^{4}\right)\right] \cdot(k T)^{4}
$$

where $k T$ is the black-body temperature in eV . Thus, a black body would radiate as shown in Table 4-1.

Knowledge of the laser intensity and the $x$-ray conversion efficiency can then be used to obtain an estimate of the region of temperature space the plasma is likely to occupy, assuming that the plasma corresponds to an optically thick black-body emitter.

## B. Z-PINCH SOURCES

In a Z-pinch device, the "pinch plasma" is produced by magnetically imploding a cylindrical gas column that fills an electrode gap. The electrodes are connected to a fast capacitor


Fig. 4-11. Emission history of a gold plasma generated by a"735-ps, 31 $J, I .06-\mu \mathrm{m}$ laser pulse incident on a gold slab. The incident power density was' $3 \times 10^{14} \mathrm{~W} / \mathrm{cm}^{2}$. The decreasing pulse width with increasing photon energy is apparent. Data were taken with a soft x-ray streak camera in combination with a five-channel layered synthetic microstructure spectrometer? with a $10-\mathrm{eV}$ channel width. Relative intensities of the five recorded energy bands were not calibrated. (From Ref. 3.)

Table 4-1. Radiated intensities for several black-body temperatures.

| $k T(\mathrm{eV})$ | $\boldsymbol{I}_{\mathrm{rad}}\left(\mathrm{W} / \mathrm{cm}^{2}\right)$ |
| :---: | ---: |
| 50 | $6.4 \times 10^{11}$ |
| 100 | $1 \times 10^{13}$ |
| 150 | $5.2 \times 10^{13}$ |
| 200 | $1.6 \times 10^{14}$ |

bank, which ionizes the gas in several nanoseconds to form a low-temperature plasma sheath. The plasma conducts a large electric current, whose azimuthal magnetic field radially compresses the plasma to create a hot, dense plasma that is an emitter of intense x -rays.

During the implosion, the plasma acquires kinetic energy which is thermalized as the plasma stagnates on axis. This thermal energy is then radiated away in a submicrosecond pulse by bound-bound and free-bound transitions from a wide range of ionization states in the plasma. The resulting spectrum is a quasi-continuum of merged lines and recombination continua, which typically peaks at $100-200 \mathrm{eV}$ and extends beyond 600 eV .

For most applications requiring a small source spot size, the source is viewed along the plasma axis through a hole in the anode. Hot gas debris and energetic electrons are also emitted through the hole and can damage specimens, filters, or windows placed too close to the source. Nonetheless, successful exposures of low-sensitivity photo resists have been made as close as 15 cm to the source, using a baffle array and permanent magnets to divert the debris and electrons. A1 the other extreme, sensitive materials, such as soft x-ray photographic films, can be exposed tens of meters away in a single shot.

Propane, nitrogen, oxygen, neon, argon, and krypton have been used to optimize the emission of Z-pinch plasmas in different spectral ranges. The radiation spectrum and intensity depend strongly on the working gas, whereas source spot size, pulse width, and jitter do not. Because the soft x-ray yield has a strong inverse dependence on photon energy, the most
intense soft $x$-radiation ( $h \nu \geqslant 1 \mathrm{keV}$ ) is achieved with a neon plasma [4]: The XUV yield ( $h \nu<1 \cdot \mathrm{keV}$ ), on the other hand, generally increases with atomic number because of the greater number of electrons in the radiating shell [4].

The soft x -ray spectrum emitted by a neon plasma consists of $K$-shell tines and recombination continua from both heliumlike and hydrogenlike species $[4]$ (see Fig. 4-12). The XUV, spectrum emitted by an argon plasma is a quasi-continuum of merged $L$-shell lines and recombination continua from a number of partially ionized argon species [5] (see Fig. 4-13).

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Fig. 4-12. Soft $x$-ray spectrum and typical pulse shape of a neon plasma source. The lines marked Ne IX are from He-like ions; those marked Ne $X$ are from $H$ like species.


## SECTION 5

 OPTICS
### 5.1 CRYSTAL AND MULTILAYER DISPERSIVE ELEMENTS

James H. Underwood

Short-wavelength electromagnetic radiation (x-rays and extreme ultraviolet light) is commonly analyzed by use of periodic structures, which split the incident beam into a large number $N$ of separate beams. Between any beam $i$ and the beam $i+1$, the optical path difference is constant. After leaving the periodic structure, the beams are recombined and caused to interfere, whereupon the spectrum of the incident radiation is produced. Dispersion of radiation by a periodic structure is thus formally equivalent to multiple-beam interferometry.

Structures that are periodic across their surface and that produce the $N$ interfering beams by division of the incident wave front are called gratings and are treated in Section 5.3. Here, we consider crystals and multilayer structures, which produce the $N$ interfering beams by division of the incident amplitude.

The spectrum of the incident radiation is dispersed in angle according to the Bragg equation:

$$
n \lambda=2 d \sin \theta
$$

where $n$ is an integer representing the order of the reflection, $\lambda$ is the wavelength of the incident radiation, $d$ is the repeat
period of the multilayer or crystal structure, and $\theta$ is the angle of glancing incidence (the complement of the conventional . optical angle of incidence).

Multilayer structures fall into four separate categories: naturally occurring crystals (i.e., minerals), artificially grown crystals, Langmuir-Blodgett multilayer films, and sputtered or evaporated multilayers.

## A. CRYSTALS AND LANGMUIR-BLODGETT FILMS

For a crystal, $d$ is the lattice spacing, the perpendicular distance between the successive planes of atoms contributing to the reflection. These planes are designated by their Miller indices [ $(h k l)$ or, in the case of crystals belonging to the hexagonal group, (hkil)].

Langmuir-Blodgett multilayer films are made from the heavy-metal (lead, barium, etc.) salts of the aliphatic carboxylic ("fatty") acids $\mathrm{C}_{n} \mathrm{H}_{2 n} \mathrm{O}_{2}$. These films are laid down on a substrate in successive monolayers, with the metal atoms on one side of the monolayer and the fatty acid chain on the other. The films are first laid on the surface of water as a condensed monolayer under a constant surface pressure, then transferred to the substrate in a dipping process, which builds up the multilayer structure layer by layer. The orientation of the molecules alternates with each successive monolayer, so that $d$, the repeat period of the structure, is twice the length of the fatty acid chain. Multilayers of this kind can be built with the salts of lauric (dodecanoic) acid ( 12 carbon atoms, $2 d=70 \AA$ ) through melissic (triacontanoic) acid ( 30 carbon atoms, $2 d=160 \mathrm{~A}$ ). In general, salts of the naturally occurring acids (those with an even number of carbon atoms) can be layered in this way, whereas those that must be made synthetically cannot.

For $2 d$ values greater than about 25 A , the choice of natural crystals is very limited, and those available (such as prochlorite) are likely to be small and of poor quality. Using vacuum deposition techniques, it is now possible to make artificial layered structures with periods ( $d$ ) of 15 A and greater. These sputtered or evaporated multilayers, discussed below, can be used as dispersing elements in the gap between the hydrogen (or "acid") phthalates, such as KAP ( $2 d=26 \mathrm{~A}$ ), and lead laurate $(2 d=70 \mathrm{~A})$. Together with the Langmuir-Blodgett structures, these devices form a bridge
between the region where crystals are useful and the UV region of conventional multilayer technology.

Table 5-1, which begins on p. 5-7, is an expansion and revision of the one compiled by E. P. Bertin [1]. The crystals and multilayers are arranged in order of increasing $2 d$ spacing.

Column 1 is the serial number of the crystal or multilayer in the table.

Column 2 gives common and chemical names and commonly used letter symbols, if any. Only the lead salts are listed for the Langmuir-Blodgett multilayers. The barium or other divalent metal salt usually has a similar $2 d$ spacing to the lead salt, but a lower diffracted intensity.

Column 3 gives the Miller indices $[(h k l)$, or ( $h k i l$ ) for hexagonal crystals)] of the diffracting planes parallel to the surface of the dispersive element. A question mark (?) indicates that the crystal is developmental and that the indices have not been ascertained. An asterisk following the indices indicates that, when reference is made to this crystal in the literature without specification of ( $h k l$ ) or $2 d$, it is likely to be this "cut" that is meant. LBF denotes a Langmuir-Blodgett film.

Column 4 gives the value of $2 d$ in angstroms. The value of $2 d$ also represents the longest wavelength that the structure can diffract.

Column 5 gives the chemical formula for the crystal substance. For organic compounds, the formula is given in a form that indicates the molecular structure.

Column 6 gives the wavelength region lying in the $2 \theta$ interval between $10^{\circ}$ and $140^{\circ}$. The analyzer should be used outside these limits in special cases onily.

Column 7 gives remarks on the principal applications of the analyzer and its limitations. Relative intensities are indicated where known or appropriate.

## B. SPUTTERED OR EVAPORATED MULTILAYER MIRRORS AND DISPERSIVE ELEMENTS

Multilayer $x$-ray reflectors can also be made by vacuum deposition. These structures are made up of ultrathin layers of two different materials, usually elemental, which are laid down on the substrate by alternately exposing it to sources (either sputtering or evaporation sources) of two different vapors. By careful control of deposition conditions, layers as thin as 7.5 A can be laid down.

Normally a sputtered or evaporated multilayer reflector is made up of layers of a material $A$ with thickness ' $A{ }^{-}$and having a high value of $\delta$ (the refractive index decrement, see Sec. 2.7) alternating with "spacer" layers of a material $B$ with thickness $t_{B}$ and having as low a value of $\delta$ as possible in the wavelength region of interest. For example, the use of tungsten (or a similar refractory heavy metal, such as molybdenum or tungsten-rhenium alloy), with carbon as the spacer, has been found to be effective over a wide range of the $x$-ray and soft $x$-ray spectrum.

When the layers are strictly periodic in depth, as described above, the relation between the reflected wavelength and the glancing angle $\theta$ is again given by the Bragg relation, where $d$ is now the period $t_{A}+t_{B}$. It should be noted that in the soft x -ray region, where values of both $\delta$ and $\beta$ (the absorption index, see Sec. 2.7) may be relatively high, the Bragg equation should be corrected for the effects of refraction and absorption. This is best accomplished using a program designed to compute the reflectivity of multilayers; many programs designed for carrying out such calculations for visible-light interference coatings will work for the $x$-ray and extreme UV case without modification. Such programs are also required to calculate the reflectivity of structures that are not periodic in depth, but rather graded in some may to widen the bandpass, increase reflectivity for a fixed number of layers, etc.

Since the number of possible material combinations is quite large, being limited mainly by considerations of material compatibility and "depositability," only some examples of the performance of these multilayers can be given here. In Fig. 5-* 1, we present the calculated normal-incidence peak reflectivity of idealized multilayer coatings of material combinations having the optimum optical constants. The number of layer pairs required to achieve this reflectivity is also plotted on the same scale. In Fig. 5-2, the Bragg reflection characteristics of sputtered or evaporated multilayer structures of tungsten and carbon are presented. For tabulations of the parameters plotted in Fig. 5-2 and for details on how they were calculated, see Ref. 2.

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Fig. 5-1. (a) Calculated normal-incidence peak reflectivities of idealized multilayer coatings of optimum material combinations and (b) the required number of layer pairs. (Computations from Ref. 3.).


Fig. 5-2. Bragg reflection characteristics. plotted as functions of energy. for a sputtered or evaporated tungsten-carbon multilayer. The number of tungsten-carbon double layers was taken as 100 , the $2 d$ spacing as 40 A , and the fractional thickness. $\mathrm{\Gamma}$ of. the tungsten layer as 0.4 ( $t_{W}=\Gamma d$ ). (a) Integrated reflection efficiency calculated with a relation derived for a mosaic crys. tal model ( $R_{m}$ ) and by integrating a modified Darwin-Prins relation $\left(R_{p}\right)$. Numerical integration limits were $\pm 5 \omega$. where $\omega$ is the diffraction width at half maximum.
(b) Percentage reflectivity' $P$ at the peak, as given by the modified Darwin-Prins relation. (c) Resolving power of the analyzer, $E / \Delta E$, where $\Delta E$ is the equivalent energy diffraction width. (From Ref. 2.)

Table 5-1. Selected data for crysials and Langmuir-Blodgett multilayer films used as dispersive elements in x-ray spectrometers and monochromators.

| No. | Crystal | Miller indices | $2 d$ (A) | Chemical formala | Usefal waveleagth region ( A ) | Applications, remarls |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | $\alpha$-Quartz, silicon dioxide | ( $50-\overline{5} 2$ ) | 1.624 | $\mathrm{SiO}_{2}$ | 0.142-1.55 | Shortest $2 d$ of any practical crystal. Good for high- $Z K$-lines excited by $100-\mathrm{k} V$ generators. |
| 2 | Lithium fluoride | (422) | 1.652 | LiF | 0.144-1.58 | Better than quartz ( $50 \overline{5} 2$ ) for the same applications. |
| 3 | Conundum, aluminum oxide | (146) | 1.660 | $\mathrm{Al}_{2} \mathrm{O}_{3}$ | 0.145-1.58 | Same applications as quariz (50 $\overline{5} 2$ ). |
| 4 | Lithium fluoride | (420) | 1.801 | LiF | 0.157-1.72 | Similar to LiF (422). |
| 5 | Calcitc. calcium carbonate | (633) | 2.02 | $\mathrm{CaCO}_{3}$ | 0.176-1.95 |  |
| 6 | a.Quantz, silicon dioxide | (224]) | 2.024 | $\mathrm{SiO}_{2}$ | 0.177-1.96 |  |
| 7 | $\alpha$-Quarzz, silicen dioxide | (3140) | 2.3604 | $\mathrm{SiO}_{2}$ | 0.205-2.25 | Transmission-crystal optics. |
| 8 | ar-Quartz, siticon dioxide | (2240). | 2.451 | $\mathrm{SiO}_{2}$ | 0.213-2.37 |  |
| 9 | Topaz, hydrated aluminum fluorosilicate | (303) | 2.712 | $\mathrm{Al}_{2}(\mathrm{~F} . \mathrm{OH})_{2} \mathrm{SiO}_{4}$ | 0.236-2.59 | Improves dispersion for V.Ni $K$-lines and rare earth $L$-lines. |
| 10. | Conundum, aluminum oxide, sapphire, alumina | (030) | 2.748 | $\mathrm{Al}_{2} \mathrm{O}_{3}$ | 0.240-2.62 | Diffracted intensity ~ 2-4X topaz (303) and quariz (203) with the same or better resolution. |

Table 5-1. Selected data for crystals and Langmuir-Blodgett mulilayer films (continued).

| No. | Crystal | Miller Indices | $2 d$ ( A$)$ | Chemical formuta | Useful wavelength region ( A ) | Applications, remarks |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 11 | $\alpha$-Quartz, silicon dioxide | (2023) | 2.749 | $\mathrm{SiO}_{2}$ | 0.240-2.62 | Same applications as topaz (303) and LiF (220). |
| 12 | Topaz | (006) | 2.795 | $\mathrm{Al}_{2}(\mathrm{~F}, \mathrm{OH})_{2} \mathrm{SiO}_{4}$ | 0.244-2.67 |  |
| 13 | Lithium fluoride | (220) | 2.848 | LiF | 0.248-2.72 | Same applications as topaz (303) and quanz (2023), with 2-4X their diffracted intensity. Diffracted intensily $\sim 0.4-0.8 \mathrm{X}$ LiF (200). |
| 14 | Mica, muscovite | $(331)$ | . 3.00 | $\mathrm{K}_{2} \mathrm{O} \cdot 3 \mathrm{Al}_{2} \mathrm{O}_{3} \cdot 6 \mathrm{SiO}_{2} \cdot 2 \mathrm{H}_{2} \mathrm{O}$ | 0.262-2.86 | Transmission erystal optics (Cauchois, DuMond types). |
| 15 | Calcite, calcium carbonate | (422) | $\cdots 3.034$ | $\mathrm{CaCO}_{3}$ | 0.264-2.93 | : . . . |
| 16 | $\alpha$-Quartz, silicon dioxide | - (2131) | 3.082 | $\mathrm{SiO}_{2}$ | 0.269-2.94 | " |
| 17 | $\alpha$-Quartz, silicon dioxide | (1122) | 3.636 | $\mathrm{SiO}_{2}$ | 0.317-3.47 | : . |
| 18 | Silicon | (220) | 3.840343 | Si | 0.335-3.66 | Lattice period known to high accuracy. |
| 19 | Fuorite, calcium fluoride | (220) | 3.362 | $\mathrm{CaF}_{2}$ | 0.337-3.68 | . |
| 20 | Germanium | (220) | 4.00 | Ge | 0.349-3.82 |  |
| 21 | Lithium fluoride. | (200) ${ }^{\text {+ }}$ | 4.027 | LiF | . $0.351-3.84$ | Best general crystal for $\mathrm{K} K$ - to Lr $L$-lines. Highest intensity for |


| 22 | Aluminum | (200) | 4.048 | A] |  |  | 0.353-3.86 | Curved, especially doubly curved, optics. |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 23 | $\alpha$-Quartz, siticon dioxide | (2020) | 4.246 | $\mathrm{SiO}_{2}$ |  |  | $0.370-4.11$ | "Prism" cut. |
| 24 | $\alpha$-Quartz silicon dioxide | (1012) | 4.564 | $\mathrm{SiO}_{2}$ | , | . | 0.398-4.35 | Used in prototype Laue multichannel spectrometer. |
| 25 | Topaz | (200) | 4.638 | $\mathrm{Al}_{2}(\mathrm{~F}, \mathrm{OH})_{2} \mathrm{SiO}_{4}$ |  |  | 0.405-4.43 |  |
| 26 | Aluminum | (111) | 4.676 | Al |  | , | 0.408-4.46 | Curved, especially doubly curved, optics. |
| 27 | $\alpha$-Quartz, silicon dioxide | (1120) | 4.912 | $\mathrm{SiO}_{2}$ |  |  | 0.428-4.75 |  |
| 28 | Gypsum, calcium sulfate dihydrate | (002) | 4.990 | $\mathrm{CaSO}_{4} \cdot 2 \mathrm{H}_{2} \mathrm{O}$ |  | - | 0.435-4.76 | Eflorescent: loses water in vacuum to become Plaster of Paris. |
| 29 | Rock salt, sodium chloride | (200) | 5.641 | NaCl |  |  | 0.492-5.38 | $\mathrm{SK} \alpha$ and $\mathrm{Cl} K \alpha$ in light matrixes. Like LiF (200), good general crystal for $\mathrm{S} K$ to $\mathrm{Lr} L$, |
| 30 | Calcite, calcium carbonate | (200) | 6.071 | $\mathrm{CaCO}_{3}$ | , | - | 0.529-5.79 | Very precise wavelength measurements. Extremely high degree of crystal perfection with resultant sharp tines. Replaced $\mathrm{NaCl}(200)$ as standard for the $x$-unit. Large pieces can be obtained. |
| 31 | Ammonium dihydrogen phosphate (ADP) | (112) | 6.14 | $\mathrm{NH}_{4} \mathrm{H}_{2} \mathrm{PO}_{4}$ |  |  | 0.535-5.86 | . ${ }^{\text {- }}$ |

Table 5-1. Selected data for crystals and Langmuir-Blodgett multilayer films (continued).

| No. | Crystal | Miller indices | $2 d$ ( $A$ ) |  | Chemical formula | Ugeful wavelength region ( $A$ ) | Applications, remarks |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 32 | Silicon | (111)* | 6.271 | Si |  | 0.547-5.98 | Very rugged and stable general. purpose crystal. High degree of perfection obtainable. |
| 33 | Sylvite, potassium chloride | (200) | 6.292 | KCl | - | 0.549-6.00 |  |
| 34 | Fluorite, calcium fluoride | (111) | 6.306 | $\mathrm{CaF}_{2}$ |  | $0.550-6.02$ | Very weak second order, strong third order. |
| 35 | Germanium | (11)* | 6.532 | Ge |  | -0.570-6.23 | Eliminates second order. Useful for intermediate. and low. 7 elements where $\mathrm{Ge} K \alpha$ emission is eliminated by pulse-height selection. |
| 36 | Potassium bromide | (200) | 6.584 | $\mathrm{KBr}^{\text {r }}$ |  | 0.574-6.28 | ". . . |
| 37 | $\alpha$-Quartz, silicon. dioxide | (1011) | 6.687 | $\mathrm{SiO}_{2}$ |  | 0.583-6.38 | $P K \alpha$ in low- $Z$ matrixes. especially in calcium. Intensity for $\mathrm{P}-\mathrm{K} \mathrm{K}$-lines greater than EDDT, but less than PET. |
| 38 | Graphite |  | 6.708 | c $\ddots$ |  | 0.585-6.40 | P, $\mathrm{S}, \mathrm{Cl} K$-lines. $\mathrm{P} K \alpha$ intensity $>5 X$ EDDT. Relatively poor resolution but high integrated reflectivity. |
| 39 | Ammonium hydrogen citrate | (?) | 7.38 | ClOH | $\mathrm{COOH})\left(\mathrm{CH}_{2} \mathrm{COONH}_{4}\right)_{2}$ | 0.644-7.04 |  |


| 40 | Indium antimonide | (111) | 7.4806 | InSb | 0.652-7.23 | 'Important for $K$-edge of Si. |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 41 | Ammonium dihydrogen phosphate (ADP) | (200) | 7.5 | $\mathrm{NH}_{4} \mathrm{H}_{2} \mathrm{PO}_{4}$ | 0.654-7.16 | Higher intensity than EDDT. |
| 42 | Topaz | (002) | 8.374 | $\mathrm{Al}_{2}(\mathrm{~F}, \mathrm{OH})_{2} \mathrm{SiO}_{4}$ | 0.730-7.99 |  |
| 43 | a-Quartz, silicon diozide | (1010): | 8.512 | $\mathrm{SiO}_{2}$ | 0.742-8.12 | Same applications as EDDT and PET; higher resolution, but lower intensity. |
| 44 | Pentaerythritol (PET) | (002) | 8.742 | $\mathrm{C}\left(\mathrm{CH}_{2} \mathrm{OH}\right)_{4}$ | 0.762-8.34 | $\mathrm{Al}, \mathrm{Si}, \mathrm{P}, \mathrm{S}, \mathrm{Cl} \mathrm{K} \alpha$. Intensities $\sim 1.5-2 \mathrm{X}$ EDDT, $\sim 2.5 \mathrm{X}$ KHP. Good general crystal for Al-Sc $K \alpha$. Low background. Soft; deteriorates with age and exposure to x-rays. Must be stored in desiocator. |
| 45 | Ammonium tartrate | (?) | 8.80 | $(\mathrm{CHOH})_{2}(\mathrm{COONH})_{2}$ | 0.767-8.4 |  |
| 46 | $E$ thylenediamine-d. tartrate (EDDT, EDdT, EDT) | (020) | 8.808 |  | 0.768-8.40 | Same applications as PET, but lower intensity, substantially lower thermal expansion coefficient. Rugged and stable. |
| 47 | Ammonium dihydrogen phosphate (ADP) | (101)* | 10.640 | $\mathrm{NH}_{4} \mathrm{H}_{2} \mathrm{PO}_{4}$ | 0.928-10.15 | $\mathrm{Mg} K \alpha$. Same applications as PET, EDDT, but lower intensity. |
| 48 | Na $\beta$-alumina. | (0004) | 11.24 | $\mathrm{NaAl}_{11} \mathrm{O}_{17}$ | 0.980-10.87 |  |
| 49 | Oxalic acid dihydrate | (001) | 11.92 | $(\mathrm{COOH})_{2} \cdot 2 \mathrm{H}_{2} \mathrm{O}$ | 1.04-11.37 |  |
| 50 | Sorbitol hexaacetate (SHA) | (110) | 13.98 |  | 1.22-13.34 | Applications similar to ADP (101) and gypsum (020). High resolution; stable in vacuum. Available in small pieces only. |

Table 5-1. Selected data for crystals and Laingmuir-Blodgett multilayer films (continued).

| No. | Crystal | Miller indices |  | - Chentical formula |  | Useful wavelength region ( $A$ ) | - Applications, remarla |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| \$1 | Rock sugar, sucrose | (001) | 15.12 | $\mathrm{C}_{12} \mathrm{H}_{22} \mathrm{O}_{11}$ |  | 1.32-14.42 |  |
| 52. | Gypsum, calcium sulfate dihydrate | (020)* | 15.185 | $\mathrm{CaSO}_{4} \cdot 2 \mathrm{H}_{2} \mathrm{O}$ |  | 1.32-14.49 | $\mathrm{Na} K \alpha$. Inferior to KHP, RHP , and beryl. Poor in vacuum (efflorescent). |
| 53 | Beryl | $(1010)^{*}$ | 15.954 | $3 \mathrm{BeO}: \mathrm{Al}_{2} \mathrm{O}_{3} \cdot 6 \mathrm{SiO}_{2}$ |  | 1.39-15.22 | Difficult to obtain. Good specimens have $\lambda / \delta \lambda \sim$ 2500-3000 at 12 A. $2 d$ may vary among specimens. |
| 54 | Bismuth titanate | (040) | 16.40 | $\mathrm{Bi}_{2}(\mathrm{TiO})_{3}{ }_{3}$ |  | 1.43-15.65 |  |
| 55 | Itaconic acid, methylenebutanedioic acid | (020) | 18.50 | $\left.\mathrm{CH}_{2} \mathrm{ClCOOH}\right) \mathrm{CH}_{2} \mathrm{COOH}$ |  | 1.61-17.65 | $\cdots$ |
| 56 | Mica, muscovite | (002)* | 19.84 | $\mathrm{K}_{2} \mathrm{O}-3 \mathrm{Al}_{2} \mathrm{O}_{3} \cdot 6 \mathrm{SiO}_{2}-2 \mathrm{H}_{2} \mathrm{O}$ |  | 1.73-18.93 | Easy to obtain. Easily bent: good for curved-crystal spectrometers," spectrographs. Cleavage plane. Higher orders may be strong |
| 57 | Silver acetate | (001) | 20.0 | $\mathrm{CH}_{3} \mathrm{COOAg}$ |  | 1.74-19.08 |  |
| 58 | Rock sugar, sucrose | (100) | 20.12 | $\mathrm{C}_{11} \mathrm{H}_{22} \mathrm{O}_{11}$ |  | 1.75-19.19 | $\cdots$ |
| 59 | $\mathrm{Na} \beta$ alumina | (0002) | 22.49 | $\mathrm{NaAl}_{11} \mathrm{O}_{17}$ |  | 1.96-21.74 |  |
| 60 | Thallium hydrogèn phthalate (THP, THP. TAP, ${ }^{\text {a }}$ TlAP ${ }^{\text {a }}$ ) | (100) | 25.9 | $\mathrm{THHC}_{8} \mathrm{H}_{4} \mathrm{O}_{4}$ |  | 2.26-24.7 | Same applications as KHP, RHP |


| 61 | Rubidium hydrogen phthalate (RHP. RbHP, RAP, ${ }^{\text {a }}$ RbAP ${ }^{\mathbf{a}}$ ) | (100) | 26.121 | $\mathrm{RbHC}_{8} \mathrm{H}_{4} \mathrm{O}_{4}$ | 2.28-24.92 | Diffracted intensity $\sim 3 \times$ KHP for Na . Mg. Al $K \alpha$ and $\mathrm{Cu} L \alpha_{1}$; $\sim 4 \mathrm{XKHP}$ for $\mathrm{F} K a ; \sim 8 \mathrm{KHP}$ for $O K \alpha$. |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 62. | Potassium hydrogen phthalate (KHP, KAP ${ }^{\text {a }}$ ) | (100) | 26.632 | $\mathrm{KHC}_{8} \mathrm{H}_{4} \mathrm{O}_{4}$ | 2.32-25.41 | Good general crystal for all low-Z elements down to 0 . |
| 63 | Clinochlore (hydrated Mg Al Fe silicate aluminate) | (001) | 28.39 |  | 2.48-27.09 | O $K \alpha$ intensity $\sim 4 \mathrm{X}$ KHP but only $\sim 0.2 \mathrm{X} \mathrm{Pb}$ stearate. Lifficult to obtain good specimens. |
| 64 | Penninite (similar to clinochlore) | (001) | 28.4 |  | 2.48-27.1 | Same applications as clinochlore. |
| 65 | Potassium hydrogen cyclohexane-1,2. diacetate | (?) | 31.2 | $\mathrm{KHC}_{10} \mathrm{H}_{14} \mathrm{O}_{4}$ | 2.72-29.76 | High resolution; good crystallinity. |
| 66 | Tetradecanoamide | (?) | -54 | $\mathrm{CH}_{3}\left(\mathrm{CH}_{2}\right)_{12} \mathrm{CONH}_{2}$ | 4.71-51.5 | Ultralong-wavelength region down to $C K \alpha$. |
| 67 | Hexadecyl hydrogen maleate (HHM) | (?) | 58.0 | $\mathrm{CH}_{3}\left(\mathrm{CH}_{2}\right)_{15} \mathrm{OOC}-\mathrm{CH}: \mathrm{CH}-\mathrm{COOH}$ | 5.06-55.3 | Ultralong-wavelength region down to $\mathrm{C} K \alpha$. |
| 68 | Octadecyl hydrogen maleate ( OHM ) | (?) | 63.5 | $\mathrm{CH}_{3}\left(\mathrm{CH}_{2}\right)_{17} \mathrm{OOC}-\mathrm{CH}: \mathrm{CH}-\mathrm{COOH}$ | 5.54-60.6 | Ultralong-wavelength region down to C $K \alpha$. |
| $69^{\circ}$ | Lead laurate, lead dodecanoate | LBF. | $\sim 70$ | $\left[\mathrm{CH}_{3}\left(\mathrm{CH}_{2}\right)_{10} \mathrm{COO}\right]_{2} \mathrm{~Pb}$ | 6.10-66.8 | Ultralong-wavelength region down to $\mathrm{B} \mathrm{K} \alpha$. |
| 70 | Behenyl hydrogen maleate ( 8 HM ) | (?) | $\sim 74$ | $\mathrm{CH}_{3}\left(\mathrm{CH}_{2}\right)_{21} \mathrm{OOC}-\mathrm{CH}: \mathrm{CH}-\mathrm{COOH}$ | 6.45-70.6 | Ultralong-wavelength region down to BKa. |
| 71 | Lead myristate, lead tetradecanoate (LTD) | LBF | 80.5 | $\left[\mathrm{CH}_{3}\left(\mathrm{CH}_{2}\right)_{12} \mathrm{COO}\right]_{2} \mathrm{~Pb}$ | 7.02-76.8 | Ultralong-wavelength region down to $8 K \alpha$. |

Table 5-1. Selected data for crystals and Langmuir-Blodgett multilayer films (continued).


Al $K \alpha, \sim 1$ for $\mathrm{Mg} K \alpha, \sim 1.5$ for $\mathrm{NaK} \alpha, \sim 2.5$ for $\mathrm{F} \mathrm{K} \alpha$.

| 78 | Lead arachidate, lead eicosanoate | LBF | $\sim 110$ | $\left[\mathrm{CH}_{3}\left(\mathrm{CH}_{2}\right)_{18} \mathrm{COO}_{2} \mathrm{~Pb}\right.$ | 9.6-105 | Ultralong-wavelength region down to $\mathrm{B} K$. |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 79 | Lead behenate, lead docosanoate | LBF | $\sim 120$ | $\left[\left.\mathrm{CH}_{3}\left(\mathrm{CH}_{2}\right)_{20} \mathrm{COO}\right\|_{2} \mathrm{~Pb}\right.$ | 10.5-114 | Ultralong-wavelength region down to $\mathrm{Be} K \alpha$. |
| 80 | Lead lignocerate, lead carnaubate, lead tetracosanoate (LTE) | LBF | $\sim 126$ | $\left[\left.\mathrm{CH}_{3}\left(\mathrm{CH}_{2}\right)_{22} \mathrm{COO}\right\|_{2} \mathrm{~Pb}\right.$ | - 11.4-124 | Ultralong-wavelength region down to $\mathrm{Be} K \alpha$. |
| 81 | Lead cerotate, lead hexacosanoate | LBF | $\sim 140$ | $\left[\left.\mathrm{CH}_{3}\left(\mathrm{CH}_{2}\right)_{24} \mathrm{COO}\right\|_{2} \mathrm{~Pb}\right.$ | 12.2-134 | Ultralong-wavelength region down to Be Ka. |
| 82. | Lead melissate, lead triacontanoate (LTC) | LBF | $\rightarrow 156$ | $\left[\left.\mathrm{CH}_{3}\left(\mathrm{CH}_{2}\right)_{38} \mathrm{COO}\right\|_{2} \mathrm{~Pb}\right.$ | 14.0-156 | Ultralong-wavelength region down to Be Ka . |

*See text.
${ }^{\text {a }}$ For rubidium or potassium arid phthalate, which is not preferred nomenclature
'Not to be confused with the hallueinogenic drug lysergic acid diethylamide.
${ }^{\text {c }}$ The symbol LOD is used for both lead octadecanoate (stearate) and lead octadecanoate decanoate.

### 5.2 SPECULAR REFLECTIVITIES FOR GRAZING-INCIDENCE MIRRORS

## - -.. Burton L. Henke

Figures 5-3 through 5-10 give reflectivities for eight grazingincidence $x$-ray mirrors, calculated from the scattering factors tabulated in Section 2.7. The calculations, which are summarized in B. L. Henke, P. Lee, T. J. Tanaka, R. L. Shimabukuro, and B. K. Fujikawa, "Low-Energy X-Ray Interaction Coefficients: Photoabsorption, Scattering, and Reflection," At. Data Nucl. Data Tables 27, 1 (1982), assume unpolarized incident radiation and perfectly smooth mirror surfaces.

The calculations are also based on the assumption that, in the low-energy x-ray region, the atoms within a condensed system act independently as scattering dipoles. The total atomic dipole moment per unit electric field amplitude is thus proportional to the average atomic scattering factor for the medium. Results for grazing angles from 10 to 785 mr at energies between 100 and 1740 eV are given in the reference cited above.


Fig. 5-3. Specular reflectivity for beryllium, assuming a mirror density of $1.85 \mathrm{~g} \cdot \mathrm{~cm}^{-3}$.



Fig. 5-5. Specular reflectivity for fised quartz, assuming a mirror density of $2.20 \mathrm{~g} \cdot \mathrm{~cm}^{-3}$.



Fig. 5-7. Specular reflectivity for aluminum, assuming a mirror density of $2.70 \mathrm{~g} \cdot \mathrm{~cm}^{-3}$.


Fig. 5-8. Specular reflectivity for nickel, assuming a mirror density of $8.90 \mathrm{~g} \cdot \mathrm{~cm}^{-3}$.


Fig. 5-9. Specular reflectivity for copper, assuming a mirror density of $8.96 \mathrm{~g} \cdot \mathrm{~cm}^{-3}$.


Fig. 5-10. Specular reffectivity for gold, assuming a mirror density of $19.3 \mathrm{~g} \cdot \mathrm{~cm}^{-3}$.

### 5.3 GRATINGS AND MONOCHROMATORS

## Malcolm R. Howells

## A. DIFFRACTION PROPERTIES

## A. 1 Notation and sign convention

If we adopt the notation of Fig. 5-11, $\alpha$ and $\beta$ have opposite signs if they are on opposite sides of the normal.

## A. 2 Grating equation

The basic grating equation may be written

$$
\begin{equation*}
m \lambda=d(\sin \alpha+\sin \beta) \tag{1}
\end{equation*}
$$

The angles $\alpha$ and $\beta$ are both arbitrary, so it is possible to impose various conditions relating them. If this is done, then for each $\lambda$, there will be a unique $\alpha$ and $\beta$. The following conditions are used:
(i) On-blaze condition:

$$
\begin{equation*}
\alpha+\beta=2 \theta_{B} \tag{2}
\end{equation*}
$$

where $\theta_{B}$ is the blaze angle (the angle of the sawtooth; see Table $5 \cdot 2$ ). The grating equation is then

$$
\begin{equation*}
m \lambda=2 d \sin \theta_{B} \cos \left(\beta+\theta_{B}\right) \tag{3}
\end{equation*}
$$



Fig. 5-11. Illustration of notational conventions.
(ii) Fixed in and out directions:

$$
\begin{equation*}
\therefore \alpha-\beta=2 \theta \tag{4}
\end{equation*}
$$

where $2 \theta$ is the (constant) included angle. The grating equation is then.

$$
\begin{equation*}
m \lambda=2 \dot{d} \cos \theta \sin (\theta+\beta) \tag{5}
\end{equation*}
$$

In this case, the wavelength scan ends when $\alpha$ or $\beta$ reaches $90^{\circ}$, which occurs at the horizon wavelength $\lambda_{H}=2 d \cos ^{2} \theta$.
(iii) Constant incidence angle: Equation (1) gives $\beta$ directly.
(iv) Constant focal distance (of a plane grating):

$$
\begin{equation*}
\frac{\cos ^{2} \alpha}{\cos ^{2} \beta}=K\left(=-\frac{r}{r^{\prime}} ; \text { see later }\right)^{\prime} \tag{6}
\end{equation*}
$$

leading to a grating equation

$$
\begin{equation*}
\left(\frac{m \lambda}{d}-\sin \beta\right)^{2}=1-K\left(1-\sin ^{2} \beta\right) \tag{7}
\end{equation*}
$$

Equations (3), (5), and (7) can readily be inverted to give $\beta$ (and thence $\alpha$ ) for any $\lambda$. Examples of the above $\alpha-\beta$ relationships are as follows:
(i) Hunter et al. double plane-grating monochromator (PGM) [1], Kunz et al. PGM [2].
(ii) Mijake et al. [3], West et al. [4], Howell's et al. [5], Eberhardt et al, (Flipper) [6] PGMs; all grazingincidence toroidal-grating monochromators (TGMs) [7], Seya-Namioka [8,9], most aberration-reduced holographic, spherical-grating devices.
(iii) Essentially all spectrographs, Grasshopper monochromator [10].
(iv) . Petersen (SX700) [11], Brown et al. (UMO) |12|.

## B. FOCUSING PROPERTIES

Gratings have complex focusing properties that vary according to the substrate shape and the pattern of grooves on the surface. An important special case is a Rowland grating, which is the intersection of the substrate surface with a set of parallel equispaced planes. The calculation of focusing properties is traditionally carried out by the use of analytical formulas for the optical path function $F$. Such formulas use a power series
development in the aperture coordinates, with each term of the series representing a recognizable geometrical optical aberration. Here, we consider only a toroidal Rowland grating illuminated by a point source in the symmetry plane [13]; see Fig. 5-12.

We then have

$$
\begin{array}{ll}
F= & F_{00}+w F_{01}+\frac{1}{2} w^{2} F_{20}+\frac{1}{2} \ell^{2} F_{02} \\
& +\frac{1}{2} w^{3} F_{30}+\frac{1}{2} w \ell^{2} F_{12}+\frac{1}{8} w^{4} F_{40}+\cdots \\
F_{00}=r+r^{\prime} & \\
F_{01}=\frac{m \lambda}{d}-\sin \alpha-\sin \beta & \text { (Grating equation) } \\
F_{20}=\Sigma T & \text { Defocus } \\
F_{02}=\Sigma S & \text { Astigmatism } \\
F_{30}= & \text { Coma } \\
F_{12}= & =\Sigma \frac{\sin \alpha}{r} T \tag{8f}
\end{array}
$$

$$
F_{40}=\Sigma\left(\frac{4 \sin ^{2} \alpha}{r^{2}} T-\frac{T^{2}}{r}+\frac{S}{R^{2}}\right) \quad \begin{aligned}
& \text { Spherical } \\
& \text { aberration }
\end{aligned}(8 \mathrm{~g})
$$



Fig. 5-12. Geometry and notation for a toroidal Rowland grating illuminated by a point source in the symmetry plane.
where

$$
\begin{aligned}
& T=\frac{\cos ^{2} \alpha}{r}-\frac{\cos \alpha}{R} \\
& S=\frac{1}{r}-\frac{\cos \alpha}{p}
\end{aligned}
$$

and the $\Sigma$ i:mplies that a second expression must be added that is identical to the first, except for the replacements $r \rightarrow r^{\prime}$ and $\alpha \rightarrow \beta$.

The condition for focus is $F_{20}=0$. This can be achieved by setting $r=R \cos \alpha$ and $r^{\prime}=R \cos \beta$, which implies that $A$ and $B_{0}$ are on the Rowland circle with diameter $R$. This is the normal choice for spectrographs but is not convenient for constant-deviation monochromators. For TGMs, $r$ and $r^{\prime}$ are chosen so that $F_{20}=0$ for two wavelengths within the working region.

The importance of the optical path function is that it enables the transverse ray aberrations $\Delta y_{i j}$ and $\Delta z_{i j}$ to be calculated for each aberration. These are measured from the Gaussian (paraxial) image point $B_{0}\left(r^{\prime}, \beta, 0\right)$ given by the grating equation and the focusing condition ( $F_{20}=0$ ).

The transverse ray aberrations are then given by

$$
\begin{equation*}
\Delta y_{i j}=\frac{r^{\prime}}{\cos \beta} \cdot \frac{\partial F_{i j}}{\partial w} \tag{9a}
\end{equation*}
$$

and

$$
\begin{equation*}
\Delta z_{i j}=r^{\prime} \frac{\partial F_{i j}}{\partial \ell} \tag{9b}
\end{equation*}
$$

The final result for the ray position is given by

$$
\begin{equation*}
\Delta y=\sum_{i j} \Delta y_{i j} \tag{10a}
\end{equation*}
$$

and

$$
\begin{equation*}
\Delta z=\sum_{i j} \Delta z_{i j} \tag{10b}
\end{equation*}
$$

## C. DISPERSION PROPERTIES

## C. 1 Angular dispersion

Angular dispersion is.given by

$$
\begin{equation*}
\left(\frac{\partial \lambda}{\partial \beta}\right)_{\alpha}=\frac{d \cos \beta}{m} \tag{11}
\end{equation*}
$$

## C. 2 Reciprocal linear dispersion

Reciprocal linear dispersion is given by

$$
\begin{equation*}
\left(\frac{\partial \lambda}{\partial q}\right)_{\alpha}=\frac{d \cos \beta}{m r^{\prime}} \equiv \frac{10^{-3} d[\AA] \cos \beta}{m r^{\prime}[\mathrm{m}]} A / \mathrm{mm} \tag{12}
\end{equation*}
$$

where $q$ is measured in the symmetry plane perpendicular to the outgoing ray. For the Rowland circle case, $r^{\prime}=R \cos \beta$ in Eq. (12)

## C. 3 Magnification

Magnification is given by

$$
\begin{equation*}
M(\lambda)=\frac{\cos \alpha}{\cos \beta} \frac{r^{\prime}}{r} \tag{13}
\end{equation*}
$$

## D. RESOLUTION PROPERTIES

The following are the main contributions to the final resolution. The actual resolution is the vector sum.
(i) Entrance slit (width $S_{1}$ ):

$$
\begin{equation*}
\Delta \lambda_{S 1}=\frac{S_{1} d \cos \alpha}{m r} \tag{14}
\end{equation*}
$$

(ii) Exit slit (width $S_{2}$ ):

$$
\begin{equation*}
\Delta \lambda_{S 2}=\frac{S_{2} d \cos \beta}{m r^{\prime}} \tag{15}
\end{equation*}
$$

(iii) Diffraction:

$$
\begin{equation*}
\Delta \lambda_{D}=\lambda / m N \tag{16}
\end{equation*}
$$

where $N$ is the number of participating grooves.
(iv) Aberrations (due to perfect optics):

$$
\begin{equation*}
\Delta \lambda_{A}=\frac{\Delta y d \cos \beta}{m r^{\prime}}=\frac{d}{m}\left(\frac{\partial F}{\partial y}\right) \tag{17}
\end{equation*}
$$

(v) System spread function (due to imperfect optics):

$$
\begin{equation*}
\Delta \lambda_{\mathrm{LSF}}=\frac{w d \cos \beta}{m r^{\prime}} \tag{18}
\end{equation*}
$$

where $w$ is the width of the system line spread function.

## E. EFFICIENCY

The calculation of diffraction grating efficiencies is, in general, highly complex [14]; however, some simplification is possible in the soft x-ray region. In Table 5-2, we give scalar theory - formulas for the absolute efficiency $E_{\lambda}$, which should be approximately valid if (a) the rellectance $R_{\lambda}$ is independent of polarization, (b) groove shadowing is negligible, and (c) the projected groove spacing satisfies the inequality $d \cos \alpha>5 \lambda$.

In the table, $\delta=2 \pi h(\cos \alpha+\cos \beta) / \lambda$, where $h$ is the peak-to-valley amplitude of the grating profile and $m$ is the spectral order defined in Fig. 5-11. The equation $\delta=Q$ can be solved to find $(\lambda / d)_{\text {peak }}$ as a function of $h, \alpha, d$, and $m$ as follows:

$$
\begin{equation*}
\left(\frac{\lambda}{d}\right)_{\text {peak }}=\frac{2 m \sin \alpha+\frac{Q d \cos \alpha}{\pi h}}{\frac{Q^{2} d^{2}}{4 \pi^{2} h^{2}}+m^{2}} \tag{19}
\end{equation*}
$$

Table 5-2. Scalar theory formulas for gräting efficiency.

|  | Lamells | Sinasoidal (holographic) | Blinzed |
| :---: | :---: | :---: | :---: |
| Waveform | square wave | sine wave | sawtooth |
| $E_{\lambda} / R_{\lambda}$ | $\left(\frac{2}{m \pi}\right)^{2} \sin ^{2}\left(\frac{\delta}{2}\right)$ | $J_{m}^{2} \frac{\delta}{2}$. | $\operatorname{sinc}^{2}\left(1 m \left\lvert\, \pi-\frac{\delta}{2}\right.\right)$ |
| Valid for m = | $\pm 1,3,5, \ldots$ | $\pm 1$ | $\pm 1.2,3, \ldots$ |
| $\delta$ at peak efficiency ( $Q$ ) | $m \pi$ | 3.68 | $2 m \pi$ |
| Peak value of $E_{\lambda} / R_{\lambda}(\%)$ | 40 | 34 | 100 |

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5-32
toroid with $a_{i j}$ values as follows: $a_{20}=1 /(2 R), a_{02}=$ $1 /(2 \rho), a_{40}=1 /\left(8 R^{2}\right), a_{22}=1 /\left(4 R^{2} \rho\right), a_{04}=1 /\left(8 \rho^{3}\right)$, all other $a_{i j}=0$ for $i+j \leqslant 4$.
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### 5.4 ZONE PLATES

Janos Kirz

Zone plates are circular diffraction gratings. In its simplest form, a transmission Fresnel zone plate for use with incident plane waves consists of alternate transparent and opaque rings. The radii of the zone edges are given by

$$
\begin{equation*}
r_{n}^{2}=n f \lambda+n^{2} \lambda^{2} / 4 \tag{1}
\end{equation*}
$$

where $n$ is the zone number (opaque and transparent zones counted separately) and $f$ is the focal length in first order. The zone plate can be used as a thin lens to focus monochromatic incident radiation, or, due to the inverse relationship between focal length and wavelength, it can be used as a dispersive element. If used as a lens, the thin-lens formula applies:

$$
\begin{equation*}
1 / s+1 / s^{\prime}=1 / f, \tag{2}
\end{equation*}
$$

where $s$ and $s^{\prime}$ are object and image distances, respectively. Diffraction-limited resolution of the zone plate is given by

$$
\begin{equation*}
\Delta \cong 1.22 \delta r_{N} \cong 1.22 r_{N} / 2 \mathrm{~N} \tag{3}
\end{equation*}
$$

where $r_{N}$ is the radius of the zone plate, $N$ is the total number of zones, and $\delta r_{N}$ is the width of the outermost zone. In higher orders, the resolution improves in proportion to the order number.

The efficiency of the simple zone plate in first order is ideally $\pi^{-2}$, or about $10 \%$. The remainder of the radiation is absorbed ( $50 \%$ ) or diffracted in other orders-zero order ( $25 \%$ ), negative orders ( $12.5 \%$ ), and higher positive orders (2.5\%). If opaque zones are replaced by transparent but phase-shifting zones, efficiencies can be substantially improved. See, for example, R. Tatchyn, P. L. Csonka, and I. Lindau, "Outline of a Variational Formulation of Zone-Plate Theory," J. Opt. Soc. Am. B 1, 806 (1984).

## SECTION 6

## X-RAY DETECTORS

## Albert C. Thompson

A wide variety of $x$-ray detectors are available, some providing only measurements of count rate or total flux, others measuring the energy, position, and/or incidence time of each $x$-ray [1]. In Table 6-1, typical values for useful energy range, energy resolution. dead time per event, and maximum count rate capability are given for common x-ray detectors. For special applications, these specifications can often be substantially improved.

Table 6-1. Properties of common x-ray detectors.

| Detector | Energy range (keV) | $\Delta E$ (FWHM)/E at 5.9 keV (\%) | Dead time/event ( $\mu \mathrm{s}$ ) | Maximum count rate ( $\mathrm{s}^{-1}$ ) |
| :---: | :---: | :---: | :---: | :---: |
| Geiger counter | 3-50 | none | 200 | $10^{4}$ |
| Gas ionization in current mode | 0.2-50 | n/a | n/a | $10^{1 / \mathrm{a}}$ |
| Gas proportiona! | -0.2-50 | 15 | 0.2 | $10^{5}$ |
| Multiwire proportional chamber | 3-50 | 20 | 0.2 | $\begin{aligned} & 10^{5} \text { /anode } \\ & \text { wire } \end{aligned}$ |
| Scintillation [ $\mathrm{Nal}(\mathrm{T})$ )] | 3-10,000 | 40 | 0.25 | $10^{6}$ |
| $\begin{aligned} & \text { Semiconductor } \\ & \text { [Si(Li)] } \end{aligned}$ | 1-60 | 3 | 4-30 | $5 \times 10^{4}$ |
| Semiconductor (Ge) | 1-10,000 | 3. | 4-30 | $5 \times 10^{4}$ |

${ }^{\text {a }}$ Maximum count rate is limited by space-charge effects to around $10^{11}$ photons/s per $\mathrm{cm}^{3}$.

New instruments currently being developed using semiconductor technology will have substantially improved count rate capabilities, position resolutions, and/or energy resolutions, and will, therefore, be especially useful with the intense x-ray sources that are becoming available at synchrotron facilities.

## A. GAS IONIZATION DETECTORS

One of the simplest $x$-ray detectors is the gas ionization chamber. Such detectors are commonly used with a low-noise current amplifier to measure $x$-ray flux rather than to count individual photons. A common detector geometry consists of a rectangular gas-tight container with thin entrance and exit windows and a flowing gas supply. Inside the detector are two parallel plates across which a potential is applied to produce an electric field of about $100 \mathrm{~V} / \mathrm{cm}$. X-rays are photoelectrically absorbed to produce fast photoelectrons and either Auger electrons or fluorescence photons. The energetic electrons produce additional electron-ion pairs by inelastic collisions, and the photons either escape or are photoelectrically absorbed. The voltage applied across the chamber sweeps the electrons and ions apart, and they are collected at the plates.

The average energy required to produce an electron-ion pair in several common gases is given in Table 6-2. The number of $x$-rays stopping in the detector can be calculated from the active volume of the chamber, the gas pressure, and the x -ray absorption cross sections for the gas used. Figure 6-1 shows, for differeni gases at normal pressure, the efficiency of a $15-\mathrm{cm}$-long ion chamber as a function of energy.

Table 6-2. Average energy required to produce an electron-hole pair in several gases.

| Element | Energy (eV) |
| :--- | :---: |
| Helium | 27.8 |
| Neon | 27.4 |
| Argon | 24.4 |
| Krypton | 22.8 |
| Xenon | 20.8 |



Fig. 6-1. Efficiency of a $15-\mathrm{cm}$-iong gas ionization chamber as a function of energy, for different gases at normal pressure.

## B. GAS PROPORTIONAL COUNTERS

Gas proportional detectors comprise a small-diameter anode wire in an enclosed cylindrical gas volume. A high voltage is applied, so that the field around the wire is above $25 \mathrm{kV} / \mathrm{cm}$. These detectors are usually used to count single photon events - -

If operated in an avalanche mode, such detectors are called Geiger counters and give very large pulses for each stopping $x$-ray. In this mode, they are filled with a noble gas to which a small amount of halogen is added to quench the gas after each pulse. A major limitation of this mode of operation is the . large dead time (about $200 \mu \mathrm{~s}$ ) for each event.

The normal mode of operation of gas proportional counters is at a lower voltage, so that the detector gain is linear. In this mode, the output is coupled to a low-noise preamplifier to give usable pulses. The pulse height resolution of the detector (about $20 \%$ at 6 keV ) can be used for some energy discrimination, and the output counting rate can be as high as $10^{6}$ counts per second.

## C. MULTIWIRE PROPORTIONAL CHAMBERS

Multiwire proportional chambers are widely used as positionsensitive detectors of both photons and charged particles [2-4]. They use a grid of fine wires spaced about 2 mm apart as the anode plane in a gas proportional chamber. Many different read-out techniques are used to measure the event positions $[5,6]$; four examples are amplifier per wire, analog charge division, time digitization using a delay line, and drift-time systems. The spatial resolution from the anode plane is usually the anode wire spacing (typically $1-5 \mathrm{~mm}$ ). Twodimensional read-out can be achieved if the cathode plane is also segmented and read out. A spatial resolution of around $80 \mu \mathrm{~m}$ can be achieved for the cathode read-out plane.

## D. SCINTILLATION DETECTORS

Scintillation detectors use either a photomultiplier tube or a photodiode to detect the optical photons produced in special materials when an x-ray is stopped. The scintillator material can be either organic scintillators, single crystals of thalliumactivated sodium iodide [commonly referred to as $\mathrm{NaI}(\mathrm{T})$ ), or single crystals of bismuth germanate (BGO). Since the light output is low (about $200-300 \mathrm{eV}$ is required for each optical
photon), the energy resolution is low. Organic scintillators have very poor energy resolution, whereas the $\mathrm{Nal}(\mathrm{Tl})$ and BGO crystals have an energy resolution of about $40 \%$ a1 10 keV . These detectors are often used for measuring the stopping time of $x$-rays. They can have a time resolution of better than 1 ns and a count rate capability up to $10^{5}$ photons per second.

Gas scintillation detectors combine the operation of a gas ionization chamber and a photon detector to give improved performance [7]. Electrons generated from photon or charged-particle interactions in a gas (usually pure xenon or argon with $1 \%$ xenon) are accelerated in a high-field ( -3 $\mathrm{kV} / \mathrm{cm}$ ) region, where they produce UV scintillation light. This light is usually wave-shifted and then detected by a photomultiplier. These detectors have an energy resolution about two to three times better than a conventional proportional chamber:

## E. SEMICONDUCTOR DETECTORS

A semiconductor detector is basically a very large, reverse biased $n^{+}-i-p^{+}$diode. When the diode is reverse biased, an intrinsic region with an electric field across it is created. When an incident photon interacts in this region, tracks of electronhole pairs are produced. In the presence of the electric field, these pairs separate and rapidly drift to the detector contacts. The average energy required to generate an electron-hole pair at 77 K is 3.6 eV for silicon and 2.98 eV for germanium. To keep the leakage current low, the detector must be of very high purity. To fabricate silicon detectors, lithium is generally drifted through the device at elevated temperature with a field on. The lithium compensates the p-type impurities in the device to give a large active region in the detector with intrinsic conductivity. Germanium crystals do not now require lithium drifting, because they can be directly purified by zone refining to the required purity ( $<10^{10}$ electrically active impurities $/ \mathrm{cm}^{3}$ ). These detectors are usually cooled to liquid nitrogen temperature ( 77 K ) 10 reduce the thermal leakage current. They are usually used in a single-photon-counting mode to exploit their excellent energy resolution (typically 175 eV at 5.9 keV ). The count rate capability is limited to less than $5 \times 10^{4}$ per second.

Lithium-drifted silicon and planar germanium detectors are
widely used for energy-dispersive analysis. 'The efficiency of 3- and 5 -mm-thick $\mathrm{Si}(\mathrm{Li})$ and 5 -mm-thick germanium detectors, as a function of energy, is illustrated in Fig. 6-2. $\mathrm{Si}(\mathrm{Li})$ detectors are often used to measure nondestructively the elemental composition of samples. Germanium detectors are generally not used below 20 keV because of the interference from peaks due to the escape of the germanium $K$ fluorescence photon. Large germanium detectors are widely used for $\gamma$-ray spectroscopy.

## F. OTHER X-RAY DETECTORS

Many instruments (especially spectrographs) use photographic film as the detector. Film is an excellent detector in experiments requiring a total-flux detecior with high spatial resolution. The major limitation of film is the need for processing. If carefully calibrated with a microdensitometer, film can be used for quantitative analysis of x-ray intensity. To enhance the detection efficiency of film, a fluorescent screen is often placed next to it. Special films are available to give improved efficiency, contrast, or resolution: for initial alignment of instruments, Polaroid film is often used.

A variety of imaging systems can be used to image $x$-rays electronically [8]. For medical imaging, an image conventer is widely used to provide real-time imaging. These detectors use a cesium iodide scintillator with a photocathode screen deposited on it to produce electrons from incident $x$-rays. The electrons are then accelerated and imaged onto a phosphor screen, which is viewed, in turn, by a video camera. Linear photodiode arrays and CCD detectors are available to give excellent position information with fast read-out. Large, onedimensional photodiode arrays coupled to a scintillator are also used for x -ray detectors. Two-dimensional x-ray CCD detectors are becoming available with $512 \times 512$ pixels; each pixel measuring $13 \mu \mathrm{~m} \times 13 \mu \mathrm{~m}$. These detectors are' currently undergoing rapid development and will find many applications both for detecting low-energy $x$-rays directly and for use with x-ray image intensifiers.

For high-speed imaging of plasmas and other intense x-ray sources, $x$-ray streak cameras have also been developed [9]:


Fig. 6-2. Detection efficiency as a function of energy for semiconductor crostals. The thickness of the detector crystal limits the detection of high-energy photons; absorption by air, beryllium windows, and the dead layer of silicon crystals limits efficiency at low energies.

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## SECTION 7

## SYNCHROTRON RADIATION FACILITIES

## Herman Winick

Table 7-1 lists storage ring synchrotron radiation facilities now in operation or under construction, together with typical electron beam energies and characteristic photon energies. The characteristic energy is defined as

$$
\epsilon_{c}[\mathrm{keV}]=2.218 E^{3} / R=0.665 B E^{2}
$$

where $E$ is $i_{1} \mathrm{GeV}, R$ (the bending radius) is in meters, and $B$ is in tesla. Additional information has recently been compiled in Refs. 1 and 2. Following the table, names and addresses are given for the current directors of these and other facilities.

## REFERENCES

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Table 7-1. Storage rings used as synchrotron radiation sources. $E$ is the typical electron beam energy and $\epsilon_{c}$ is the characteristic photon energy of bending-magnet radiation.

| Location | Ring (lab) | $E(\mathrm{GeV})$ | $\mathrm{E}_{\mathrm{c}}(\mathrm{keV})$ | Notes ${ }^{\text {a }}$ |
| :---: | :---: | :---: | :---: | :---: |
| China |  |  |  |  |
| Beijing | BEPC (IHEP) | 2.2-2.8 | 3.8 (2.6 GeV) | C, Par |
| Hefe: | HESYRL (USTC) | 0.8 | 0.43 | C. Ded |
| England |  |  |  |  |
| Daresbury | SRS | 2.0 | 3.2 | O. Ded |
| France |  |  |  |  |
| Orsay | ACO (LURE) | 0.54 | 0.33 | O. Ded |
|  | DCI (LURE) | 1.8 | 3.4 | O. PDed |
|  | Superaco (LURE) | 0.8 | 0.62 | C. Ded |
| Germany |  |  |  |  |
| Hamburg | DORIS (DESY) | 5.0 | 23 | O. PDed |
| W. Berlin | BESSY | 0.8 | 0.63 | O. Ded |
|  | Cosy | 0.56 | . | C, Ded |
| Haly |  |  |  |  |
| Frascati | ADONE | 1.5 | 1.5 | O. PDed |
| Japan |  |  |  |  |
| Tsukuba | Photon Factory (KEK) | 2.5 | 4.1 | O. Ded |
|  | Accumulator (KEK) | 6-8 | $33(7 \mathrm{GeV})$ | O. PDed |
|  | TRISTAN (KEK) | 30 | 243 | C. Par |
|  | TERAS (ETL) | 0.66 | 0.24 | O. Ded |
| Tokyo | SOR (1SSP) | 0.4 | 0.13 | O, Ded |
| Okasaki | UVSOR (IMS) | 0.6 | 0.22 | O, Ded |
| Sweden |  |  |  |  |
| Lund | Max (LTH) | 0.56 | 0.30 | C. Ded |
| Taiwan |  |  |  |  |
| Hsinchu | TSL (SRRC) | 1.0 | - | C. Ded |
| USA |  |  |  |  |
| Gaithersburg, MD | SURF (NBS) | 0.284 | 0.06 | O, Ded |
| Ithata, NY | CESR (CHESS) | 5.5 | 11.5 | O. Par |
| Stanford. CA | SPEAR (SSRL) | 3-4 | $4.7(3 \mathrm{GcV})$ | O. PDed |
|  | SXRL (SSRL) | 1.0 | - | C. PDed |
|  | PEP (SSRL) | 15.0 | - . | C. Par |
| Stoughton, WI | Tantalus (SRC) | 0.24 | 0.05 | O, Ded |
|  | Aladdin (SRC) | 1.0 | 1.07 | O, Ded |
| Upton, NY | NSLS I (BNL) | 0.75. | 0.50 | O. Ded |
|  | NSLS II (BNL) | 2.5 | 5.0 | O. Ded |
| USSR |  |  |  |  |
| Karkhov , | ' N-100 (KPl) | 0.10 | 0.04 | O, Ded |
| Moscow (Kurchatov) | Plamia I | 0.45 | 0.20 | C. Ded |
| Novosibirsk $\quad \therefore$ | VEPP-2M (1NP) | 0.67 | 0.54 | O. PDed |
|  | VEPP. 3 (INP) | 2.2 | 4.3 | o. PDed |
|  | VEPP-4 (INP) | 7 | 46 | O. Par |

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## SECTION 8

## MISCELLANEOUS

### 8.1 PROBABILITY AND STATISTICS

## A. PROBABILITY DISTRIBUTIONS AND CONFIDENCE LEVELS

We give here properties of three commonly used probability distributions: normal (or Gaussian), chi-squared ( $\chi^{2}$ ), and Poisson. We warn the reader that there is no universal convention for the term "confidence level"; thus, explicit definitions that correspond to common usage are given for each distribution. It is explained below how confidence levels for all three distributions may be extracted from Fig. 8-1.

## A. 1 Normal distribution

The normal distribution with mean $\bar{x}$ and standard deviation $\sigma$ (variance $\sigma^{2}$ ) is

$$
\begin{equation*}
P(x) d x=\frac{1}{\sigma \sqrt{2 \pi}} e^{-(x-\bar{x})^{2} / 2 \sigma^{2}} d x \tag{1}
\end{equation*}
$$

The confidence level associated with an observed deviation $\delta$ from the mean is the probability that $|x-\bar{x}|>\delta$, i.e.,

$$
\mathrm{CL}=2 \int_{\bar{x}+\delta}^{\infty} d x P(x),
$$



Fig. 8-1. Confidence level as a function of $\chi^{2}$ for several values of $n_{D}$, the number of degrees of freedom.
since the distribution is symmetric about $\bar{x}$. The small figure in Eq. (2) is drawn with $\delta=2 \boldsymbol{\sigma}$. CL is given by the ordinate of the $n_{D}{ }^{\circ}=1$ curve in Fig. 8-1 at $\chi^{2}=(\delta / \sigma)^{2}$. The confidence level for $\delta=\mathrm{l} \sigma$ is $31.7 \% ; 2 \sigma, 4.6 \% ; 3 \sigma, 0.3 \%$. The odds against exceeding $\delta,(1-\mathrm{CL}) / \mathrm{CL}$, for $\delta=1 \sigma$ are $2.15: 1 ; 2 \sigma$, 21:1; 3 $\sigma, 370: 1 ; 4 \sigma, 16,000 ; 1 ; 5 \sigma, 1,700,000: 1$. Relations between $\sigma$ and other measures of the width:' probable error ( $\mathrm{CL}=0.5$ ) $=0.67 \sigma$; mean absolute deviation $=0.80 \sigma$; RMS deviation $=\sigma$; half width at half maximum $=1.18 \sigma$.
A. $2 x^{2}$ distribution

The $\chi^{2}$ distribution for $n_{D}$ degrees of freedom is

$$
\begin{align*}
& P_{n_{D}}\left(\chi^{2}\right) d \chi^{2} \\
& \quad=\frac{1}{2^{h} \Gamma(h)}\left(\chi^{2}\right)^{h-1} e^{-\chi^{2} / 2} d \chi^{2} \quad\left(\chi^{2} \geqslant 0\right) \tag{3}
\end{align*}
$$

where $h$ (for "half") $=n_{D} / 2$. The mean and variance are $n_{D}$ and $2 n_{D}$ respectively. In evaluating Eq. (3) one may use Stirling's approximation:

$$
\Gamma(h) \cong 2.507 e^{-h} h^{(h-1 / 2)}(1+0.0833 / h)
$$

which is accurate to $\pm 0.1 \%$ for all $h \geqslant 1 / 2$. The confidence level associated with a given value of $n_{D}$ and an observed value of $\chi_{0}^{2}$ is the probability of the $\chi^{2}$ exceeding the observed value, i.e.,

$$
\mathrm{CL}=\int_{x_{0}^{2}}^{\infty} d \chi^{2} P_{n_{D}}\left(\chi^{2}\right) \underbrace{1-\mathrm{CL}}_{0}
$$

The small figure in Eq. (4) is drawn with $n_{D_{1}}=5$ and $\mathrm{CL}=10 \%$. CL is plotted as a function of $\chi^{2}$ for several values of $n_{D}$ in Fig. 8-1. For large $n_{D}, \chi^{2}$ becomes normally distributed about $n_{D}$. Thus,

$$
\begin{equation*}
y_{1}=\left(\chi^{2}-n_{D}\right) / \sqrt{2 n_{D}} \tag{5}
\end{equation*}
$$

becomes normally distributed with unit standard deviation and mean zero. A better approximation is that $\chi$, not $\chi^{2}$, becomes normally distributed; specifically,

$$
\begin{equation*}
y_{2}=\sqrt{2 \chi^{2}}-\sqrt{2 n_{D}-1} . \tag{6}
\end{equation*}
$$

approaches normality with unit standard deviation and mean zero. For small CLs in particular, $y_{2}$ is much more accurate than $y_{1}$. Thus, for $n_{D}=50$ and $\chi^{2}=80$, the true $\mathrm{CL}=0.45 \%$, but $y_{1}$ is 3.0 , corresponding to a CL of $0.13 \%$, while $y_{2}$ is 2.7 , corresponding to a CL of $0.35 \%$.

## A. 3 Poisson distribution

The Poisson distribution with mean $\bar{n}$ is

$$
\begin{equation*}
P_{\bar{n}}(n)=\frac{e^{-\bar{n}} \bar{n}^{n}}{n!}(n=0,1,2, \cdots) \tag{7}
\end{equation*}
$$

The variance is equal to the mean. Confidence levels for Poisson distributions are usually defined in terms of quantities called "upper limits" as follows: The confidence level associated with a given upper limit $N$ and an observed value $n_{0}$ of $n$ is the probability that $n>n_{0}$ if $\bar{n}=N$, i.e.,


The small figure in Eq. (8) is drawn with $n_{0}=2$ and $\mathrm{CL}=$ $90 \%$. A useful relation between Poisson and $\chi^{2}$ confidence levels allows one to look up this quantity in Fig. 8-1. Specifically, the quantity $1-\mathrm{CL}$ is given by the ordinate of the $n_{D}=2\left(n_{0}+1\right)$ curve at $\chi^{2}=2 N$. Thus, $90 \%$ confidence level upper limits for $n_{0}=0,1$, and 2 are given by half the $\chi^{2}$ value corresponding to an ordinate of 0.1 on the $n_{D}=2,4$, and 6 curves, respectively; the values are $N=2.3,3.9$, and 5.3.

Tables of confidence levels for all three of these distributions, the relation between Poisson and $\chi^{2}$ confidence levels, and numerous other useful tables and relations may be found in Ref. 1.

## B. STATISTICS

Suppose one is presented with $N$ independent data, $y_{n} \pm \sigma_{n}$, and it is desired to make some inference about the "true" value of the quantity. represented by these data. For this purpose we interpret each datum $y_{n}$ as a single sample point drawn randomly (and independently of the other data) from a distribution having true mean $\bar{y}_{n}$ (which we wish to estimate) and variance $\sigma_{n}^{2}$. We do not require that they be normally distributed. (Identification of the true $\sigma_{n}$ with the $\sigma_{n}$ datum is oflen an approximation which may become seriously inaccurate when $\sigma_{n}$ is an appreciable fraction of $y_{n}$.) Some commonly used methods of estimation are given below; see Ref. 2
for numerous applications. Section B. 1 deals with the case in which all $\bar{y}_{n}$ are the same, e.g., several different measurements of the same quantity; Sec. B. 2 deals with the case in which $\bar{y}_{n}=\bar{y}\left(x_{n}\right)$, where $x_{n}$ represents some set of independent variables.

## B. 1 Single mean and variance estimates

(1) If the $y_{n}$ represent a set of values all supposedly drawn from a single distribution with mean $\bar{y}$ and variance $\sigma^{2}$ (i.e., the $\sigma_{n}$ are all the same, but their common value is unknown), then

$$
\begin{equation*}
\hat{y}=\frac{1}{N} \sum_{n=1}^{N} y_{n} \tag{9}
\end{equation*}
$$

and

$$
\begin{align*}
\hat{\sigma}^{2} & =\frac{1}{N-1} \sum_{n=1}^{N}\left(y_{n}-\hat{y}\right)^{2} \\
& =\frac{N}{N-1}\left[\left\langle\left(y^{2}\right)\right\rangle-(\hat{y})^{2}\right] \tag{10}
\end{align*}
$$

are unbiased estimates of $\bar{y}$ and $\sigma^{2}$; the angular brackets denote an average over the data. The variance of $\hat{y}$ is $\sigma^{2} / N$. If the parent distribution is normal and $N$ is large, the variance of $\hat{\sigma}^{2}$ is $2 \sigma^{4} / N$.
(2) If the $y_{n}$ are independent estimates of the same $\bar{y}$, and the $\sigma_{n}$ are known, then the weighted average

$$
\begin{equation*}
\hat{y}=\frac{1}{w} \sum_{n} w_{n} y_{n} \tag{11}
\end{equation*}
$$

where $w_{n}=1 / \sigma_{n}^{2}$ and $w=\Sigma w_{n}$, is an appropriate unbiased estimate of $\bar{y}$. This choice of weighting factors in Eq. (11) minimizes the variance of the estimate; the variance is $1 / \mathrm{w}$.

## B. 2 Linear least-squares fit

We wish to determine the best fit of independent unbiased data $y_{n} \pm \sigma_{n}$, measured at points $x_{n}$, to the form $y(x)=$ $\Sigma a_{i} f_{i}(x)$, where the $f_{i}$ are known, linearly independent functions (e.g., Legendre polynomials), one-to-one over the allowed range of $x$. The estimates for the linear coefficients $a_{i}$ which minimize the sum of the squared deviations are

8-6

$$
\begin{equation*}
\hat{a}_{i}=\sum_{j, n} V_{i j} f_{j}\left(x_{n}\right) y_{n} / \sigma_{n}^{2} \tag{12}
\end{equation*}
$$

Here $V$ is the covariance matrix of the fitted parameters

$$
\begin{equation*}
V_{i j}=\overline{\left(\hat{a}_{i}-\bar{a}_{i}\right)\left(\hat{a}_{j}-\bar{a}_{j}\right)}, \tag{13}
\end{equation*}
$$

where the overbar denotes the unknown true value; $V$ is estimated by

$$
\begin{equation*}
\left(V^{-1}\right)_{i j}=\sum_{n} f_{i}\left(x_{n}\right) f_{j}\left(x_{n}\right) / \dot{\sigma}_{n}^{2} \tag{14}
\end{equation*}
$$

The estimated variance of an interpolated or extrapolated value of $y$ at point $x, \hat{y}=\Sigma \hat{a}_{i} f_{i}(x)$, is

$$
\begin{equation*}
\left.(\hat{y}-\bar{y})^{2}\right|_{\text {est }}=\sum_{i j} V_{i j} f_{i}(x) f_{j}(x) \tag{15}
\end{equation*}
$$

For the case of a straight line fit, $y(x)=a+b x$, one obtains the following estimates of $a$ and $b$ :

$$
\begin{align*}
& \hat{a}=\left(S_{y} S_{x x}-S_{x} S_{x y}\right) / D  \tag{16}\\
& \hat{b}=\left(S_{1} S_{x y}-S_{x} S_{y}\right) / D
\end{align*}
$$

where

$$
\begin{align*}
& S_{1}, S_{x}^{\prime}, S_{y}^{\prime}, S_{x x}, S_{x y} \\
& \quad=\Sigma\left(1, x_{n}, y_{n}, x_{n}^{2}, x_{n} y_{n}\right) / \sigma_{n}^{2} \tag{17}
\end{align*}
$$

respectively, and

$$
D=\dot{S}_{1} S_{x x}-\dot{S}_{x}^{2}
$$

The covariance matrix of the fitted parameters is:

$$
\left(\begin{array}{cc}
V_{a a} & V_{a b .}  \tag{18}\\
V_{a b} & V_{b b}
\end{array}\right)=\frac{1}{D}\left(\begin{array}{cc}
S_{x x} & -S_{x} \\
-S_{x} & S_{1}
\end{array}\right)
$$

The estimated variance of an interpolated or extrapolated value of $y$ at point $x$ is

$$
\begin{equation*}
\left.(\hat{v}-\bar{y})^{2}\right|_{\mathrm{est}}=\frac{1}{S_{1}}+\frac{S_{1}}{D}\left(x-\frac{S_{x}}{S_{1}}\right)^{2} \tag{19}
\end{equation*}
$$

A least-squares fit gives estimates for the $a_{i}$ [Eq. (12)] with the smallest variance, under the conditions that the expansion of $y$ in terms of $a_{i} f_{i}$ is the correct model and that the $y_{n}$ are independent, unbiased measurements whose variances $\sigma_{n}^{2}$ are known.

## C. ERROR PROPAGATION

Suppose one wishes to calculate the value and error of a function of some other quantities with errors, e.g., in a Monte Carlo program. Let $\{y\}$ be a set of random variables with means $\{\bar{y}\}$ and covariance matrix $V$. Then the mean and variance of a function of these variables are approximately (to second order in $\{y-\bar{y}\}$ )

$$
\begin{equation*}
\bar{f} \simeq f(\{\bar{y}\})+\frac{1}{2} \sum_{m n} V_{m n}\left(\frac{\partial^{2} f}{\partial y_{m} \partial y_{n}}\right)_{\{y\}=\{\bar{y}\}} \tag{20}
\end{equation*}
$$

and

$$
\begin{align*}
& \overline{(f-\bar{f})^{2}} \\
& \cong \sum_{m n} V_{m n}\left(\frac{\partial f}{\partial y_{m}}\right)_{\{y\}=\{\bar{y}\}}\left(\frac{\partial f}{\partial y_{n}}\right)_{\{y\}=\{\bar{y}\}} . \tag{21}
\end{align*}
$$

E.g., the mean and variance of a function of a single variable with mean $\bar{y}$ and variance $\sigma^{2}$ are

$$
\begin{equation*}
\bar{f} \cong f(\bar{v})+\frac{1}{2} \sigma^{2} f^{\prime \prime}(\bar{y}) \tag{22}
\end{equation*}
$$

and

$$
\begin{equation*}
\overline{(f-\bar{f})^{2}} \cong \sigma^{2} f^{\prime}(\bar{y})^{2} \tag{23}
\end{equation*}
$$

Note that these equations will usually be applied by substituting measured quantities, $\{\tilde{y}\}$ say, for the true means, $\{\bar{y}\}$. If, as is often the case, $\bar{y}_{n}-\bar{y}_{n}$ is of order $\sqrt{V_{n n}}$, then the second-order terms in Eqs. (20) and (22) may be small compared with the first-order errors introduced by the substitution.

## REFERENCES

1. M. Abramowitz and I. Stegun, Eds., Handbook of

- -Mathematical Functions (Dover, New York, 1972).

2. W. T. Eadie, D. Drijard, F. E. James, M. Roos, and B. Sadoulet, Statistical Methods in Experimental Physics (North Holland, Amsterdam and London, 1971); S. L. Meyer, Data Analysis for Scientists and Engineers (John . Wiley and Sons, Inc., New York, 1975); A. G. Frodesen, O. Skjeggestad, and H. Tøfte, Probability and Statistics in Particle Physics (Universitetsforlaget, Oslo, Norway, 1979).

This section was adapted, with permission, from the April 1984 edition of the Particle Properties Data Booklet.

### 8.2 ELECTROMAGNETIC RELATIONS

| Quantity | Gaussian CGS | MKSA |
| :---: | :---: | :---: |
| Units and conversions: |  |  |
| Charge: | $2.99792 \times 10^{9}$ esu | $=1$ coul - 1 amp-sec |
| Potential: | $\begin{aligned} & (1 / 299.792) \text { statvolt } \\ & =(1 / 299.792) \text { erg/esu } \end{aligned}$ | $=1$ volt - 1 joule/coul |
| Magnetic field: Electron charge: | $\begin{aligned} & 10^{4} \text { gauss }=10^{4} \text { dyne/esu } \\ & e=4.803242 \times 10^{-10} \text { esu } \end{aligned}$ | $\begin{aligned} & =1 \text { tesla }=1 \mathrm{nt} / a m p-m \\ & =1.6021892 \times 10^{-19} \text { coul } \end{aligned}$ |
| Lorents. force: | $F=q\left(\mathbf{F}+\frac{\mathrm{v}}{c} \times \mathbf{B}\right)$ | $F=q(E+v \times \mathbf{B})$ |
| Maxwell equations: | $\begin{aligned} & \nabla \cdot \mathrm{D}=4 \pi \rho \\ & \nabla \times \mathrm{E}=-\frac{1}{c} \frac{\partial \mathrm{~B}}{\partial t} \\ & \nabla \cdot \mathbf{B}=0 \\ & \nabla \times \mathbf{H}=\frac{4 \pi \mathrm{j}}{c}+\frac{1}{c} \frac{\partial \mathrm{D}}{\partial t} \end{aligned}$ | $\begin{aligned} & \nabla \cdot \mathrm{D}=\rho \\ & \nabla \times \mathbf{E}=-\frac{\partial \mathbf{B}}{\partial t} \\ & \nabla \cdot \mathrm{~B}=0 \\ & \nabla \times \mathrm{H}=\mathrm{j}+\frac{\partial \mathrm{D}}{\partial t} \end{aligned}$ |
| Materials: | $\mathbf{D}=\boldsymbol{\epsilon E}, \mathbf{B}=\mu \mathbf{H}$ | $\mathbf{D}=\boldsymbol{\epsilon E , ~} \mathbf{B}=\mu \mathbf{H}$ |
| Dielectric constant: | $\epsilon_{\text {vac }}=1$ | $\epsilon_{\text {vac }}=\epsilon^{\prime}$ |
| Magnetic susceptibility: | $\mu_{\mathrm{vac}}=1$ | $\mu_{\mathrm{vac}}=\mu_{0}$ |
| Fields: | $\begin{aligned} & \mathbf{E}=-\nabla V-\frac{1}{c} \frac{\partial \mathbf{A}}{\partial t} \\ & \mathbf{B}=\nabla \times \mathbf{A} \end{aligned}$ | $\begin{aligned} & \mathbf{E}=-\nabla V-\frac{\partial \mathbf{A}}{\partial t} \\ & \mathbf{B}=\nabla \times \mathbf{A} \end{aligned}$ |
| Static potentials: (coulomb gauge) | $\begin{aligned} & V=\sum_{\text {charges }} \frac{g}{r} \\ & A=\frac{1}{c} \sum_{\text {currents }} \frac{I}{r} \end{aligned}$ | $\begin{aligned} & V=\frac{1}{4 \pi \epsilon_{0}} \sum_{\text {charges }} \frac{g}{r} \\ & \mathrm{~A}=\frac{\mu_{0}}{4 \pi} \sum_{\text {cursents }} \frac{\mathrm{I}}{r} \end{aligned}$ |
| Relativistic Imanformations: ( $v$ is the velocity of arimed system as seen in unprimed system) | $\begin{aligned} & \mathbf{E}_{1}^{\prime}=\mathbf{E}_{1} \\ & \mathbf{E}_{\perp}^{\prime}=\gamma\left(E_{\perp}+\frac{1}{c} v \times B^{\prime}\right) \\ & \mathbf{B}_{1}^{\prime}=\mathbf{B}_{1} \\ & \mathbf{B}_{\perp}^{\prime}=\gamma\left(\mathbf{B}_{\perp}-\frac{1}{c} v \times \mathbf{E}^{\prime}\right) \end{aligned}$ | $\begin{aligned} & \mathbf{E}_{\mathbf{\prime}}^{\prime}=\mathbf{E}_{*} \\ & \mathbf{E}_{\perp}^{\prime}=\gamma\left(\mathbf{E}_{\perp}+v \times \mathbf{B}\right) \\ & \mathbf{B}_{1}^{\prime}=\mathbf{B}_{1} \\ & \mathbf{B}_{\perp}^{\prime}=\gamma\left(\mathbf{B}_{\perp}-\frac{1}{c^{2}} v \times \mathbf{E}\right) \end{aligned}$ |
|  | $\begin{aligned} & 4 \pi \epsilon_{0}=\frac{1}{c^{2}} 10^{7} \frac{\operatorname{coul} 1^{2}}{n t s^{2}}= \\ & \frac{\mu_{0}}{4 \pi}=10^{-7} \frac{n t s^{2}}{\operatorname{cou} l^{2}}: c= \end{aligned}$ | $\begin{aligned} & \frac{1}{18755} \times 10^{-9} \frac{\text { coul }^{2}}{n t m^{2}} \\ & .99792458 \times 10^{8} \mathrm{~m} \mathrm{~s}^{-1} \end{aligned}$ |

## Impedances (MKSA)

$\rho=$ resistivity in $10^{-8} \Omega \mathrm{~m}$ :
$\longrightarrow \sim 1: 7$ for $\mathrm{Cu} \quad \sim 5.5$ for W
$\sim 2.4$ for $\mathrm{Au} \quad \sim 73$ for SS 304
$\sim 2.8$ for Al
$\sim 100$ for Nichrome
(Al alloys may have double this value.)

For alternating currents, instantaneous current $I$, voltage $V$, angular frequency $\omega$ :

$$
V=V_{0} e^{i \omega t}=Z I
$$

Impedance of self-inductance $L: Z=i \omega L$
Impedance of capacitance $C: \dot{Z}=1 / i \omega C$. .
Impedance of free space: $Z=\sqrt{\mu_{0} / \epsilon_{0}}=376.7 \Omega$.
Impedance per unit length of a flat conductor of width $\boldsymbol{w}$ (high frequency, $\nu$ ):

$$
\begin{aligned}
& Z=\frac{(1+i) \rho}{w \delta}, \text { where } \delta=\text { effective skin depth } \\
& \delta=\sqrt{\frac{\rho}{\pi \nu \mu}} \cong \frac{6.6 \mathrm{~cm}}{\sqrt{\nu\left[\sec ^{-1}\right]}} \text { for } \mathrm{Cu}
\end{aligned}
$$

Capacitance $\hat{C}$ and inductance $\hat{L}$ per unit length (MKSA)
Flat rectangular plates of width $w$, separated by $d \ll w$;

$$
\begin{aligned}
& \hat{C}=\epsilon \frac{w}{d} ; \hat{L}=\mu \frac{d}{w} \\
& \frac{\epsilon}{\epsilon_{0}}=2 \text { to } 6 \text { for plastics; } 4 \text { to } 8 \text { for porcelain, glasses. }
\end{aligned}
$$

Coaxial cable of inner radius $r_{1}$, outer radius $r_{2}$ :

$$
\hat{C}=\frac{2 \pi \epsilon}{\ln \left(r_{2} / r_{1}\right)} ; \hat{L}=\frac{\mu}{2 \pi} \ln \left(r_{2} / r_{1}\right) .
$$

Transmission lines (no loss):

$$
\text { Impedance: } Z=\sqrt{\hat{L} / \bar{C}}
$$

$$
\text { Velocity: } v=1 / \sqrt{\hat{L} \hat{C}}=1 / \sqrt{\mu \epsilon} .
$$

Motion of charged particles in a uniform, static, magnetic field
The path of motion of a charged particle of momentum $p$ is a helix of constant radius $R$ and constant pitch angle $\lambda$, with the axis of the helix along $B$ :

$$
p[\mathrm{GeV} / c \mid \cos \lambda=0.29979 q B[\text { tesla }] R[\mathrm{~m}],
$$

where the charge $q$ is in units of the electronic charge. The angular velocity about the axis of the helix is

$$
\left.\omega \mid \mathrm{rad} \mathrm{~s}^{-1}\right]=8.98755 \times 10^{7} q B[\text { tesla }] / E|\mathrm{GeV}|
$$

where $E$ is the energy of the particle.
This section was adapted, with permission, from the April 1984 edition of the Particle Properties Data Booklet. See J. D. Jackson, Classical Electrodynamics, 2d ed. (John Wiley \& Sons, New York, 1975) for more formulas and details.

## -- 8.3 -RADIOACTIVITY - AND RADIATION PROTECTION

The International Commission on Radiation Units and Measurements (ICRU) recommends the use of SI units. Therefore, we list SI units first, followed by cgs (or other common) units in parentheses, where they differ.

Unit of activity = becquerel (curie):
$1 \mathrm{~Bq}=1$ disintegration $\left./ \mathrm{s} \mid=1 /\left(3.7 \times 10^{10}\right) \mathrm{Ci}\right]$.
Unit of exposure, the quantity of $x$ - or $\gamma$-radiation at a point in space integrated over time, in terms of charge of either sign produced by showering electrons in a small volume of air about the point:
$=1 \mathrm{coul} / \mathrm{kg}$ of air (roentgen; $1 \mathrm{R}=2.58 \times 10^{-4} \mathrm{coul} / \mathrm{kg}$
$=1 \mathrm{esu} / \mathrm{cm}^{3}=87.8 \mathrm{erg}$ released energy per g of air);
implicit in the definition is the assumption that the small test volume is embedded in a sufficiently large uniformly irradiated volume that the number of secondary electrons entering the volume equals the number leaving.
Unit of absorbed dose $=$ gray (rad):

$$
\begin{aligned}
1 \mathrm{~Gy} & =1 \mathrm{joule} / \mathrm{kg}\left(=10^{4} \mathrm{erg} / \mathrm{g}=10^{2} \mathrm{rad}\right) \\
& =6.24 \times 10^{12} \mathrm{MeV} / \mathrm{kg} \text { deposited energy } .
\end{aligned}
$$

Unit of dose equivalent (for biological damage) $=$ sievert
$\left[=10^{2}\right.$ rem (roentgen equivalent for man)]:
Dose equivalent in $S v=$ grays $\times Q$, where $Q$ (quality factor) expresses long-term risk (primarily cancer and leukemia) from low-level chronic exposure; it depends upon the type of radiation and other factors. For $\gamma$ rays and $\beta$ particles, $Q \cong 1$; for protons, $Q \cong 1$ at $\sim 10 \mathrm{MeV}$, rising gradually to $\cong 2$ at $\sim 1 \mathrm{GeV}$; for thermal neutrons, $Q$ $\cong 3$; for fast neutrons, $Q$ ranges up to 10 ; and for $\alpha$ particles and heavy ions (assuming internal deposition - skin and clothing are usually sufficient protection against external sources), $Q \cong 20$.
Natural annual background, all sources: Most world areas, whole-body dose equivalent rate $\simeq(0.4-4) \mathrm{mSv}(40-400$ millirems). Can range up to 50 mSv ( 5 rems ) in certain areas. U.S. average $\cong 0.8 \mathrm{mSv}$. The lungs receive an additional $\cong 0.1 \mathrm{mSv}$ ( $\cong 10 \mathrm{mrem}$ ) from inhaled natural radioactivity, mostly radon and radon daughters (good to $\cong$
factor of 2 in open areas; can range an order of magnitude higher in buildings and up to $1000 \times$ in poorly ventilated mines).
Cosmic ray background in counters (Earth's surface): $\sim 10^{4} / \mathrm{min} / \mathrm{m}^{2} / \mathrm{sr}$.
Fluxes ( $\mathrm{per} \mathrm{m}^{2}$ ) to deposit one Gy in one kg of matter, assuming uniform irradiation:
$\cong$ (charged particles) $6.24 \times 10^{12} /(d E / d x)$, where $d E / d x$ ( $\mathrm{MeV} \mathrm{m}^{2} / \mathrm{kg}$ ), the energy loss per unit length, may be obtained from range-energy data.
$\cong 3.5 \times 10^{13}$ minimum-ionizing singly charged particles in carbon.
$\approx$ (photons) $6.24 \times 10^{12} /\left[E[\mathrm{MeV}]\left(\mu_{\mathrm{en}} / \rho\right)\left[\mathrm{m}^{2} / \mathrm{kg}\right]\right\}$, for photons of energy $E$, mass energy absorption coefficient $\mu_{\mathrm{en}}$, and density $\rho$, for samples thick enough to contain the secondary electrons but $\ll 1 / \mu_{\text {en }}$.
$\cong 2 \times 10^{15}$ photons of 1 MeV energy on carbon. (Quoted fluxes good to about a factor of 2 for all materials.)
U.S. maximum permissible occupational dose for the whole body:
$50 \mathrm{mSv} /$ year ( $5 \mathrm{rem} / \mathrm{year}$ ).
Lethal dose: Whole-body dose from penetrating ionizing radiation resulting in $50 \%$ mortality in 30 days (assuming no medical treatment), 2.5-3.0 Gy ( $250-300 \mathrm{rads}$ ) as measured internally on body longitudinal center line; surface dose varies due to variable body attenuation and may be a strong function of energy.

For a recent review, see E. Pochin, Nuclear Radiation: Risks and Benefits (Clarendon Press, Oxford, 1983).

This section was adapted, with permission, from the April 1984 edition of the Particle Properties Data Booklet.

## .- 8.4 . PROPERTIES OF VACUUM SYSTEMS

## A. THROUGHPUT AND CONDUCTANCE

The throughput of any conducting element in a vacuum system is given by

$$
\begin{equation*}
q_{P V}=P V / t \tag{1}
\end{equation*}
$$

where $P$ is the pressure and $V$ is the volume of gas passed in time $t$. For a pump, if $P$ and $V$ are constant,

$$
\begin{equation*}
q_{P V}=P S \tag{2}
\end{equation*}
$$

where $S$ is the pumping speed at the intake pressure $P$. Throughput for a passive element can also be expressed as

$$
\begin{equation*}
q_{P V}=C \Delta P \tag{3}
\end{equation*}
$$

where $\Delta P$ is the difference between the pressures at the entrance and exit of the element and $C$ is the conductance. In high and ultrahigh vacuums, $C$ is effectively independent of pressure. By analogy to Ohm's law, conductance for parallel constructions is given by

$$
\begin{equation*}
C_{\mathrm{tot}}=C_{1}+C_{2}+\ldots \tag{4}
\end{equation*}
$$

and for series constructions by

$$
\begin{equation*}
1 / C_{\text {tot }}=1 / C_{1}+1 / C_{2}+ \tag{5}
\end{equation*}
$$

The effective pumping speed of a pump depends on both the nominal pumping speed and the conductance of connections between the pump and the volume to be evacuated:

$$
\begin{equation*}
1 / S_{\mathrm{eff}}=1 / S+1 / C_{101} \tag{6}
\end{equation*}
$$

In the regime of molecular flow (see Table 8-3, below), the conductance, for air (in $1 \cdot \mathrm{~s}^{-1}$ ). of an aperture of area $A$ (in $\mathrm{cm}^{2}$ ) is

$$
\begin{equation*}
C_{\mathrm{air}}=11.6 \mathrm{~A} \tag{7}
\end{equation*}
$$

For a long straight tube of uniform circular cross section having length $L$ and diameter $D$,

$$
\begin{equation*}
C_{\mathrm{air}}=12.1 D^{3} / L \tag{8}
\end{equation*}
$$

For short tubes, Eqs. (7) and (8) must be combined:

$$
\begin{equation*}
C_{\mathrm{air}}=\frac{1}{\frac{1}{11.6 A}+\frac{L}{12.1 . D^{3}}} \tag{9}
\end{equation*}
$$

The equivalent diameter of a tube that tapers from diameter $D_{1}$ to diameter $D_{2}$ is.

$$
\begin{equation*}
D_{e}=\left(\frac{2 D_{1}^{2} D_{2}^{2}}{D_{1}+D_{2}}\right)^{1 / 3} \tag{10}
\end{equation*}
$$

The equivalent length of an elbow is

$$
\begin{equation*}
L_{e}=L+1.33 \frac{\theta}{180} D, \tag{11}
\end{equation*}
$$

where $\theta$ is the angle of the elbow in degrees.

## B. GAS LOADS AND ULTIMATE PRESSURE

Sources of gas in a vacuum system include (a) the residual gas in the system; (b) the vapor in equilibrium with the materials present; and (c) the gases produced or introduced by leakage, outgassing, and permeation. In high-vacuum systems, the ultimate system pressure $P_{u}$ usually depends only on (c):

$$
\begin{equation*}
P_{u}=Q_{G} / S_{\mathrm{eff}}, \tag{12}
\end{equation*}
$$

where $Q_{G}$ is the gas load due, in this case, to leakage, outgassing, and permeation. Where $Q_{G}$ is constant, as in the case of a leak, $P_{u}$ is also constant; whereas, if $Q_{G}=f(t)$, as it is when outgassing dominates, $P_{u}$ is also a function of time. Reference 1 contains nomograms relating gas loads, ultimate pressures, and various physical system parameters. Table 8-1 gives outgassing rates for several vacuum materials. Extensive outgassing data can be found in Ref. 2.

By assuming that the process is dominated by residual gas, pumpdown in the high-vacuum region can be described by

$$
\begin{equation*}
P=P_{i} \exp \left[-\left(S_{\mathrm{eff}} / V_{\mathrm{tot}}\right) / t\right] \tag{13}
\end{equation*}
$$

where $P$ is the pressure after time $t, P_{i}$ is the pressure at $t=0$, and $V_{\text {tot }}$ is the total system volume.

Table 8-1. Approximate outgassing rate $K_{1}$ for several vacuum materials, after one hour in vacuum at room temperature.

| Material | $\text { (mbar } \cdot 1 \cdot \mathrm{~s}^{-1} \cdot \mathrm{~cm}^{-2} \text { ) }$ |
| :---: | :---: |
| Aluminum (fresh) | $9 \times 10^{-9}$ |
| Aluminum ( 20 h at $100^{\circ} \mathrm{C}$ ) | $5 \times 10^{-14}$ |
| Stainless steel (304) | $2 \times 10^{-8}$ |
| Stainless steel (304, electropolished) | $6 \times 10^{-9}$ |
| Stainless steel (304, mechanically polished) | $2 \times 10^{-9}$ |
| Stainless steel (304, electropolished, 30 h at $250^{\circ} \mathrm{C}$ ) | : $4 \times 10^{-12}$ |
| Perbunan | $5 \times 10^{-6}$ |
| Pyrex | $1 \times 10^{-8}$ |
| Teflon | $8 \times 10^{-8}$ |
| Viton A (fresh) | $2 \times 10^{-6}$ |

## C. MISCELLANEOUS VACUUM PROPERTIES

The mean free path $\lambda$ of a gas is inversely proportional to the pressure:

$$
\begin{equation*}
\lambda P=c^{*} \tag{14}
\end{equation*}
$$

where $c^{*}$ is a constant characteristic of a given gas. Values for several gases are given in Table 8-2.

For ultrahigh-vacuum systems, it is common to quote the monolayer time $\tau$, which is defined as the time required for a monomolecular layer to form on a gas-free surface, assuming. that every impinging gas molecule finds and binds to a vacant site. The monolayer time, in seconds, can be conveniently estimated from

$$
\begin{equation*}
\tau=3.2 \times 10^{-6} / P \tag{15}
\end{equation*}
$$

Table 8-2. Values for the product $c^{*}$ of the mean free path $\lambda$ and the pressure $P$ for several gases at $20^{\circ} \mathrm{C}$.

| Gas | $c^{*}(\mathbf{c m} \cdot \mathrm{mbar})$ |
| :--- | ---: |
| Hydrogen | $12.00 \times 10^{-3}$ |
| Helium | $18.00 \times 10^{-3}$ |
| Nitrogen | $6.10 \times 10^{-3}$ |
| Oxygen | $6.50 \times 10^{-3}$ |
| Argon | $6.40 \times 10^{-3}$ |
| Mercury | $3.05 \times 10^{-3}$ |
| Water | $3.95 \times 10^{-3}$ |
| Air | $6.67 \times 10^{-3}$ |

where $P$ is expressed in mbar.
Table 8-3 lists for several pressures rough values for $\lambda_{1} \tau$, the impingement rate $Z_{A}$ (the number of particles incident on a unit surface per unit time), and the volume collision rate $Z_{V}$ (the number of collisions in a unit volume per unit time).

## REFERENCES

1. A. Roth, Vacuum Technology; 2d ed. (North-Holland, Amsterdam, 1982), p. 142.
2. R. J. Elsey, "Outgassing of Vacuum Materials," Vacuum 25, 299, 347 (1975).

Table 8-3. Values for characteristic vacuum parameters at five representative pressures.


This report was done with support from the Department of Energy. Any conclusions or opinions expressed in this report represent solely those of the author(s) and not necessarily those of The Regents of the University of California, the Lawrence Berkeley La' boratory or the Department of Energy.

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[^0]:    ${ }^{\mathrm{a}} \mathrm{O}=$ Operational. C - Under construction. $\mathrm{D}=$ Dedicated, PDed - Partly dedicated.
    Par = Parasitic

